

# MODEL 8/16E

## EXTENDED MEMORY TEST

**Consists of:**

8-Bit Object Tape	06-221M17
Assembly Listing	06-221M96
Program Description	06-221A15

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MODEL 8/16E EXTENDED MEMORY  
TEST PROGRAM DESCRIPTION

1. RELATED ITEMS

1.1 Related Documents

Test Program Listing	06-221M91R00A13
Test Program Paper Tape	06-221M17R00

1.2 Related Test Programs

The following test programs are to be run prior to loading this test:

Model 8/16E Processor Test Part 1	06-211
Model 8/16E Processor Test Part 2	06-212

1.3 Other Applicable Tests

Common Teletype Basic Confidence Test	06-004
Common Current Loop Interface Test	06-184
Common CRT Test	06-146
Common Carousel 300 Test	06-183

2. PURPOSE OF TEST

The Model 8/16E Extended Memory Test verifies the operation of all available memory from address X'00080' up to a maximum address of X'3FFE' (256KB). The test is divided into two parts. Part 1 tests memory locations from X'00080' through X'00FFE' - the first 4KB. The test program itself occupies the second 4KB starting at address X'01000'.

Part 2 of the program tests memory locations from LAST+2 through X'3FFE'. The test program for Part 2 occupies memory locations X'00100' through X'010CD'.

2.1 A brief description of the subtests available in Part 1 follows.

TEST 0

The test area begins at X'00080' and ends at X'00FFE'. Each halfword in the test area is set equal to its address. Each halfword is then read back and tested.

TEST 1

The test area begins at X'00080' and ends at X'00FFE'. Each halfword in the test area is set equal to the one's complement of its address. Each halfword is then read back and tested.

## TEST 2

The test area begins at X'00080' and ends at X'0FFE'. A data pattern initially equal to X'8000' is stored in the first halfword. The data pattern is rotated right one bit position and stored in the next sequential halfword. The pattern repeats itself through every 16 halfword block in the test area. Each halfword is then read back and tested.

## TEST 3

The test area begins at X'0FFE' and ends at X'00080'. A data pattern initially equal to X'FFFE' is stored in the last halfword. The data pattern is rotated left one bit position and stored in the next lower halfword. Working backwards toward location X'00080', the pattern repeats itself through every 16 halfword block in the test area. Each halfword is then read back and tested.

## TEST 4

The test area begins at X'00080' and ends at X'0FFE'. The test area is initially set to all zeros. Then a halfword of X'FFFF' is stored in the first halfword location and the second halfword is read and tested for zeros. The process repeats for every pair of halfwords in the test area so that on completion, every other halfword equals X'FFFF'. Finally, starting back at X'00080', zeros are stored in the second halfword and the first halfword is read and tested for all ones. This continues for every halfword pair in the test area.

## 2.2 A brief description of the subtests available in Part 2 follows.

### TEST 0

The test area equals the four consecutive halfwords beginning at addresses X'01100', X'01108', X'01110, X'01120', X'01140', X'01180', X'01300', X'01500', and X'01900'. The test area is cleared, then a data pattern is written to the first four halfwords. All other segments are then tested for zero. The first four halfwords are reset to zero and the pattern is moved to the second set of four halfwords.

### TEST 1

The test area begins at LAST+2 and ends at X'0FFE'. A data pattern initially equal to X'8000' is stored in the first halfword. The data pattern is rotated right one bit position and stored in the next sequential halfword. The pattern repeats itself through every 16 halfword block in the test area. Each halfword is then read back and tested. Finally, starting at the top of the test area and progressing towards LAST+2. The one's complement of the rotating pattern is used as the test data.

## TEST 2

The test area begins at LAST+2 and ends at the last available half-word address in memory. Each halfword in the test area is set equal to the least significant 16 bits of its address. Each halfword is then read back and tested. Next, starting at the top of the test area and progressing towards LAST+2, each halfword is set equal to the one's complement of its address. Each halfword is read back and tested.

## TEST 3

The test area begins at LAST+2 and ends at the last available half-word address in memory. The entire test area is set to zeros. The first halfword is read, tested for zeros, and then rewritten equal to all ones. This repeats for each halfword in the test area so that when finished, the test area contains all ones. Starting at the top of the test area and progressing towards LAST+2, each halfword is read, tested for all ones, then re-written with zeros.

## TEST 4

The test area equals one halfword out of every 8KB block of memory between LAST+2 and the top of memory. The first halfword is at X'01400', the second is at X'03400', the third is at X'05400' . . . etc. The test area is set to zero then one halfword is set equal to all ones and the corresponding halfwords in all other 8KB blocks are read and tested for zero.

## TEST 5

The test area begins at an address specified by the user and ends at an address also specified by the user. A data pattern specified by the user is written to every halfword in the test area. The test repeats continuously.

## TEST 6

The test area begins at LAST+2 and ends at the last available half-word address in memory. First the test area is set to all zeros. All ones are written to the first halfword and the next sequential halfword is read and tested for all zeros. This repeats for every halfword in the test area so that on completion, the test area equals all ones. Starting back at LAST+2, the second halfword is set to zero and the first halfword is read and tested for all ones. The first halfword is reset to all ones. This repeats through every half-word in the test area until the test area again contains all zeros. Finally, for every halfword in the test area, the halfword is read, tested for zero, re-written with all ones, read back and tested for all ones, then reset to zero.

## TEST 7

The test area begins at LAST+2 and ends at the last available halfword address in memory. Three passes are made through the test area. On pass 1, the first halfword is set to X'5555', the second halfword is set to X'AAAA', the third halfword is set to X'5555' . . . etc. Every odd halfword is set to X'5555' and every even halfword is set to X'AAAA'. Each halfword is read back and tested. On pass 2, the data patterns used are X'0000' and X'FFFF'. On pass 3, the data patterns used are X'C6C6' and X3939'.

## TEST 8

The test area begins at LAST+2 and ends at the last available halfword in memory. A subroutine is copied to memory beginning at the first halfword location in the test area. The subroutine is executed 100 times then it is moved up one halfword location.

### 3. MINIMUM HARDWARE REQUIRED

The following is a list of the minimum hardware required to run this test:

1. Processor - Model 8/16E
2. Minimum Memory - 32KB of 750ns core or 1 $\mu$ s core
3. Console Input/Output device - Teletype, GDT, CRT or Carousel 15, 30, or 35 on a Current Loop interface or a CRT or Carousel 300 on a PASLA/PALM interface.  
(See Appendix 1.)

### 4. REQUIREMENTS OF MACHINE UNDER TEST

This program assumes that the applicable programs indicated in Section 1.2 and 1.3 have been run without detecting an error.

### 5. LOADING PROCEDURE

#### 5.1 Test Tape Format

The 06-221M17 tape is an absolute, non-zoned memory image tape with a front-end boot loader. Both parts of the test are on the same tape, Part 1 first followed by Part 2. Each part occupies approximately 4KB.

#### 5.2 Normal Loading Procedure

1. Manually enter the X'50' sequence shown below into memory:

<u>LOCATION</u>	<u>CONTENTS</u>
X'30'	X'0000'
X'32'	X'0000'
X'34'	X'0000'
X'36'	X'0050'
X'50'	X'D500'
X'52'	X'00CF'
X'54'	X'4300
X'56'	X'0080
X'78'	X'0294'      For TTY or Carousel 35
X'78'	X'0399'      For HS PTR
X'78'	X'1399'      For HS PTR/P

2. Place the program tape in the tape reader.
3. Execute at address X'30'.
4. When the Processor halts, observe the CHKSUM byte, displayed on Processor Display indicator D1. If it is zero, loading is complete; else, repeat the loading procedure.

### 5.3 Multi-Media Diagnostic Loading Procedure

To load this program from the INTERDATA Multi-Media Diagnostic System, refer to Publication Number 06-176A15.

### 5.4 Program Execution

After successfully loading Part 1, if the console device is a TTY, GDT, CRT or Carousel 15, 30 or 35 on a current loop interface with device number X'02', press EXECute to begin Part 1. If the console device is different, refer to Appendix 1 and set up the parameters for the Console Input/Output device. Address location X'1000' and execute. Note that the following title is output to the console device:

8/16E EXTENDED MEMORY TEST PART 1 06-221R00

## 6. OPERATING PROCEDURES

### 6.1 Normal Testing (Part 1)

After the title is printed, the program automatically sequences through all four subtests, testing memory from X'00080' through X'00FFE'. On completion, if no errors were detected, the message

NO ERROR

is printed followed by a carriage return, line feed, and an asterisk (\*) character. At this time, the operator can cause Part 1 to be repeated by depressing the carriage return (CR) Key on the console device. If the line feed (LF) Key is depressed, the program uses the standard X'50' sequence to load Part 2 of the test.

When the processor halts, observe the CHKSUM byte displayed on the Processor display indicator D1. If it is zero, loading is complete; else repeat the loading procedure as described in Section 5.

After successfully loading Part 2, if the console device is a TTY, GDT, CRT or Carousel 15, 30, or 35 on a current loop interface with device number X'02', press EXECute to begin Part 2. If the console device is different, refer to Appendix 1 and set up the parameters for the Console Input/Output device. Address location X'0100' and execute. Note that the following title is output to the console device:

8/16E EXTENDED MEMORY TEST PART 2 06-221R00

## 6.2 Normal Testing (Part 2)

After the title is printed, a search for available memory is performed. The program then prints the message:

PROGRAM DETECTED MAXIMUM MEMORY XXXXX

where XXXXX equals the address in hexadecimal of the last halfword in memory.

After the maximum memory message, the program outputs an asterisk (\*) to indicate that it is ready for operator input. To execute the default tests (Test 0 through 4 and Test 6 through 8), enter the following options from the console device. Appendix 2 summarizes the command/option input format. Appendix 3 summarizes the possible options or commands.

- \* TEST  Selects the default Tests  
0,1,2,3,4,6,7,8
- \* RUN  Starts the test sequence

The program executes Tests 0 through 4 and Tests 6 through 8 in the default sequence. Appendix 4 summarizes the expected results.

Test 5 is provided so that scope measurements can be made while a test pattern is repeatedly written through an area of memory. To execute Test 5, enter the following options from the console device:

* LOW XXXXX		Select Low memory address
* HIGH XXXXX		Select High memory address
* DATA XXXX		Select Data pattern
* TEST 5		Select Test 5
* RUN		Start Execution

Test 5 continuously writes the selected data pattern to every halfword location from the Low memory address to the High memory address. To terminate Test 5, depress the Break Key on the console device.

Any or all Tests, other than Test 5, may be repeated a specified number of times by using the LOOP option. For example:

* TEST 3,4,6		Select Tests 3,4, and 6
* LOOP 10		Run each test sixteen times (Hexadecimal '10')
* RUN		Start the test sequence

Any single test can be run continuously by using the CONTINue option. For example:

* LOOP 0		Cancel LOOP option
* CONTIN 1		Set CONTINue option = 1
* TEST 7		Select Test 7
* RUN		Start test

The user must depress the Break Key on the console device to terminate the test. The CONTINue option is then cancelled by:

\* CONTIN Ø

### 6.3 Optional Testing

Overnight testing is allowed by turning the console device off-line once the test sequence has been started. While the console device is off-line, the program continuously executes all selected Tests. A count of the number of times the entire test sequence is repeated is maintained in memory location TOTAL. If an error is detected, the tally in memory location TOTERR is incremented.

When the console device is turned back on line and the program reaches the end of the current Test, the total number of times the test sequence was repeated and the total number of errors that occurred are output to the console device. If, while the console device is off-line, the total number of times the test was repeated or the error tally reaches X'FFFF', the test sequence is aborted and the Processor halts. To continue, put the console device on line and depress RUN.

#### 6.4 Error Procedures

If an error is detected in the data read from a memory location, the error message is printed in the following format:

MEMORY LOCATION	DATA EXPECTED	DATA OBSERVED
XXXXX	YYYY	ZZZZ

where XXXXX is the address of the halfword under test (In Part 1, only a 4 digit address is printed)

YYYY is the data that was expected at XXXXX  
ZZZZ is the data actually read from XXXXX

#### NOTE

Some tests restore the correct data after an error is detected.

If more than one location is failing, the header lines are not repeated. The new failing address, expected data, and actual data are printed in columnar form under the appropriate heading.

If a machine malfunction interrupt occurs, the following error message is output:

MACHINE MALFUNCTION A BBBB CCCC DDDDD

where A is the new Condition Code  
BBBB is the Old PSW (Status portion)  
CCCC is the Old PSW (Location Counter)  
DDDDD is the memory location being tested

If an illegal instruction interrupt occurs, the following error message is output:

ILLEGAL INSTRUCTION BBBB CCCC

where BBBB is the Old PSW (Status Portion)  
CCCC is the Old PSW (Location Counter)

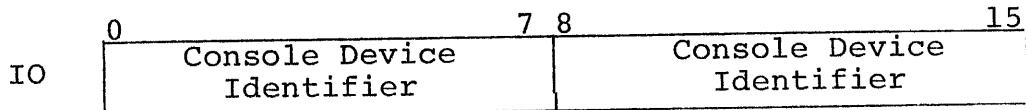
After a machine malfunction interrupt or an illegal instruction interrupt, the Processor is halted. Press the RUN switch on the display to continue.

## 7. PROGRAMMING NOTES

1. The PSW values used in this program can be modified by inserting the desired value in the location labeled PSW or PSW2.
2. Although the program is titled 8/16E, it can be run on any INTERDATA 16-bit series processor with core memory. The program can be run on Processors equipped with MOS memory, but many potential errors with MOS memory may go un-detected. There are special test programs available that are designed specifically for MOS memory.
3. When addressing memory locations beyond 64KB, the program assumes the 8/16E memory bank scheme. Consequently, it may not work on future extended memory processors.

APPENDIX 1  
USER DEVICE DEFINITION

The halfword labeled 'IO' (see the Program Listing) has the default value for Teletype, CRT, or Carousel 15/30/35 (all on Current Loop Interface) as the input/output console device. If the setup is different 'IO' must be changed as follows:



Console Device Identifier	Meaning
X'01'	GDT/CRT on PASLA/PALM interface, strapped for FDX operation and highest baud rate.
X'02'	TTY/GDT/CRT/Carousel 15/30/35 on Current Loop Interface
X'03'	Reserved. Interpreted as X'02'.
X'04'	Carousel 300 on PASLA/PALM Interface, strapped for FDX operation and highest baud rate.
X'05'	TTY/GDT/CRT/Carousel 15/30/35 on Micro I/O Bus Current Loop Interface
X'00', X'06' - X'FF'	Reserved. Interpreted as X'02'

1. The GDT (Graphic Display Terminal) or CRT, if used on PASLA/PALM interface, should be strapped for device addresses X'10' and X'11', for Receive and Transmit sides, respectively. If the addresses are different, then the halfword labeled 'PASLADR' (see the Program Listing) must be changed accordingly.
2. The Teletype or Current Loop Interface, if used, should be strapped for device address X'02'. If the address is different, the halfword labeled 'CLIFADR' (see the Program Listing) must be changed accordingly.
3. The Carousel 300, if used, should be strapped for device addresses X'10 and X'11', for Receive and Transmit sides, respectively. If the addresses are different, the halfword labeled 'C300ADR' (see the Program Listing) must be changed accordingly.
4. The console device on Micro I/O Bus, if used, should be strapped for device address X'C0'. If the address is different, the halfword labeled 'MICROIO' (see the program listing) must be changed accordingly.

## APPENDIX 2

### COMMAND/OPTION INPUT METHOD

An asterisk (\*) is output to the console device to indicate that the program is waiting user input. All option names must be typed in from the console, followed by a space and the desired argument or arguments separated by commas. A carriage return (CR) must be typed to end every command-option input. An invalid command-option name or option value causes a question mark (?) followed by a carriage return (CR), line feed (LF), and an asterisk (\*) to be output. If, during command-option entry, an error is made, it can be handled in two ways. The hash mark (#) can be typed to delete the entire line. This causes a carriage return (CR), line (LF), and an asterisk (\*) to be output. The left arrow (←) can be typed to delete the previous character; or a string of characters can be deleted by typing a left arrow (←) for each character to be deleted.

## APPENDIX 3

## OPTION TABLE

<u>OPTION</u>	<u>DEFAULT</u>	<u>TESTS</u>	<u>DESCRIPTION</u>
TEST	$\emptyset, 1, 2, 3,$ $4, 6, 7, 8$		Select test or tests to be performed. Accept digits 0 through 8.
NOMSG	$\emptyset$	ALL	Message handling option 0 = Print all messages 1 = Print only error messages
LOOP	$\emptyset$	ALL	Specify number of times to repeat each test. Accept 0 through X'FFFF'.
CONTIN	$\emptyset$	ALL	Specify action at conclusion of last selected test. 0 = Print "END OF TEST" message and return to command input 1 = Repeat all selected tests until the BREAK key is depressed.
LOW	X'020000'	5	Specify start address of scope loop test area. Accept LAST+2 through MAXMEM.
HIGH	MAXMEM	5	Specify end address of scope loop test area. Accept LAST+2 through MAXMEM.
DATA	X'A5A5'	5	Specify data pattern to continuously write into each halfword of the scope loop test area. Accept 0 through X'FFFF'.
RUN	-	ALL	Begin test sequence

APPENDIX 4  
EXPECTED RESULT TABLE

8/16E EXTENDED MEMORY TEST PART 1 06-221R00

NO ERROR

\* CR

8/16E EXTENDED MEMORY TEST PART 1 06-221R00

NO ERROR

\* LF

8/16E EXTENDED MEMORY TEST PART 2 06-221R00

PROGRAM DETECTED MAXIMUM MEMORY 3FFE

\* RUN CR

SUBTEST Ø NO ERROR

SUBTEST 1 NO ERROR

SUBTEST 2 NO ERROR

SUBTEST 3 NO ERROR

SUBTEST 4 NO ERROR

SUBTEST 6 NO ERROR

SUBTEST 7 NO ERROR

SUBTEST 8 NO ERROR

END OF TEST

\* TEST 5 CR

\* LOW 8000 CR

\* HIGH 8FFE CR

\* DATA FFFF CR

\* RUN CR

SUBTEST 5 BRK

\*

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PROG= MT816E ASSEMBLED BY CAL 03-065308-00 (32-BIT)

2	SCRAT	MTE00020
3	CROSS	MTE00030
4	TARGT 16	MTE00040
6	* PART 1 IS DESIGNED TO TEST MEMORY LOCATIONS X'0080' THROUGH	MTE00050
7	* X'OFFE'. THE TEST PROGRAM ITSELF RESIDES IN THE SECOND 4KB	MTE00070
8	* STARTING AT ADDRESS X'1000'.	MTE00080
9	*	MTE00090
10	* PROGRAM IS LOADED USING THE STANDARD SD SEQUENCE.	MTE00100
11	* AFTER LOADING, THE PROCESSOR HALTS. IF THE CHECKSUM BYTE	MTE00110
12	* SHOWN ON THE LOW ORDER DISPLAY INDICATORS (D1) IS NOT ZERO,	MTE00120
13	* REPEAT THE LOADING PROCESS.	MTE00130
14	*	MTE00140
15	* IF THE CONSOLE DEVICE IS A TTY,GDT,CRT OR CAROUSEL 15,30 OR 35	MTE00150
16	* ON A CURRENT LOOP INTERFACE (DEVICE ADDRESS X'02'), PRESS "RUN".	MTE00160
17	*	MTE00170
18	* IF THE CONSOLE DEVICE IS NOT A TTY,GDT,CRT OR CAROUSEL 15,30 OR 35	MTE00180
19	* ON A CURRENT LOOP INTERFACE, THE HALFWORD LABELED "I0" MUST BE	MTE00190
20	* MODIFIED. AFTER ADJUSTING THE CONSOLE DEVICE IDENTIFIER AS SHOWN	MTE00200
21	* BELOW, SELECT ADDRESS X'1000' AND BEGIN EXECUTION.	MTE00210
22	*	MTE00220
23	* CONSOLE DEVICE IDENTIFIER:	MTE00230
24	*	MTE00240
25	* 01 = GDT OR CRT ON PASLA/PALM (FDX, HIGHEST BAUD RATE)	MTE00250
26	* 02 = TTY,GDT,CRT OR CAROUSEL 15,30 OR 35 ON CURRENT LOOP	MTE00260
27	* 03 = RESERVED, INTERPRETED AS '02'	MTE00270
28	* 04 = CAROUSEL 300 ON PASLA OR PALM (FDX, HIGHEST BAUD RATE)	MTE00280
29	* 05 = TTY,GDT,CRT OR CAROUSEL 15,30 OR 35 ON MICRO I/O CLI	MTE00290
30	* 00 AND 06:FF = RESERVED, INTERPRETED AS '02'	MTE00300

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 GENERAL REGISTER ASSIGNMENTS

0000 0000	32	R0	EQU	0	ASCII CHARACTER FOR I/O	MTE00320
0000 0001	33	R1	EQU	1	PROGRAM ADDRESS	MTE00330
0000 0002	34	R2	EQU	2	CONSOLE DEVICE NUMBER	MTE00340
0000 0003	35	R3	EQU	3	G.P. ACCUMULATOR	MTE00350
0000 0004	36	R4	EQU	4	MESSAGE START ADDRESS	MTE00360
0000 0005	37	R5	EQU	5	STATE REGISTER	MTE00370
0000 0006	38	R6	EQU	6	HEX DIGIT FOR ERROR PRINT-OUT	MTE00380
0000 0007	39	R7	EQU	7	HALFWORD FOR ERROR PRINT-OUT	MTE00390
0000 0008	40	R8	EQU	8	OBSERVED MEMORY DATA	MTE00400
0000 0009	41	R9	EQU	9	EXPECTED MEMORY DATA	MTE00410
0000 000A	42	R10	EQU	10	DATA PATTERN REGISTER	MTE00420
0000 000B	43	R11	EQU	11	DATA PATTERN REGISTER	MTE00430
0000 000C	44	R12	EQU	12	MINOR LINK REGISTER	MTE00440
0000 000D	45	R13	EQU	13	MAJOR LINK REGISTER	MTE00450
0000 000E	46	R14	EQU	14	MEMORY ADDRESS	MTE00460
0000 000F	47	R15	EQU	15	*	MTE00470
	48	*			*	MTE00480
	49	*			*	MTE00490
	50	*	STATE REGISTER BIT DEFINITIONS			
0000 0001	51	*				
0000 0002	52	WASDU	EQU	X"0001"	CONSOLE DU FLAG	MTE00510
0000 0004	53	WASDUI	EQU	X"0002"	AUXILIARY DU FLAG	MTE00520
0000 0008	54	MICROFLG	EQU	X"0004"	MICRO I/O BUS FLAG	MTE00530
0000 0040	55	ERRFLG	EQU	X"0008"	ERROR FLAG	MTE00540
0000 0080	56	PAUSE	EQU	X"0040"	CAROUSEL 300 DC4/DC2 FLAG	MTE00550
0000 0100	57	CAROUSEL	EQU	X"0080"	CAROUSEL 300 FLAG	MTE00560
0000 0200	58	PASFLG	EQU	X"0100"	PASLA/PALM FLAG	MTE00570
	59	PARITY	EQU	X"0200"	FIRST PARITY ERROR FLAG	MTE00580
						MTE00590

## BOOT LOADER

0000R		61	ORG X'0080'	MTE00610
0080 C810 1000		62	LHI R1,ORIGIN1	MTE00620
0084 2421		63	LIS R2,1	MTE00630
0086 C830 1549		64	LHI R3,LNZB	MTE00640
008A C860 00FF		65 MN	LHI R6,X'FF'	MTE00650
008E D340 0078		66	LB R4,X'78'	MTE00660
0092 DE40 0079		67	OC R4,X'79'	MTE00670
0096 9045		68 LEADER	SSR R4,R5	MTE00680
0098 2091		69	BTBS 9,1	MTE00690
009A 9345		70	RDR R4,R5	MTE00700
009C 0855		71	LDAR R5,R5	MTE00710
009E 2234		72	BZS LEADER	MTE00720
00A0 D251 0000		73 LOAD	STB R5,0(R1)	MTE00730
00A4 0765		74	XAR R5,R5	MTE00740
00A6 9A26		75	WDR R2,R6	MTE00750
00A8 9045		76	SSR R4,R5	MTE00760
00AA 2091		77	BTBS 9,1	MTE00770
00AC 9345		78	RDR R4,R5	MTE00780
00AE C110 0040		79	BXLE R1,LOAD	MTE00790
00B2 9826		80	WHR R2,R6	MTE00800
00B4 C200 0038		81 HALT3	LPSW STARTX	MTE00810
00B8 8000		82	ALIGN 8	MTE00820
00BA 1000		83 STARTY	DC X'8000',ORIGIN1	MTE00830

## MODEL 8/16 E EXTENDED MEMORY TEST 06-221R00M96 PART 1

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00BC		85	ORG	X'1000*		
1000	2309	86	ORIGIN1	BS	START1	MTE00850
		87	*			MTE00860
		88	*			MTE00870
1002	3000	89	PSW	DCX	3000	MTE00880
1004	0000	90	PSW2	DCX	0000	MTE00890
		91	*			MTE00900
		92	*			MTE00910
1006	0002	93		DCX	0002	MTE00920
1008	0010	94	PASLADR	DCX	0010	MTE00930
100A	0002	95	CLIFADR	DCX	0002	MTE00940
100C	0010	96	C300ADR	DCX	0010	MTE00950
100E	0000	97	MICROIO	DCX	0000	MTE00960
		98	*			MTE00970
1010	0202	99	I0	DCX	0202	MTE00980
		100	*			MTE00990
		101	*			MTE01000
1012	0300 1010	102	START1	L8	R0,I0	MTE01010
1016	0755	103		XHR	R5,R6	MTE01020
1018	2701	104		SIS	R0,1	MTE01030
101A	4330 105A	105		BZ	CRT	MTE01040
101E	2703	106		SIS	R0,3	MTE01050
1020	4330 1044	107		BZ	C300	MTE01060
1024	4210 1073	108		BM	TTY	MTE01070
1028	2701	109		SIS	R0,1	MTE01080
102A	4230 1073	110		BNZ	TTY	MTE01090
		111	*			
102E	0650 0004	112		OHI	R5,MICROFLG	MTE01100
1032	4920 100E	113		LH	R2,MICROIO	MTE01110
1036	4810 163A	114		LH	R1,MICRORD	MTE01120
103A	0700	115		XHR	R0,R0	MTE01130
103C	DE20 1638	116		OC	R2,MICRORST	MTE01140
1040	4300 1084	117		B	DEVSET	MTE01150
1044	4820 100C	118	C300	LH	R2,C300ADR	MTE01160
1048	4810 163C	119		LH	R1,CARRD	MTE01170
104C	4800 163E	120		LH	R0,CAR2ND	MTE01180
1050	D340 1640	121		LB	R4,CARRQ2S	MTE01190
1054	C650 0080	122		OHI	R5,CAROUSEL	MTE01200
1058	2309	123		BS	CRT2	MTE01210
105A	4820 1003	124	CRT	LH	R2,PASLADR	MTE01220
105E	4810 1542	125		LH	R1,CRTRD	MTE01230
1062	4800 1644	126		LH	R0,CRT2ND	MTE01240
1066	D340 1641	127		LB	R4,CRTRQ2S	MTE01250
106A	C650 0100	128	CRT2	OHI	R5,PASFLG	MTE01260
106E	9460	129		EXBR	R6,R0	MTE01270
1070	9526	130		OCR	R2,R6	MTE01280
1072	3240 1634	131		STB	R4,CONRQ2S	MTE01290
1076	2307	132		BS	DEVSET	MTE01300
1078	4820 100A	133	TTY	LH	R2,CLIFADR	MTE01310
107C	4810 1646	134		LH	R1,CLIFRD	MTE01320
1080	4800 1648	135		LH	R0,CLIF2ND	MTE01330
1084	4020 1630	136	DEVSET	STH	R2,CONADR	MTE01340
1088	4010 1632	137		STH	R1,CONRD	MTE01350
108C	4000 1634	138		STH	R0,CON2ND	MTE01360
						MTE01370
						MTE01380

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1090 0733	140 EXECUTE XHR R3,R3	CLEAR PSW	MTE01400
1092 9503	141 EPSR R0,R3	TITLE START ADDRESS	MTE01410
1094 C840 1555	142 LHI R4,TITLE1	PRINT "S16 EXT. MEMORY TEST PART 1"	MTE01420
1098 4100 1354	143 BAL R13,MESSAGE		MTE01430
	144 *		MTE01440
	145 *		MTE01450
109C 0765	146 XHR R6,R6		MTE01460
109E 4060 0034	147 STH R6,X'34'	NEW PSW, ILLEGAL INSTRUCTION	MTE01470
10A2 4060 0036	148 STH R6,X'36'		MTE01480
10A6 C800 128A	149 LHI R0,PARERR		MTE01490
10AA 4000 003E	150 STH R0,X'3E'		MTE01500
10AE C800 130C	151 LHI R0,ILLEGL		MTE01510
10B2 4000 0036	152 STH R0,X'36'		MTE01520
10B6 C450 FFFC	153 RUVIT NHI R5,-1-WASDU-WASDU1		MTE01530
10BA 0700	154 XHR R0,R0		MTE01540
10BC 4000 162A	155 STH R0,TOTAL	CLEAR TOTAL	MTE01550
10C0 4000 152C	156 STH R0,TOTERR		MTE01560
10C4 4830 1002	157 STRTTEST LH R3,PSW		MTE01570
10C8 9503	158 EPSR R0,R3	SET PSW	MTE01580

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S U B T E S T 3

		160 * STORE ADDRESS AS DATA IN EACH HALFWORD FROM *0080* TO *0FFE*	
		161 *	
10CA	C8F0 0080	162 TEST0 LHI R15,X'0080'	MTE01600
10CE	42FF 0002	163 TEST0.01 STH R15,0(R15)	MTE01610
10D2	26F2	164 AIS R15,2	MTE01620
10D4	C5C0 1000	165 CLHI R15,X'1000'	MTE01630
10D8	2085	166 BLS TEST0.01	MTE01640
		167 *	MTE01650
10DA	C8F0 0080	168 LHI R15,X'80'	MTE01660
10DE	089F	169 TEST0.02 LHR R9,R15	MTE01670
10E0	488F 0000	170 LH R8,0(R15)	MTE01680
10E4	0589	171 CLHR R8,R9	MTE01690
10E6	2333	172 BES TEST0.03	MTE01700
10E8	41D0 1435	173 BAL R13,ERRMSG	MTE01710
10EC	26F2	174 TEST0.03 AIS R15,2	MTE01720
10EE	C5F0 1000	175 CLHI R15,X'1000'	MTE01730
10F2	208A	176 BLS TEST0.02	MTE01740

## S U B T E S T \_ 1

		178	* STORE COMPLEMENT OF ADDRESS AS DATA FROM '0080' TO '0FFE'	MTE01780
		179	*	MTE01790
10F4	C8F0 0080	180	TEST1 LHI R15,X'80'	MTE01800
10F8	2581	181	LCS R11,1	MTE01810
10FA	089F	182	TEST1.01 LHR R9,R15	MTE01820
10FC	0798	183	XHR R9,R11	R9 = ONES COMP OF ADDRESS
10FE	409F 0000	184	STH R9,0(R15)	STORE
1102	26F2	185	AIS R15,2	MTE01840
1104	C5F0 1000	186	CLHI R15,X'1000'	MTE01850
1108	2087	187	BLS TEST1.01	MTE01860
		188	*	MTE01870
110A	C8F0 0080	189	LHI R15,X'80'	MTE01880
110E	089F	190	TEST1.02 LHR R9,R15	MTE01890
1110	0798	191	XHR R9,R11	R9 = EXPECTED DATA
1112	488F 0000	192	LH R8,0(R15)	R8 = OBSERVED DATA
1115	0589	193	CLHR R8,P9	MTE01920
1118	2333	194	BES TEST1.03	MTE01930
111A	4100 1436	195	BAL R13,ERRMSG	MTE01940
111E	26F2	196	TEST1.03 AIS R15,2	MTE01950
1120	C5F0 1000	197	CLHI R15,X'1000'	MTE01960
1124	2083	198	BLS TEST1.02	MTE01970
				MTE01980

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\* S U B T E S T 2

1126	C8F0 0080	200	* STORE X'8000',X'4000',X'2000'...,X'0002',X'0001' IN EACH	MTE02000
112A	C890 8000	201	* 16 HALFWORD BLOCK FROM X'0000' THROUGH X'0FFE'	MTE02010
112E	409F 0000	202	*	MTE02020
1132	25F2	203	TEST2 LHI R15,X'80'	MTE02030
1134	C5F0 1000	204	TEST2.01 LHI R9,X'8000'	MTE02040
1138	2384	205	TEST2.02 STH R9,0(R15)	MTE02050
113A	9091	206	AIS R15,2	MTE02060
113C	2239	207	CLHI R15,X'1000'	MTE02070
113E	2208	208	BNLS TEST2.03	MTE02080
1140	C8F0 0082	209	SRLS R9,1	MTE02090
1144	C890 8000	210	BZS TEST2.01	MTE02100
1148	486F 0000	211	BS TEST2.02	MTE02110
114C	0589	212	*	MTE02120
114E	2333	213	TEST2.03 LHI R15,X'80'	MTE02130
1150	4100 1436	214	TEST2.04 LHI R9,X'8000'	MTE02140
1154	25F2	215	TEST2.05 LH R8,0(R15)	MTE02150
1156	C5F0 1000	216	CLHR R8,R9	MTE02160
115A	2384	217	BES TEST2.06	MTE02170
115C	9091	218	BAL R13,ERRMSG	MTE02180
115E	223D	219	TEST2.06 AIS R15,2	MTE02190
1160	220C	220	CLHI R15,X'1000'	MTE02200
		221	BNLS TEST3	MTE02210
		222	SRLS R9,1	MTE02220
		223	BZS TEST2.04	MTE02230
		224	BS TEST2.05	MTE02240

## S U B T E S T 3

		225 * STORE X'7FFF', X'BFFF', X'DFFF'...X'FFFF' IN EACH	MTE02260
		227 * 16 HALFWORD BLOCK FROM X'0080' THROUGH X'0FFE'.	MTE02270
		228 * SEQUENCE WILL BE FROM THE TOP DOWN.	MTE02280
		229 *	MTE02290
1162	C8F0 0FFE	230 TEST3 LHI R15,X'0FFE'	MTE02300
1166	2591	231 LCS R11,1 R11 = 'FFFF'	MTE02310
1168	24A1	232 TEST3.01 LIS R10,1 R10 = TRUE VERSION OF DATA PATTERN	MTE02320
116A	089A	233 TEST3.02 LHR R9,R10 R9 = TRUE DATA	MTE02330
116C	0798	234 XHR R9,R11 R9 = FALSE DATA	MTE02340
116E	409F 0000	235 STH R9,0(R15) STORE	MTE02350
1172	27F2	236 SIS R15,2 DECREMENT ADDRESS	MTE02360
1174	C5F0 0080	237 CLHI R15,X'80' FINISHED	MTE02370
1178	2184	238 BLS TEST3.03 SHIFT PATTERN	MTE02380
117A	0AAA	239 AHR R10,R10 RESET TO '0001'	MTE02390
117C	208A	240 BCS TEST3.01	MTE02400
117E	228A	241 BS TEST3.02	MTE02410
		242 *	MTE02420
1180	C8F0 0FFE	243 TEST3.03 LHI R15,X'0FFE' TRUE VERSION OF DATA PATTERN	MTE02430
1184	24A1	244 TEST3.04 LIS R10,1	MTE02440
1186	089A	245 TEST3.05 LHR R9,R10	MTE02450
1188	0798	246 XHR R9,R11 R9 = FALSE DATA	MTE02460
118A	488F 0000	247 LH R8,0(R15) R8 = OBSERVED DATA	MTE02470
118E	0589	248 CLHR R8,R9	MTE02480
1190	2333	249 BES TEST3.06 SKIP IF EQUAL	MTE02490
1192	4100 1436	250 BAL R13,ERRMSG	MTE02500
1196	27F2	251 TEST3.06 SIS R15,2 DECREMENT ADDRESS	MTE02510
1198	C5F0 0080	252 CLHI R15,X'80'	MTE02520
119C	2184	253 BLS TEST4 FINISHED	MTE02530
119E	0AAA	254 AHR R10,R10 SHIFT PATTERN	MTE02540
11A0	208A	255 BCS TEST3.04 RESET TO '0001'	MTE02550
11A2	228E	256 BS TEST3.05 TEST NEXT	MTE02560

## \* S U B T E S T 4

	258 * TEST MEMORY WITH ALTERNATE HALFWORDS OF ZEROS AND ONES		
11A4 C8F0 0080	259 *		MTE02580
11A8 0799	260 TEST4 LHI R15,X'80'		MTE02590
11AA 409F 0000	261 XHR R9,R9		MTE02600
11AE 25F2	262 TEST4.01 STH R9,0(R15)	CLEAR THE TEST AREA	MTE02610
11B0 C5F0 1000	263 AIS R15,2		MTE02620
11B4 2085	264 CLHI R15,X'1000'		MTE02630
	265 BLS TEST4.01		MTE02640
	266 *		MTE02650
11B6 25B1	267 LCS R11,1	R11 = 'FFFF'	MTE02660
11B8 C8F0 0080	268 LHI R15,X'80'		MTE02670
11B8 0799	269 TEST4.02 XHR R9,R9		MTE02680
11BE 488F 0000	270 LH R8,0(R15)	READ ZEROS	MTE02690
11C2 2333	271 BIS TEST4.03		MTE02700
11C4 41D0 1436	272 BAL R13,ERRMSG		MTE02710
11C8 408F 0002	273 TEST4.03 STH R11,2(R15)	WRITE ONES IN NEXT CELL	MTE02720
11CC 26F4	274 AIS R15,4		MTE02730
11CE C5F0 1000	275 CLHI R15,X'1000'		MTE02740
11D2 2088	276 BLS TEST4.02		MTE02750
	277 *		MTE02760
11D4 C8F0 0080	278 LHI R15,X'80'		MTE02770
11D8 2591	279 LCS R9,1		MTE02780
11DA 0788	280 XHR R11,R11		MTE02790
11DC 408F 0000	281 TEST4.04 STH R11,0(R15)	WRITE ZEROS	MTE02800
11E0 488F 0002	282 LH R8,2(R15)	READ ONES	MTE02810
11E4 0589	283 CLHR R8,R9		MTE02820
11E6 2333	284 BES TEST4.05		MTE02830
11E8 41D0 1436	285 BAL R13,ERRMSG		MTE02840
11EC 26F4	286 TEST4.05 AIS R15,4		MTE02850
11EE C5F0 1000	287 CLHI R15,X'1000'		MTE02860
11F2 2088	288 BLS TEST4.04		MTE02870
			MTE02880

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11F4	4830 1004	290	TEST-END LH	R3,PSW2	MTE02900
11F8	9503	291	EPSR	R0,R3	MTE02910
11FA	2401	292	LIS	R0,1	MTE02920
11FC	6100 162A	293	AHM	R0,TOTAL	MTE02930
1200	C350 0008	294	THI	R5,ERRFLG	MTE02940
1204	2135	295	BNZS	TEND01	MTE02950
1206	C840 159C	296	LHI	R4,NOER	MTE02960
120A	4100 1354	297	BAL	R13,MESSAGE	MTE02970
120E	4100 1334	298	TEND01	BAL R12,TSTDU	MTE02980
1212	4230 1258	299	BNZ	KEEP9	MTE02990
1216	C350 0002	300	THI	R5,WASDUI	MTE03000
121A	4230 1288	301	BNZ	KEEP92	MTE03010
121E	4100 1478	302	OPTIN	BAL R13,CRLF	MTE03020
1222	C800 002A	303	LHI	R0,C**	MTE03030
1226	4100 13FC	304	BAL	R12,OUTCHR	MTE03040
122A	2501	305	LCS	R0,1	MTE03050
122C	4100 13FC	306	RDCHAR	BAL R12,OUTCHR	MTE03060
1230	4100 1486	307	BAL	R13,GETCHR	MTE03070
1234	C500 0000	308	CLHI	R0,X'0D'	MTE03080
1238	4330 1012	309	BE	START1	MTE03090
123C	C500 000A	310	CLHI	R0,X'0A'	MTE03100
1240	4230 122C	311	BNE	RDCHAR	MTE03110
1244	C100 1250	312	LM	R12,ALSEQUNC	MTE03120
1248	D000 0050	313	STM	R12,X'50'	MTE03130
124C	4300 0050	314	B	X'50'	MTE03140
1250	D500	315	ALSEQUNC	DCX D500,00CF	MTE03150
1252	00CF			AL X'CF'	
1254	4300	316	DCX	4300,0080	MTE03160
1256	0080			B X'80'	
1258	C650 0001	317	*		MTE03170
125C	2401	318	KEEP9	OHI R5,WASDUI	MTE03180
125E	D000 162E	319	KEEP91	LIS R0,1	MTE03190
1262	D400 162B	320	OC	R0,INCRMNTL	MTE03200
1266	DA03 162A	321	WD	R0,TOTAL+1	MTE03210
126A	DA03 162D	322	WD	R0,TOTAL	MTE03220
126E	DA00 162C	323	WD	R0,TOTERP+1	MTE03230
1272	D000 152F	324	WD	R0,TOTERR	MTE03240
1276	4810 162A	325	OC	R0,NORMAL	MTE03250
127A	C510 FFFF	326	LH	R1,TOTAL	MTE03260
127E	4280 1004	327	CLHI	R1,X'FFFF'	MTE03270
1282	C810 8000	328	BL	STRTEST	MTE03280
1286	9501	329	*		MTE03290
1288	4100 1334	330	HALT9	LHI R1,X'8000'	MTE03300
128C	2035	331	EPSR	R0,R1	MTE03310
128E	C450 FFFE	332	*		MTE03320
1292	4100 1473	333	KEEP92	BAL R12,TSTDU	MTE03330
1296	4870 162A	334	BNZS	HALT9	MTE03340
129A	4100 1526	335	KEEP10	NHI R5,-1-WASDUI	MTE03350
129E	C840 1616	336	BAL	R13,CRLF	MTE03360
12A2	4100 1354	337	LH	R7,TOTAL	MTE03370
12A6	4870 162C	338	BAL	R13,PRINTR7	MTE03380
12AA	4100 1526	339	LHI	R4,TOTALMSG	MTE03390
		340	BAL	R13,MESSAGE	MTE03400
		341	LH	R7,TOTERR	MTE03410
		342	BAL	R13,PRINTR7	MTE03420
				PRINT YYYYY	

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12AE C840 1620	343	LHI R4,ERRORS		
12B2 4100 1354	344	BAL R13,MESSAGE	PRINT	ERRORS
	345 *		*	XXXX TOTAL,YYYY ERRORS
12B6 4300 121E	346	B OPTIN		

MTE03430  
MTE03440  
MTE03450  
MTE03460

## SUBROUTINES

128A 9566	348 PARERR	EPSR R6,R6	CAPTURE CURRENT PSW	MTE03480
128C C350 0200	349 THI R5,PARITY		IGNORE FIRST PARITY ERROR	MTE03490
12C0 2135	350 BNZS PARERR1		REACT TO ALL OTHERS	MTE03500
12C2 C650 0200	351 OHI R5,PARITY		SET FIRST PARITY ERROR FLAG	MTE03510
12C6 C200 0038	352 LPSW X'38'		CONTINUE	MTE03520
12CA 4100 1478	353 PARERR1	BAL R13,CRLF		MTE03530
12CE C840 15A8	354 LHI R4,MALEMSG			MTE03540
12D2 4100 1354	355 BAL R13,MESSAGE		PRINT "MACHINE MALFUNCTION"	MTE03550
12D6 4100 154A	356 BAL R12,PRINTRS		PRINT CURRENT CONDITION CODE	MTE03560
12DA C800 0020	357 LHI R0,X'20'			MTE03570
12DE 4100 13FC	358 BAL R12,OUTCHR			MTE03580
12E2 4870 0039	359 LH R7,X'38'			MTE03590
12E5 4100 1526	360 BAL R13,PRINTR7		OLD PSW	MTE03600
12EA C800 0020	361 LHI R0,X'20'			MTE03610
12EE 4100 13FC	362 BAL R12,OUTCHR			MTE03620
12F2 4870 003A	363 LH R7,X'3A'			MTE03630
12F6 4100 1526	364 BAL R13,PRINTR7		OLD LOC	MTE03640
12FA C800 0020	365 LHI R0,X'20'			MTE03650
12FE 4100 13FC	366 BAL R12,OUTCHR			MTE03660
1302 087F	367 LHR R7,R15		OUTPUT MEMORY ADDRESS	MTE03670
1304 4100 1526	368 BAL R13,PRINTR7			MTE03680
1308 4300 1282	369 B HALT9			MTE03690
130C 4100 1478	371 ILLEGAL	BAL R13,CRLF		MTE03710
1310 C840 1502	372 LHI R4,ILLMSG			MTE03720
1314 4100 1354	373 BAL R13,MESSAGE		PRINT "ILLEGAL INSTRUCTION"	MTE03730
1318 4870 0030	374 LH R7,X'30'			MTE03740
131C 4100 1526	375 BAL R13,PRINTR7		OLD PSW	MTE03750
1320 C800 0020	376 LHI R0,X'20'			MTE03760
1324 4100 13FC	377 BAL R12,OUTCHR			MTE03770
1328 4370 0032	378 LH R7,X'32'			MTE03780
132C 4100 1526	379 BAL R13,PRINTR7			MTE03790
1330 4300 1282	380 B HALT9			MTE03800

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SUBROUTINES

		382 *	S U B R O U T I N E	T S T D U	
1334	C350 0100	383 *			MTE03320
1338	2338	384 TSTDU	THI R5,PASFLG	PASLA?	MTE03830
133A	9023	385 BZS	TESTDU1	SKIP IF NO	MTE03840
133C	C430 00FC	386 SSR	R2,R3		MTE03350
1340	273C	387 NHI	R3,X#FC*		MTE03860
1342	2337	388 SIS	R3,X#0C*	BUSY & EXAMINE	MTE03870
1344	0733	389 BZS	SETDU	YES	MTE03880
1346	030C	390 XHR	R3,R3	CLEAR CC	MTE03900
1348	9023	391 BR	R12	RETURN	MTE03900
134A	C430 0001	392 TESTDU1	SSR R2,R3		MTE03910
134E	030C	393 NHI	R3,1		MTE03920
1350	2431	394 BR	R12		MTE03930
1352	030C	395 SETDU	LIS R3,1		MTE03940
		396 SR	R12	NON-ZERO CC	MTE03950
					MTE03950

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SUBROUTINES

		398 *	S U B R O U T I N E	M E S S A G E	
1354	4820 1630	399 *			MTE03980
1358	C350 0100	400	MESSAGE LH R2,CONADR		MTE03990
135C	2333	401	THI R5,PASFLG	PASLA?	MTE04000
135E	DE20 1634	402	BZG P4		MTE04010
1362	41C0 1334	403	OC R2,CON2ND	PASLA SET UP COMMAND	MTE04020
1366	2334	404	P4 BAL R12,TSTDU	TEST FOR DU STATUS	MTE04030
1368	C550 0001	405	BZS P1	SKIP IF NOT DU	MTE04040
136C	030D	406	OHI R5,WASDU	SET DU FLAG	MTE04050
136E	C350 0001	407	BR R13	RETURN	MTE04060
1372	4330 1394	408	P1 THI R5,WASDU	NOT DU NOW, WAS IT?	MTE04070
1376	2531	409	BZ P3	SKIP IF NO	MTE04080
1378	2731	410	LCS R3,1	R3 = *FFFF*	MTE04090
137A	2031	411	SIS R3,1	DELAY FOR CRT WARM-UP	MTE04100
137C	C450 FFFF	412	BTRS 3,1		MTE04110
1380	C550 0002	413	NHI R5,-1-WASDU	CLEAR DU FLAG	MTE04120
1384	2501	414	OHI R5,WASDU1	SET DU ONCE FLAG	MTE04130
1386	2444	415	LCS R3,1		MTE04140
1388	41C0 13FC	416	LIS R4,4		MTE04150
138C	2741	417	P2 BAL R12,CUTCHR	OUTPUT 4 DELETES	MTE04160
138E	2023	418	SIS R4,1		MTE04170
1390	4300 1285	419	BPS P2		MTE04180
		420	B KEEP10	PRINT TOTAL, TOTERR	MTE04190
		421 *			MTE04200
1394	0304 0000	422 P3	L3 R0,0(R4)	PICK UP MESSAGE CHARACTER	MTE04210
1398	41C0 13FC	423	BAL R12,CUTCHR	OUTPUT IT	MTE04220
139C	2541	424	AIS R4,1		MTE04230
139E	C400 007F	425	NHI R0,X'7F'		MTE04240
13A2	C500 007F	425	CLHI R0,X'7F'	DONE WHEN OUTPUT DELETE	MTE04250
13A6	2039	427	BNES P3	EXIT THROUGH TSTBRK	MTE04260
					MTE04270

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SUBROUTINES

		429 *	S U B R O U T I N E	T S T B R K	
13A8	4820 1630	430 *			MTE04290
13AC	DE20 1632	431 TSTBRK	LH R2,CONADR		MTE04300
13B0	9D23	432 OC	R2,CONRD	SELECT READ MODE	MTE04310
13B2	C330 0020	433 SSR	R2,R3		MTE04320
13B6	0330	434 THI	R3,X"20"	LINE BREAK STATUS?	MTE04330
13B8	C350 0004	435 BZR	R13	EXIT IF NO	MTE04340
13BC	233E	436 THI	R5,MICROFLG	MICRO I/O BUS?	MTE04350
13BE	C330 0008	437 BZS	TSTBRK2	SKIP IF NO	MTE04360
13C2	2134	438 TSTBRK0	THI R3,8	BUSY ALSO SET?	MTE04370
13C4	9820	439 BNZS	TSTBRK1	SKIP IF YES	MTE04380
13C6	9D23	440 RDR	R2,R0	DUMMY READ	MTE04390
13C8	2282	441 SSR	R2,R3		MTE04400
13CA	9D23	442 BFBS	8,2	WAIT FOR BUSY TO SET	MTE04410
13CC	C330 0020	443 TSTBRK1	SSR R2,R3		MTE04420
13D0	2039	444 THI	R3,X"20"		MTE04430
13D2	9320	445 BNZS	TSTBRK0	LOOP UNTIL BREAK RESETS	MTE04440
13D4	4300 13F8	446 RDR	R2,R0		MTE04450
13D8	C350 0100	447 B	TSTBRK4	TAKE BREAK EXIT	MTE04460
13DC	233A	448 TSTBRK2	THI R5,PASFLG	PASLA?	MTE04470
13DE	C330 0008	449 BZS	TSTBRK3	SKIP IF NO	MTE04480
13E2	023D	450 THI	R3,X"08"	BUSY ALSO SET?	MTE04490
13E4	9320	451 BNZR	R13	EXIT IF YES, BREAK ACKNOWLEDGED	MTE04500
13E6	9D23	452 RDR	R2,R0	READ THE CHARACTER	MTE04510
13E8	2281	453 SSR	R2,R3		MTE04520
13EA	0800	454 BFBS	8,1	WAIT FOR BUSY	MTE04530
13EC	023D	455 LHR	R0,R0		MTE04540
13EE	2305	456 BNZR	R13	EXIT IF FRAMING ERROR	MTE04550
13F0	9D23	457 BS	TSTBRK4		MTE04560
13F2	C330 0020	458 TSTBRK3	SSR R2,R3		MTE04570
13F6	2033	459 THI	R3,X"20"		MTE04580
13F8	4300 121E	460 BNZS	TSTBRK3	WAIT FOR BREAK TO RELEASE	MTE04590
		461 TSTBRK4	B OPTIN		MTE04600
					MTE04610

## SUBROUTINES

			S U B R O U T I N E	C U T C H R	
			463 *		MTE04630
			464 *		MTE04640
1	13FC	4000 1450	465 OUTCHR	STH R12,OUT1+2	MTE04650
1	1400	C350 0080	466 THI R5,CAROUSEL	SAV RETURN ADDRESS	MTE04660
1	1404	4330 1442	467 BZ OUTCHR2	CAROUSEL 300?	MTE04670
1	1408	C450 FFBF	468 NHI R5,-1-PAUSE	SKIP IF NO	MTE04680
1	140C	41C0 1334	469 OTC.0 BAL R12,TSTDJ	RESET FLAG	MTE04690
1	1410	4230 145A	470 BNZ OUT0	ON LINE?	MTE04700
1	1414	9023	471 SSR R2,R3	SKIP IF NO	MTE04710
1	1416	2386	472 BNCS OTC.2	BRANCH IF NOT BUSY	MTE04720
1	1418	C350 0040	473 OTC.1 THI R5,PAUSE		MTE04730
1	141C	2038	474 BNZS OTC.0	IF FLAG SET, WAIT FOR DC2	MTE04740
1	141E	4300 1442	475 B OUTCHR2	PRESS ON	MTE04750
1	1422	9823	476 OTC.2 RDR R2,R3	DC2,DC4	MTE04760
1	1424	C430 007F	477 NHI R3,X*7F*		MTE04770
1	1428	C830 0012	478 SHI R3,X*12*	DC2?	MTE04780
1	142C	2134	479 BNZS OTC.3	SKIP IF NO	MTE04790
1	142E	C450 FF3F	480 NHI R5,-1-PAUSE	RE-SET FLAG	MTE04800
1	1432	2308	481 BS OUTCHR2		MTE04810
1	1434	2732	482 OTC.3 SIS R3,2	DC4?	MTE04820
1	1436	4230 140C	483 BNZ OTC.0	NO, KEEP LOOKING	MTE04830
1	143A	C650 0040	484 OHI R5,PAUSE	SET FLAG	MTE04840
1	143E	4300 140C	485 B OTC.0	LOOK FOR DC2	MTE04850
1			486 *		MTE04860
1	1442	41C0 1334	487 OUTCHR2 BAL R12,TSTDJ	BRANCH IF DU	MTE04870
1	1446	217A	488 BNZS OUT0		MTE04880
1	1448	C350 0100	489 SETJP THI R5,PASFLG	PASLA?	MTE04890
1	144C	2333	490 BZS SETUP1	SKIP IF NO	MTE04900
1	144E	C620 0001	491 OHI R2,1	SELECT XMIT ADDRESS	MTE04910
1	1452	DF20 1633	492 SETUP1 OC R2,CONWR	SELECT WRITE MODE	MTE04920
1	1456	9023	493 OTC.4 SSR R2,R3		MTE04930
1	1458	2315	494 BNMS CONT02		MTE04940
1	145A	C650 0001	495 OJTO OHI R5,WASDU	SET DU FLAG	MTE04950
1	145E	4300 145E	496 OUT1 B OUT1	RETURN	MTE04960
1			497 *		MTE04970
1	1462	C530 0000	498 CONT02 CLHI R3,12		MTE04980
1	1466	2236	499 BIS OUT0	PASLA DU	MTE04990
1	1468	C330 0008	500 THI R3,8		MTE05000
1	146C	2038	501 BNZS OTC.4	LOOP ON BUSY	MTE05010
1	146E	9420	502 WDR R2,RS	OUTPUT CHARACTER	MTE05020
1	1470	9023	503 OTC.5 SSR R2,R3		MTE05030
1	1472	203C	504 BNZS OUT0	EXIT IF DU	MTE05040
1	1474	2082	505 BCS OTC.5	WAIT FOR BUSY	MTE05050
1	1476	220C	506 BS OUT1	RETURN	MTE05060

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SUBROUTINES

		508 *	S U B R O U T I N E	C R L F	
1478	240D	509 *			MTE05080
147A	41C0 13FC	510 CRLF	LIS R0,X#0D*	CARRIAGE RETURN	MTE05090
147E	240A	511	BAL R12,OUTCHR		MTE05100
1480	41C0 13FC	512	LIS R0,X#0A*	LINE FEED	MTE05110
1484	030D	513	BAL R12,OUTCHR		MTE05120
		514	BR R13		MTE05130
					MTE05140
		516 *	S U B R O U T I N E	G E T C H R	
1486	4820 1630	517 *			MTE05160
148A	DE20 1632	518 GETCHR	LH R2,CONADR	PICK UP DEVICE NUMBER	MTE05170
148E	9B20	519	DC R2,CONRD		MTE05180
1490	9D20	520	RDR R2,R0	FORCE BUSY	MTE05190
1492	0210	521	SSR R2,R0		MTE05200
1494	2082	522	BTCR 1,R13	RETURN IF DU	MTE05210
1496	9B20	523	BTBS 8,2	LOOP ON BUSY	MTE05220
1498	C350 3004	524	RDR R2,R0		MTE05230
149C	2333	525	THI R5,MICROFLG	SEE IF MICRO I/O BUS	MTE05240
149E	9A20	526	BZS SENSET	SKIP IF NO	MTE05250
14A0	2308	527	WDR R2,R0	ECHO	MTE05260
14A2	C350 0080	528	BS SENSEX		MTE05270
14A6	2335	529 SENSET	THI R5,CAROUSEL	CAROUSEL 300?	MTE05280
14A8	2521	530	BZS SENSEX	SKIP IF NO	MTE05290
14AA	9D23	531	AIS R2,1	ODD ADDRESS	MTE05300
14AC	2081	532 SENSEM	SSR R2,R3		MTE05310
14AE	9A20	533	BCS SENSEM		MTE05320
14B0	C400 007F	534	WDR R2,R0		MTE05330
14B4	030D	535 SENSEX	NHI R0,X#7F*		MTE05340
		536	BR R13		MTE05350
					MTE05360

## SUBROUTINES

		S U B R O U T I N E	E R R M S G	
14B6	4320 1630	538 *		MTE05380
14BA	C550 0008	539 *		MTE05390
14BE	41C0 1334	540 ERMSG LH R2,CONAD	SET ERROR FLAG	MTE05400
14C2	2338	541 OHI R5,ERRFLG	TEST DU ON CONSOLE	MTE05410
14C4	4800 162C	542 BAL R12,TSTD0J	CONTINUE IF NO	MTE05420
14C8	2601	543 BZS ERMSG1		MTE05430
14CA	4000 162C	544 LH R0,TOTERR	INCREMENT ERROR TALLY	MTE05440
14CE	C500 FFFF	545 AIS R0,I		MTE05450
14D2	023D	546 STH RD,TOTERR		MTE05460
14D4	4300 1282	547 CLHI R0,X*FFFF*		MTE05470
14D8	4000 1524	548 BNTR R13		MTE05480
14DC	4100 1478	549 B HALT9		MTE05490
14E0	4800 162C	550 ERMSG1 STH R13,RETURN	SAVE RETURN	MTE05500
14E4	2135	551 BAL R13,CRLF	CARRIAGE RETURN, LINE-FEED	MTE05510
14E6	C840 1508	552 LH R0,TOTERR		MTE05520
14EA	4100 1354	553 BNZS ERMSG2	SKIP IF NOT FIRST ERROR	MTE05530
		554 LHI R4,MEMORY		MTE05540
		555 BAL R13,MESSAGE	OUTPUT TWO LINE MESSAGE:	MTE05550
		556 *	MEMORY DATA DATA	MTE05560
		557 *	LOCATION EXPECTED OBSERVED	MTE05570
		558 *		MTE05580
14EE	2401	559 ERMSG2 LIS R0,I	INCREMENT ERROR TALLY	MTE05590
14F0	6100 152C	560 AHM R0,TOTER-		MTE05600
14F4	C800 0020	561 LHI R0,X*20*		MTE05610
14F8	41C0 13FC	562 BAL R12,OUTCHR	TWO SPACES	MTE05620
14FC	41C0 13FC	563 BAL R12,OUTCHR		MTE05630
1500	087F	564 LHR R7,R15		MTE05640
1502	4100 1526	565 BAL R13,PRINR7	MEMORY LOCATION	MTE05650
1506	C840 1612	566 LHI R4,SPACE3		MTE05660
150A	4100 1354	567 BAL R13,MESSAGE	THREE SPACES	MTE05670
150E	0879	568 LHR R7,R9		MTE05680
1510	4100 1526	569 BAL R13,PRINR7	DATA EXPECTED	MTE05690
1514	C840 1610	570 LHI R4,SPACES		MTE05700
1518	4100 1354	571 BAL R13,MESSAGE	FIVE SPACES	MTE05710
151C	0878	572 LHR R7,R8		MTE05720
151E	4100 1526	573 BAL R13,PRINR7	DATA OBSERVED	MTE05730
1522	4300 1524	574 B RETURN		MTE05740
	0000 1524	575 RETURN EQU **-2		MTE05750

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SUBROUTINES

		577	*	S U B R O U T I N E	P R I N T R 7	
		578	*			MTE05770
1526	0766	579	PRINTR7	XHR	R6,R6	MTE05780
1528	E060 0004	580	SLL	R6,4	R6,R7 = 32 BIT REGISTER	MTE05790
152C	41C0 154A	581	BAL	R12,PRINTR6	R6 = R7 0:3	MTE05800
1530	E060 0004	582	SLL	R6,4	PRINT IT	MTE05810
1534	41C0 154A	583	BAL	R12,PRINTR6	R6 = R7 4:7	MTE05820
1538	E060 0004	584	SLL	R6,4	PRINT IT	MTE05830
153C	41C0 154A	585	BAL	R12,PRINTR6	R6 = R7 8:11	MTE05840
1540	E060 0004	586	SLL	R6,4	PRINT IT	MTE05850
1544	41C0 154A	587	BAL	R12,PRINTR6	R6 = R7 12:15	MTE05860
1548	030D	588	BR	R13	PRINT IT	MTE05870
						MTE05880
		590	*	S U B R O U T I N E	P R I N T R 6	
		591	*			MTE05900
154A	C460 000F	592	PRINTR6	NHI	R6,X=F	MTE05910
154E	D306 1555	593	LS	80,ASCII(R6)		MTE05920
1552	4300 13FC	594	S	OUTCHR	EXIT THROUGH OUTCHR	MTE05930
1556	3031 3233 3435 3637	595	*			MTE05940
155E	3839 4142 4344 4546	596	ASCII	DC	C#0123456789ABCDEF#	MTE05950
						MTE05960

## MESSAGES AND BUFFERS

1566	000A	598	TITLE1	DCX	000A,0000	MTE05280
1568	0000					
156A	382F 3135 2045 2045	599		DC	C'8/16 E EXTENDED MEMORY TEST PART 1 06-221R00'	MTE05290
1572	5854 454E 4445 4420					
157A	4D45 4D4F 5259 2054					
1582	4553 5420 5041 5254					
158A	2031 2020 3036 2032					
1592	3231 5230 3020					
1598	000A	600		DCX	000A,FFFF	MTE06000
159A	FFFF					
159C	0000	601	NOER	DC	X'0000',C'NO ERROR',X'FFFF'	MTE06010
159E	4E4F 2045 5252 4E22					
15A6	FFFF					
15A8	0000	602	MALEMMSG	DC	O,C'MACHINE MALFUNCTION ',X'FFFF'	MTE06020
15AA	4041 4348 494E 4520					
15B2	4041 4C46 554E 4354					
15B8	454F 4E20					
15BE	FFFF					
15C0	0000	603	ILLMSG	DC	O,C'ILLEGAL INSTRUCTION ',X'FFFF'	MTE06030
15C2	494C 4C45 4741 4C20					
15CA	494E 5354 5255 4354					
15D2	494F 4E20					
15D6	FFFF					
15D8	4045 4D4F 5259 2020	604	MEMORY	DC	C'MEMORY DATA',DATA,X'000A'	MTE06040
15E0	2044 4154 4120 2020					
15E8	2020 4441 5441					
15EE	000A					
15F0	0000	605		DC	X'0000'	MTE06050
15F2	4C4F 4341 5449 4F4E	606		DC	C'LOCATION EXPECTED OBSERVED',X'000A',X'FFFF'	MTE06060
15FA	2045 5850 4543 5445					
1602	4420 4F42 5345 5256					
160A	4544					
160C	000A					
160E	FFFF					
1610	2020	607	SPACES	DC	X'2020'	MTE06070
1612	2020	608	SPACES	DC	X'2020',X'20FF'	MTE06080
1614	20FF					
1616	2054 4F54 414C 2020	609	TOTALMSG	DC	C' TOTAL ',X'FFFF'	MTE06090
161E	FFFF					
1620	2045 5252 4F52 5320	610	ERRORS	DC	C' ERRORS ',X'FFFF'	MTE06100
1628	FFFF					
162A	0000	611	TOTAL	DCX	0	MTE06110
162C	0000	612	TOTERR	DCX	0	MTE06120
162E	40	613	INCRMNTL	DB	X'40'	MTE06130
162F	80	614	NORMAL	DB	X'80'	MTE06140
1630	0000	615	CONADR	DCX	0	MTE06150
1632	00	616	CON'D	DB	0	MTE06160
1633	00	617	CONWRT	DB	0	MTE06170
1634	0000	618	CON2ND	DC	0	MTE06180
1636	0000	619	CONRQ2S	DC	0	MTE06190
1638	0303	620	MICRORST	DCX	0303	MTE06200
163A	8222	621	MICRORD	DCX	8222	MTE06210
163C	A9AB	622	CARRD	DCX	A9AB	MTE06220

MODEL 8/16 E EXTENDED MEMORY TEST 06-221R00496 PART 1 PAGE 22 08:31:43 08/12/80  
MESSAGES AND BUFFERS

163E	F000	623	CAR2ND	DCX	F000	
1640	23	624	CARRQ2S	DB	X'23'	MTE06230
1641	38	625	CRTRQ2C	DB	X'38'	MTE06240
1642	B9AB	626	CRTRD	DCX	B9AB	MTE06250
1644	F879	627	CRT2ND	DCX	F879	MTE06260
1646	A4D8	628	CLIFRD	DCX	A4D8	MTE06270
1648	0000	629	CLIF2ND	DCX	0000	MTE06280
	0000 1649	630	LNZB	EQU	*-1	MTE06290
						MTE06300

## CHKSUM/M17 PUNCHER

164A 2400	532	SCHKSUM	LIS	R0,C	PUNCH M17 TAPE WITH CHECKSUM	MTE06320
164C 9510	533		EPSR	R1,R0	SELECT REG. SET 0	MTE06330
	534 *					MTE06340
164E C810 1000	635		LDAI	R1,ORIGIN1	START	MTE06350
1652 2421	636		LIS	R2,1	INCREMENT	MTE06360
1654 C830 1649	637		LDAI	R3,LNZB	FINAL	MTE06370
1658 2440	638		LIS	R4,0	CHECKSUM BYTE	MTE06380
165A D351 0000	639	\$GEN	LB	R5,0(R1)		MTE06390
165E 9745	640		XAR	R4,R5		MTE06400
1660 C110 165A	641		BXLE	R1,\$GEN		MTE06410
1664 D240 0080	642		STS	R4,MN+3	CHECKSUM BYTE TO BOOT LOADER	MTE06420
	643 *					MTE06430
1668 C810 0080	644	STAPE	LHI	R1,X'0080'	DISPLAY : NORMAL MODE	MTE06440
166C 9E21	645		OCR	R2,R1		MTE06450
166E 9444	646		EXBR	R4,R4		MTE06460
1670 9824	647		WHR	R2,R4	CHECKSUM BYTE TO D1	MTE06470
1672 9411	648		EXBR	R1,R1		MTE06480
1674 9501	649		EPSR	R0,R1	HALT PROCESSOR.	MTE06490
1676 D360 007A	651	\$PUNCH	LB	R6,X'7A'	GET BOUTDN (PUNCH) ADDRESS.	MTE06510
167A DE60 007B	652		OC	R6,X'7B'	START TAPE PUNCH	MTE06520
167E 9960	653		SSR	R6,R0		MTE06530
1680 2081	654		BTBS	8,1		MTE06540
1682 41F0 16C4	655		BAL	R15,\$TAPL	PUNCH LEADER	MTE06550
1686 9411	656		EXBR	R1,R1	(R1) = X'0080'	MTE06560
1688 C830 00CF	657		LHI	R3,X'CF'		MTE06570
168C DA61 0000	658	\$PNCH1	WD	R6,0(R1)	PUNCH BOOT LOADER	MTE06580
1690 9060	659		SSR	R6,R0		MTE06590
1692 2081	660		BTBS	8,1		MTE06600
1694 C110 168C	661		BXLE	R1,\$PNCH1		MTE06610
1698 41F0 16CA	662		BAL	R15,\$TAPL1	PUNCH ONE-FOLD GAP.	MTE06620
	663 *					MTE06630
169C D340 0080	664		LB	R4,MN+3	GET CHECKSUM BYTE	MTE06640
16A0 C810 1000	665		LDAI	R1,ORIGIN1	(NORMALLY X'A0C0')	MTE06650
16A4 C830 1649	666		LDAI	R3,LNZB		MTE06660
16A8 D351 0000	667	\$PNCH2	LB	R5,0(R1)	PUNCH PROGRAM	MTE06670
16AC 0745	668		XAR	R4,R5		MTE06680
16AE 9A65	669		WCR	R6,R5		MTE06690
16B0 9401	670		EXBR	R0,R1		MTE06700
16B2 9820	671		WHR	R2,R0	DATA ADDRESS TO DISPLAY	MTE06710
16B4 9060	672		SSR	R6,R0		MTE06720
16B6 2081	673		BTBS	8,1		MTE06730
16B8 C110 16A8	674		BXLE	R1,\$PNCH2		MTE06740
16BC 41F0 16C4	675		BAL	R15,\$TAPL	PUNCH TRAILER.	MTE06750
16C0 4300 1668	676		B	\$TAPE	DISPLAY CHECKSUM, HALT PROCESSOR	MTE06760
16C4 C800 0100	678	\$TAPL	LHI	R0,256	TO PNCH BLANK LEADER	MTE06780
16C8 2303	679		BS	\$TAPLP		MTE06790
16CA C800 0055	680	\$TAPL1	LHI	R0,85	TO PNCH 1-FOLD GAP	MTE06800

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CHKSUM/M17 PUNCHER

15CE 2701	681	\$TAPLP	SIS	R0,1	
16D0 032F	682		BNPR	R15	RETURN
16D2 2430	683		LIS	R3,C	MTE06810
16D4 9A63	684		WCR	R6,R3	MTE06820
16D6 9D68	685		SSR	R6,R8	MTE06830
16D8 2081	686		BTBS	8,1	MTE06840
16DA 2206	687		BS	\$TAPLP	MTE06850
16DC	688		END		MTE06860
					MTE06870
					MTE06880

MODEL 8/16 E EXTENDED MEMORY TEST 06-221ROOM96 PART 1

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CHKSUM/M17 PUNCHER

ASSEMBLED BY CAL 03-066R03-00 (32-BIT)

START OPTIONS: \*NONE\*

NO CAL ERRORS  
1 CAL WARNING PREVIOUS WARNING ON PAGE 1  
2 PASSES

TABLE SPACE USED : 5K

\$CHKSUM	0000 154A	632*					
\$GEN	0000 155A	639*	541				
\$PNCH1	0000 158C	658*	561				
\$PNCH2	0000 15A8	657*	574				
\$PUNCH	0000 1576	651*					
\$TAPE	0000 1568	644*	576				
\$TAPL	0000 15C4	655	575	678*			
\$TAPL1	0000 15CA	652	580*				
\$TAPLP	0000 15CE	679	581*	587			
ABSTOP	0000 15DC						
ADC	0000 0002						
ALSEQUNC	0000 1250	312	315*				
ASCII	0000 1556	593	596*				
C300	0000 1044	107	118*				
C300ADR	0000 100C	96*	118				
CAR2ND	0000 153E	123	523*				
CAROUSEL	0000 0380	57*	122	466	529		
CARRD	0000 153C	119	522*				
CARRQ2S	0000 1540	121	524*				
CLIF2ND	0000 1548	135	629*				
CLIFADR	0000 100A	35*	133				
CLIFRD	0000 1546	134	628*				
CON2ND	0000 1534	138	403	618*			
CONADR	0000 1530	136	400	531	518	540	615*
CONRD	0000 1632	137	432	519	615*		
CONRQ2S	0000 1636	131	519*				
CONT02	0000 1462	494	498*				
CONWRIT	0000 1433	492	517*				
CRLF	0000 1478	302	336	353	371	510*	551
CRT	0000 105A	105	124*				
CRT2	0000 106A	123	128*				
CRT2ND	0000 1544	125	527*				
CRTRD	0000 1542	125	626*				
CRTRQ2S	0000 1541	127	625*				
DEVSET	0000 1084	117	132	136*			
ERRFLG	0000 0008	55*	294	541			
ERRMSG	0000 1496	173	195	218	250	272	285
ERRMSS1	0000 14D8	543	550*				
ERRMSS2	0000 14EE	553	559*				
ERRORS	0000 1620	343	610*				
EXECUTE	0000 1090	140*					
GETCHR	0000 1486	307	518*				
HALT3	0000 00B4	81*					

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CHKSUM/M17 PUNCHER

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CHKSUM/M17 PUNCHER

## CHKSUM/M17 PUNCHER

SENSEX	0000 1480	528	530	535*					
SETDU	0000 1350	389	395*						
SETUP	0000 1448	483*							
SETUP1	0000 1452	491	492*						
SPACE3	0000 1612	565	603*						
SPACES	0000 1610	570	607*						
START1	0000 1012	26	102*	309					
STARTX	0000 0088	61	83*						
STRTTEST	0000 19C4	157*	323						
TEND01	0000 120E	295	298*						
TEST-END	0000 11F4	240*							
TEST0	0000 10CA	162*							
TEST0.01	0000 10CE	163*	165						
TEST0.02	0000 10DE	169*	176						
TEST0.03	0000 10EC	172	174*						
TEST1	0000 10F4	180*							
TEST1.01	0000 10FA	182*	187						
TEST1.02	0000 110E	193*	198						
TEST1.03	0000 111E	194	195*						
TEST2	0000 1126	203*							
TEST2.01	0000 112A	204*	210						
TEST2.02	0000 112E	205*	211						
TEST2.03	0000 1140	209	213*						
TEST2.04	0000 1144	214*	223						
TEST2.05	0000 1148	215*	224						
TEST2.06	0000 1154	217	219*						
TEST3	0000 1162	221	230*						
TEST3.01	0000 1168	232*	240						
TEST3.02	0000 116A	233*	241						
TEST3.03	0000 1180	238	243*						
TEST3.04	0000 1184	244*	255						
TEST3.05	0000 1186	245*	256						
TEST3.06	0000 1196	249	251*						
TEST4	0000 11A4	253	260*						
TEST4.01	0000 11AA	262*	265						
TEST4.02	0000 11BC	269*	276						
TEST4.03	0000 11C8	271	273*						
TEST4.04	0000 11DC	281*	288						
TEST4.05	0000 11EC	284	286*						
TESTDU1	0000 1348	385	392*						
TITLE1	0000 1566	142	598*						
TOTAL	0000 152A	155	293	321	322	326	337	511*	
TOTALMSG	0000 1616	339	607*						
TOTERR	0000 152C	155	323	324	341	544	548	552	560
TSTBRK	0000 13A8	431*							
TSTBRK0	0000 138E	438*	445						
TSTBRK1	0000 13CA	437	443*						
TSTBRK2	0000 13D8	437	448*						
TSTBRK3	0000 13F0	449	458*	460					
TSTBRK4	0000 13F8	447	457	461*					
TSTDU	0000 1334	293	333	184*	404	469	487	542	
TTY	0000 1078	108	110	133*					
WASDU	0000 0001	52*	153	318	335	405	408	413	425

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CHKSUM/M17 PUNCHER

WASD01 0000 0002 53\* 153 300 414

PROG= MT816E ASSEMBLED BY CAL 03-066R08-00 (32-BIT)

2	SCRAT	MTE00020
3	CROSS	MTE00030
4	TARGT 16	MTE00040
5		
6	* PROGRAM IS DESIGNED TO TEST ALL OF MEMORY FROM THE TOP OF THE	MTE00060
7	* TEST PROGRAM TO THE TOP OF AVAILABLE MEMORY. THE HOST PROCESSOR	MTE00070
8	* IS ASSUMED TO BE A 7/16 OR EQUIVALENT WITH A MAXIMUM ADDRESSING	MTE00080
9	* CAPABILITY OF 256 KB (HEX *40000*). THE PROGRAM ALSO ASSUMES	MTE00090
10	* THAT ALL OF MEMORY IS CONTIGUOUS - NO HOLES IN MEMORY.	MTE00100
11	*	MTE00110
12	* DURING TESTING, ALL KNOWN WORST-CASE DATA PATTERNS ARE USED.	MTE00120
13	* EVERY AVAILABLE LOCATION IS TESTED AS A DATA SOURCE AND AS AN	MTE00130
14	* INSTRUCTION SOURCE. THE LATTER IS ACCOMPLISHED BY RELOCATING	MTE00140
15	* A SUBROUTINE THROUGH EVERY HALFWORD AND THEN EXECUTING IT.	MTE00150
16	*	MTE00160
17	* PROGRAM IS LOADED USING THE STANDARD 50 SEQUENCE	MTE00170
18	* AFTER LOADING, THE PROCESSOR HALTS. IF THE CHECKSUM BYTE	MTE00180
19	* SHOWN ON THE LOW ORDER 16 DISPLAY INDICATORS IS NOT ZERO,	MTE00190
20	* REPEAT THE LOADING PROCESS.	MTE00200
21	*	MTE00210
22	* IF THE CONSOLE DEVICE IS A TTY,GDT,CRT OR CAROUSEL 15,30 OR 35	MTE00220
23	* ON A CURRENT LOOP INTERFACE (DEVICE ADDRESS X*02*), PRESS "RUN".	MTE00230
24	*	MTE00240
25	* IF THE CONSOLE DEVICE IS NOT A TTY,GDT,CRT OR CAROUSEL 15,30 OR 35 ON	MTE00250
26	* A CURRENT LOOP INTERFACE, THE HALFWORD LABELED "IO" MUST BE MODIFIED	MTE00260
27	*	MTE00270
28	* CONSOLE DEVICE IDENTIFIER:	MTE00280
29	*	MTE00290
30	01 = GDT OR CRT ON PASLA OR PALM (FDX, HIGHEST BAUD RATE)	MTE00300
31	02 = TTY,GDT,CRT OR CAROUSEL 15,30 OR 35 ON CURRENT LOOP INF	MTE00310
32	03 = RESERVED, INTERPRETED AS '02'	MTE00320
33	04 = CAROUSEL 300 ON PASLA OR PALM (FDX, HIGHEST BAUD RATE)	MTE00330
34	05 = TTY,GDT,CRT OR CAROUSEL 15,30 OR 35 ON MICRO I/O CLI	MTE00340
35	00 AND 06:FF = RESERVED, INTERPRETED AS '02'	MTE00350

0000 0000	37	*		
0000 0001	38	R0	EQU 0	ASCII CHARACTER FOR I/O MTE00370
0000 0002	39	R1	EQU 1	PROGRAM ADDRESS MTE00380
0000 0003	40	R2	EQU 2	CONSOLE DEVICE NUMBER MTE00390
0000 0004	41	R3	EQU 3	G.P. ACCUMULATOR MTE00400
0000 0005	42	R4	EQU 4	MESSAGE START ADDRESS MTE00410
0000 0006	43	R5	EQU 5	STATE REGISTER MTE00420
0000 0007	44	R6	EQU 6	HEX DIGIT FOR ERROR PRINT-OUT MTE00430
0000 0008	45	R7	EQU 7	HALFW-ORD FOR ERROR PRINT MTE00440
0000 0009	46	R8	EQU 8	OBSERVED MEMORY DATA MTE00450
0000 000A	47	P9	EQU 9	EXPECTED MEMORY DATA MTE00460
0000 000B	48	R10	EQU 10	DATA PATTERN REGISTER MTE00470
0000 000C	49	R11	EQU 11	DATA PATTERN REGISTER MTE00480
0000 000D	50	R12	EQU 12	MINOR LINK REGISTER MTE00490
0000 000E	51	R13	EQU 13	MAJOR LINK REGISTER MTE00500
0000 000F	52	R14	EQU 14	MS MEMORY ADRS MTE00510
	53	R15	EQU 15	LS MEMORY ADRS MTE00520
	54	*		MTE00530
	55	*		MTE00540
	56	*		MTE00550
	57	*	STATE REGISTER BIT DEFINITIONS	MTE00560
	58	*		MTE00570
0030 0001	59	WASDU	EQU X'0001'	CONSOLE DU FLAG MTE00580
0000 0002	60	WASDU1	EQU X'0002'	AUXILARY DU FLAG MTE00590
0000 0004	61	MICROFLG	EQU X'0004'	CONSOLE MICRO I/O BUS FLAG MTE00600
0000 0008	62	ERRFLG	EQU X'0008'	
0000 0020	63	TSTFLG	EQU X'0020'	MTE00610
0000 3040	64	PAUSE	EQU X'0040'	MTE00620
0000 0080	65	CAROUSEL	EQU X'0080'	MTE00630
0000 0100	66	PASFLG	EQU X'0100'	MTE00640
0000 0400	67	ISITERR	EQU X'0400'	PASLA/PALM FLAG MTE00650
0000 C800	68	EXTMEM	EQU X'0800'	ERROR MESSAGE FLAG MTE00660
0000 1000	69	PARITY	EQU X'1000'	MORE THAN 64KB MTE00670
				FIRST PARITY ERROR FLAG MTE00680
				MTE00690

## BOOT LOADER

0000R		71	ORG	X"80"	MTE00710
0080 C810 0100		72	LHI	R1,ORIGIN1	MTE00720
0084 2421		73	LIS	R2,1	MTE00730
0086 C830 10C7		74	LHI	R3,LNZB	MTE00740
008A C860 00FF		75 MN	LHI	R6,X"FF"	MTE00750
008E D340 0078		76	LS	R4,X"78"	MTE00760
0092 DE40 0079		77	OC	R4,X"79"	MTE00770
0096 9D45		78 STATUS1	SSR	R4,R5	MTE00780
0098 2001		79	BTBS	X"0",1	MTE00790
009A 9845		80	RDR	R4,R5	MTE00800
009C 0855		81	LHR	R5,R5	MTE00810
009E 2234		82	BZS	STATUS1	MTE00820
00A0 0251 0000		83 STOREBYT	ST3	R5,0(R1)	MTE00830
00A4 0765		84	XHR	R6,R5	MTE00840
00A6 9A26		85	WDR	R2,R6	MTE00850
00A8 9D45		86 STAT1	SSR	R4,R5	MTE00860
00AA 20D1		87	BT3S	X"0",1	MTE00870
00AC 9345		88	RDR	R4,R5	MTE00880
00AE C110 00A0		89	BXLE	R1,STOREBYT	MTE00890
00B2 9A26		90	WDR	R2,R6	MTE00900
00B4 C200 00B3		91	LPSW	LDWT	MTE00910
00B8		92	ALIGN	8	MTE00920
00B8 8000		93 LDWT	DC	X"8000",ORIGIN1	MTE00930
00BA 0100					

## MODEL 8/16 E EXTENDED MEMORY TEST 06-221R00496 PART 2

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00BC		95	ORG	X'0100'		
0100	2309	96	ORIGIN1	BS	START2	MTE00950
		97	*			MTE00960
		98	*			MTE00970
0102	3000	99	PSW	DCX	3000	MTE00980
0104	0000	100	PSW2	DCX	0000	MTE00990
		101	*			MTE01000
		102	*			MTE01010
0106	0002	103		DCX	0002	MTE01020
0108	0010	104	PASLADR	DCX	0010	MTE01030
010A	0002	105	CLIFADR	DCX	0002	MTE01040
010C	0010	106	C300ADR	DCX	0010	MTE01050
010E	0000	107	MICROIO	DCX	00C0	MTE01060
		108	*			MTE01070
0110	0202	109	IO	DCX	0202	MTE01080
		110	*			MTE01090
	0000 0008	111	MAXTST	EQU	8	MTE01100
		112	*			MTE01110
0112	0300 0110	113	START2	L8	R0,IO	MTE01120
0116	0755	114		XHR	R5,R5	MTE01130
0118	2701	115		SIS	R0,1	MTE01140
011A	4330 015A	116		BZ	CRT	MTE01150
011E	2703	117		SIS	PC,3	MTE01160
0120	4330 0144	118		SZ	C300	MTE01170
0124	4210 0173	119		BM	TTY	MTE01180
0128	2701	120		SIS	R0,1	MTE01190
012A	4230 0178	121		BNZ	TTY	MTE01200
		122	*			MTE01210
012E	0650 0004	123		OHI	R5,MICROFLG	MTE01220
0132	4820 010E	124		LH	R2,MICROIO	MTE01230
0136	4810 09FE	125		LH	R1,MICRORD	MTE01240
013A	0700	126		XHR	R0,RC	MTE01250
013C	DE20 09FD	127		OC	R2,MICRORST	MTE01260
0140	4300 0184	128		B	DEVSET	MTE01270
0144	4820 010C	129	C300	LH	R2,C300ADR	MTE01280
0148	4910 0A00	130		LH	R1,CARRD	MTE01290
014C	4800 0A02	131		LH	R0,CAR2ND	MTE01300
0150	D340 0A04	132		LB	R4,CARRQ2S	MTE01310
0154	C650 0080	133		OHI	R5,CAROUSEL	MTE01320
0158	2309	134		BS	CRT2	MTE01330
015A	4820 0108	135	CRT	LH	R2,PASLADR	MTE01340
015E	4810 0A06	136		LH	R1,CRTRD	MTE01350
0162	4800 0A08	137		LH	R0,CRT2ND	MTE01350
0166	D340 0A05	138		LB	R4,CRTRQ2S	MTE01370
016A	C650 0100	139	CRT2	OHI	R5,PASFLG	MTE01380
016E	9460	140		EXBR	R6,RD	MTE01390
0170	9E26	141		OCR	R2,R6	MTE01400
0172	D240 09FC	142		ST3	R4,CONRQ2S	MTE01410
0176	2307	143		BS	DEVSET	MTE01420
0178	4920 010A	144	TTY	LH	R2,CLIFADR	MTE01430
017C	4810 0A0A	145		LH	R1,CLIFRD	MTE01440
0180	4800 0A0C	146		LH	R0,CLIF2ND	MTE01450
0184	4020 09F6	147	DEVSET	STH	R2,CONADR	MTE01460
0188	4010 09F8	148		STH	R1,CONRD	MTE01470
018C	4000 09FA	149		STH	R0,CON2ND	MTE01480
						MTE01490

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0190	0733	151	EXECUTE	XHR	R3,R3		MTE01510
0192	9503	152		EPSR	R0,R3	CLEAR PSW	MTE01520
		153	*				MTE01530
0194	C840 085C	154		LHI	R4,TITLE?	TITLE START ADDRESS	MTE01540
0198	4100 0572	155		BAL	R13,MESSAGE	PRINT "S16 EXTENDED MEMORY TEST"	MTE01550
		156	*				MTE01560
		157	*				MTE01570
019C	07EE	158		XHR	R14,R14	R14,R15 = 8K MARK	MTE01580
019E	C8F0 2000	159		LHI	R15,X'2000'	START ADDRESS FOR SEARCH	MTE01590
		160	*				MTE01600
01A2	D0E0 0A1E	161		STM	R14,LOW+6	DEFAULT LOW LIMIT	MTE01610
01A6	C8A0 5050	162		LHI	R10,X'5050'	DATA PATTERN IS X'5050'	MTE01620
01AA	4100 072C	163	FINDMAX	BAL	R13,ADRSET	SET UP ADDRESS	MTE01630
01AE	40A1 0000	164		STH	R10,0(R1)	STORE PATTERN	MTE01640
01B2	40D0 10C8	165		STH	R13,LAST		MTE01650
01B6	45A1 0000	166		CLH	R10,0(R1)	READ BACK AND COMPARE	MTE01660
		167	*			IF READ BACK IS AT ALL DIFFERENT	MTE01670
		168	*			FROM THE PATTERN, ASSUME TOP OF	MTE01680
						MEMORY HAS BEEN FOUND	MTE01690
01B8	4230 01FE	169		BNE	FOUNDT	INCREMENT TEST ADRS BY 8K	MTE01700
01B8	CAF0 2000	170		AHI	R15,X'2000'		MTE01710
01C2	228C	171		BNCS	FINDMAX		MTE01720
01C4	40A0 FFFF	172		STH	R10,X'FFFF'	STORE PATTERN	MTE01730
01C8	C890 0010	173		LHI	R8,X'10'		MTE01740
01CC	9518	174		EPSR	R1,R8	CHANGE BANK SELECT BITS	MTE01750
01CE	24E1	175		LIS	R14,1		
01D0	07FF	176		XHR	R15,R15	R14,R15 = 10000	MTE01760
01D2	45A0 FFFF	177		CL4	R10,X'FFFF'	SEE IF SAME PATTERN	MTE01770
01D6	4330 01FE	178		BE	FOUNDT	IF YES, TOP = 64KB	MTE01780
01DA	C650 0800	179		CHI	R5,EXTMEM	SET EXTENDED MEMORY FLAG	MTE01790
01DE	4100 072C	180	TOM2	BAL	R13,ADRSET	CONTINUE SEARCH FROM 10000	MTE01800
01E2	40A1 0000	181		STH	R10,0(R1)	STORE PATTERN	MTE01810
01E6	4000 10C8	182		STH	R13,LAST	CLEAR MEMORY DATA	MTE01820
01EA	45A1 0000	183		CLH	R10,0(R1)	READ BACK AND COMPARE	MTE01830
01EE	2138	184		BNES	FOUNDT	IF DIFFER, TOP FOUND	MTE01840
01F0	CAF0 2000	185		AHI	R15,X'2000'	NEXT 8KB	MTE01850
01F4	4EE0 09E4	186		ACH	R14,ZERO		MTE01860
01F8	C5E0 0004	187		CLHI	R14,4	SEARCH LIMIT LESS THAN '40000'	MTE01870
01FC	208F	188		BLS	TOM2		MTE01880
		189	*				MTE01890
01FE	27F2	190	FOUNDT	SIS	R15,2	R14,P15 = ADDRESS OF LAST HALFWORD	MTE01900
0200	4FE0 09E4	191		SCH	R14,ZERO	IN MEMORY. STORE RESULT AT MAXMEM	MTE01910
0204	D0E0 09E0	192		STM	R14,MAXMEM		MTE01920
0208	D0E0 0A28	193		STM	R14,HIGH+6	DEFAULT HIGH LIMIT	MTE01930
		194	*				MTE01940
020C	C840 08A2	195		LHI	R4,PDMXMM	PRINT MESSAGE	MTE01950
0210	4100 0572	196		BAL	R13,MESSAGE		MTE01960
0214	086E	197		LHR	R6,R14		MTE01970
0216	41C0 0810	198		BAL	R12,PRINTR6		MTE01980
021A	087F	199		LHR	R7,R15		MTE01990
021C	4100 07EC	200		BAL	R13,PRINTR7		MTE02000
0220	C890 0A2C	201		LHI	R9,LOOP	LOOP THROUGH OPTION TABLE	MTE02010
0224	48A9 0000	202	DEF.OPT	LH	R10,0(R9)	TEST TABLE ENTRY	MTE02020
0228	2117	203		BMS	OPTIN	DONE	MTE02030
022A	48A9 0008	204		LH	R10,8(R9)	PICK UP DEFAULT VALUE	MTE02040
022E	40A9 0006	205		STH	R10,6(R9)	MAKE IT CURRENT	MTE02050

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0232	269A	206	AIS	R9,10		
0234	2208	207	BS	DEF.OPT	LOOP	MTE02060
		208 *				MTE02070
		209 *				MTE02080
0236	4100 06A4	210	OPTIN	BAL R13,CRLF		MTE02090
023A	C800 002A	211	OPTIN1	LHI R0,C*'*	OUTPUT AN ASTERISK TO	MTE02100
023E	4100 0628	212	BAL	R12,OUTCHR	INDICATE COMMAND MODE	MTE02110
0242	2501	213	LCS	R0,1		MTE02120
0244	4100 J628	214	BAL	R12,OUTCHR	DELETE	MTE02130
		215 *				MTE02140
		216 *				MTE02150
0248	4860 0104	217	RETRY	LH R6,PSW2		MTE02160
024C	9506	218	EPSR	R0,RS	CLEAR PSW	MTE02170
024E	0766	219	XHR	R6,R6		MTE02180
0250	4060 0034	220	STH	R6,X'34'	*00034*=NEW PSW, ILLEGAL INSTR	MTE02190
0254	4060 003C	221	STH	R6,X'3C'	*0003C*=NEW PSW, MACHINE MALFNCTY	MTE02200
0258	C500 04CA	222	LHI	R0,PARERR		MTE02210
025C	4000 003E	223	STH	R0,X'3E'		MTE02220
0260	C800 0526	224	LHI	R0,ILLEG-		MTE02230
0264	4000 0034	225	STH	R0,X'36'		MTE02240
		226 *				MTE02250
0268	C800 2020	227	LHI	R0,X'2020'	CLEAR COMMAND BUFFER	MTE02260
026C	4000 09F0	228	STH	R0,OPTBUF		MTE02270
0270	4000 09F2	229	STH	R0,OPTBUF+2		MTE02280
0274	4000 09F4	230	STH	R0,OPTBUF+4		MTE02290
0278	2430	231	LIS	R8,0	OPTBUF INDEX	MTE02300
027A	4100 0632	232	RDCHAR	BAL R13,GETCHR	GET A CHARACTER IN R	MTE02310
027E	C500 0060	233	CLHI	R0,X'60'	LOWER CASE ALPHA	MTE02320
0282	2183	234	BLS	RDCHAR0	SKIP IF NO	MTE02330
0284	C800 0020	235	SHI	R0,X'20'	CONVERT TO UPPER CASE	MTE02340
0288	C500 0023	236	RDCHAR0	CLHI R0,X'23'	IS IT #?	MTE02350
028C	4330 0235	237	BE	OPTIN	CANCEL & RESTART EXEC	MTE02360
0290	C500 005F	238	CLHI	R0,X'5F'	LEFT ARROW?	MTE02370
0294	213A	239	BNES	RDCHAR1	SKIP IF NO	MTE02380
0296	2781	240	SIS	R9,1	DECREMENT INDEX	MTE02390
0298	4210 0380	241	BM	QMARK	ERROR	MTE02400
029C	C800 0020	242	LHI	R0,X'20'		MTE02410
02A0	D208 09F0	243	STB	R0,OPTBUF(R8)	BLANK OUT LAST CHARACTER	MTE02420
02A4	4300 027A	244	B	RDCHAR		MTE02430
02A8	C500 000D	245	RDCHAR1	CLHI R0,X'0D'	CARRIGE RETURN?	MTE02440
02AC	233D	246	BES	LOOKUP	TRY FOR A MATCH IF YES	MTE02450
02AE	C500 0020	247	CLHI	R0,X'20'	SPACE?	MTE02460
02B2	233A	248	BES	LOOKUP		MTE02470
02B4	C580 0006	249	CLHI	R8,6	SIX CHARACTERS ALREADY?	MTE02480
02B8	4380 0380	250	BNL	QMARK	ERROR IF YES	MTE02490
02BC	D208 09F0	251	STB	R0,OPTBUF(R8)	STORE CHARACTER	MTE02500
02C0	2681	252	AIS	R8,1	BUMP INDEX	MTE02510
02C2	4300 027A	253	B	RDCHAR	LOOP	MTE02520
		254 *				MTE02530
02C6	C890 0A0E	255	LOOKUP	LHI R9,OPT	START OF OPTION TABLE	MTE02540
02CA	0788	256	LOOK1	XHR R8,R8	OPTBUF INDEX	MTE02550
02CC	08A9	257	LHR	R10,R9	OPTION WORD INDEX	MTE02560
02CE	481A 0000	258	LOOK2	LH R1,0(R10)	HALFWORD FROM LOOK-UP TABLE	MTE02570
02D2	4210 0330	259	BM	QMARK	ERROR	MTE02580
02D6	4518 09F0	260	CLH	R1,OPTBUF(R8)	COMPARE TO HW FROM OPTBUF	MTE02590
						MTE02600

02DA	2333	251	BES	LOOK3	MATCH...TRY ANOTHER HALFWORD	MTE02610
02DC	269A	252	AIS	R9,10	NO MATCH, TRY NEXT TABLE ENTRY	MTE02620
02DE	220A	253	BS	LOOK1		MTE02630
02E0	2682	254	LOOK3	AIS	TRY NEXT HALFWORD	MTE02640
02E2	26A2	255	AIS	R8,2		MTE02650
02E4	0580 0306	256	CLHI	R8,6	MATCH 3 HALFWORDS?	MTE02660
02E8	208D	257	BLS	LOOK2	LOOP IF NO	MTE02670
		258	*			MTE02680
		259	*	COMMAND MATCH		MTE02690
		270	*	R9 = COMMAND DELIMITER CHARACTER (SPACE OR CARRIAGE RETURN)		MTE02700
		271	*	R9 = START ADDRESS OF MATCHING COMMAND TABLE ENTRY		MTE02710
		272	*			MTE02720
02EA	C590 0A0E	273	CLHI	R9,RUN	RJN COMMAND?	MTE02730
02EE	4330 0356	274	BE	RUNIT		MTE02740
02F2	C590 0A36	275	LOOK4	CLHI	TEST COMMAND?	MTE02750
02F6	4330 0324	276	BE	TESTOP		MTE02760
02FA	270D	277	SIS	R0,13	DELIMETER = CARRIAGE RETURN?	MTE02770
02FC	4330 03B0	278	BZ	QMARK	ERROR IF YES...HAS TO BE SPACE	MTE02780
0300	41D0 06E2	279	BAL	R13,OPTVAL	GET OPTION VALUE IN R14,R15	MTE02790
0304	270D	280	SIS	R0,13	TERMINATED BY CARRIAGE RETURN?	MTE02800
0306	4230 03B0	281	BNZ	QMARK	ERROR IF NO	MTE02810
030A	40F9 0006	282	STH	R15,6(R9)	STORE LS 16 BITS	MTE02820
030E	C590 0A18	283	CLHI	R9,LOW	LOW ADDRESS OPTION	MTE02830
0312	2335	284	BES	LOOK4.1	STORE 32 BIT VALUE IF YES	MTE02840
0314	C590 0A22	285	CLHI	R9,HIGH	HIGH ADDRESS OPTION	MTE02850
0318	4230 0236	286	BNE	OPTIN		MTE02860
031C	D0E9 0006	287	LOOK4.1	STM	STORE 32 BIT VALUE	MTE02870
0320	4300 0236	288	S	OPTIN	NEXT COMMAND	MTE02880
		289	*			MTE02890
0324	270D	290	TESTOP	SIS	CARRIAGE RETURN?	MTE02900
0326	2137	291	BNZS	TESTOP1	SKIP IF NO	MTE02910
0328	43F0 0A3E	292	LH	R15,DEFTSTS	IF CARRIAGE RETURN,	MTE02920
032C	40F0 0A3C	293	STH	R15,TEST+6	SELECT DEFAULT TESTS	MTE02930
0330	4300 0236	294	B	OPTIN	NEXT COMMAND	MTE02940
0334	0777	295	TESTOP1	XHR	CLEAR BIT ACCUMULATOR	MTE02950
0336	41D0 06E2	296	TESTOP2	BAL	GET VALUE IN R14,R15	MTE02960
033A	C5F0 0009	297	CLHI	R15,MAXTST+1		MTE02970
033E	4380 03B0	298	BNL	QMARK	ERROR, INVALID TEST	MTE02980
0342	0AFF	299	AHR	R15,*R15	CONVERT TO HALFWORD INDEX	MTE02990
0344	48FF 09A8	300	LH	R15,BIT0(R15)	PICK UP BIT	MTE03000
0348	067F	301	OHR	R7,R15	OR INTO BIT ACCUMULATOR	MTE03010
034A	270D	302	SIS	R0,13	CARRIAGE RETURN?	MTE03020
034C	2038	303	BNZS	TESTOP2	LOOP IF NO	MTE03030
034E	40F0 0A3C	304	STH	R7,TEST+5	SAVE SELECTED TESTS	MTE03040
0352	4300 0236	305	B	OPTIN	NEXT COMMAND	MTE03050
		307	RUNIT	BAL	R13,CRLF	MTE03070
0356	41D0 06A4	308	NHI	R5,-1-WASDU-WASDU1-ISITERR		MTE03080
035A	C450 F8FC	309	XHR	R0,R0		MTE03090
035E	0700	310	STH	R0,COUNT	CLEAR LOOP COUNT	MTE03100
0360	4000 09E6	311	STH	R0,TOTAL	CLEAR TOTAL	MTE03110
0364	40D0 09E8	312	STH	R0,TOTERR		MTE03120
0368	4000 09EA	313	KEEP3	STH	R0,SUBST	MTE03130

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0400	2135	364	BNZS	NEXTTEST	NEXT TEST IF YES	MTE03640
0402	C840 0808	365	LHI	R4,NOER	PRINT MESSAGE "NO ERROR"	MTE03650
0406	4100 0572	366	BAL	R13,MESSAGE	INCREMENT TO NEXT SUBTEST	MTE03660
040A	2411	367	NEXTTEST	LIS R1,1	CLEAR LOOP COUNTER	MTE03670
040C	6110 09EE	368	AHM	R1,SUBTST	PICK UP NEXT SUBTEST NUMBER	MTE03680
0410	0700	369	XHR	R0,R0	LAST TEST?	MTE03690
0412	4000 09E6	370	STH	R0,COUNT	NO, SELECT NEXT TEST	MTE03700
0416	4810 09EE	371	KEEP7.1	LH R1,SUBTST	MTE03710	
041A	C510 0009	372	CLHI	R1,MAXTST+1	MTE03720	
041E	4280 0370	373	BL	SUBSEL	MTE03730	
0422	4000 09EE	374	STH	R0,SUBTST	MTE03740	
		375 *				MTE03750
0426	41C0 0552	376	ABORT	BAL R12,TSTDU	CHECK CONSOLE DU	MTE03760
042A	4230 045E	377	BNZ	KEEP9	IF DU, DISPLAY TOTAL	MTE03770
042E	C350 0002	378	THI	R5,WASDU1	WAS IT EVER DU ?	MTE03780
0432	4230 0494	379	BNZ	KEEP92	YES, PRINT TOTAL, TOTERR	MTE03790
0436	41D0 0504	380	BAL	R13,TSTBRK	BACK TO CMDIN IF BREAK	MTE03800
043A	0700	381	XHR	R0,R0	MTE03810	
043C	4810 0A46	382	LH	R1,CONTIN+6	MTE03820	
0440	4230 036C	383	BNZ	KEEP3	TEST IF CONTINUE OPTION	MTE03830
0444	4810 0104	384	ABORT1	LH R1,PSW2	REPEAT ALL TESTS IF YES	MTE03840
0448	9501	385	EPSR	R0,R1	MTE03850	
044A	C840 08E4	386	LHI	R4,EOTMSG	MTE03860	
044E	4100 0572	387	BAL	R13,MESSAGE	MTE03870	
0452	4810 0A50	388	LH	R1,NOMSG+5	MTE03880	
0456	4230 0494	389	BNZ	KEEP92	MTE03890	
045A	4300 0236	390	S	OPTIN	MTE03900	
045E	C650 0001	391	KEEP9	OHI R5,WASDU	MTE03910	
0462	2471	392	LIS	R7,1	MTE03920	
0464	6170 09E8	393	AHM	R7,TOTAL	MTE03930	
0468	2401	394	KEEP91	LIS R0,1	MTE03940	
046A	DE00 09EC	395	OC	R0,INCRMN1	MTE03950	
046E	DA00 09E9	396	WD	R0,TOTAL+1	MTE03960	
0472	DA00 09E8	397	WD	R0,TOTAL	MTE03970	
0476	DA00 09E8	398	WD	R0,TOTERR+1	MTE03980	
047A	DA00 09EA	399	WD	R0,TOTERR	MTE03990	
047E	DE00 09ED	400	OC	R0,NORMAL	MTE04000	
0482	4810 09E8	401	LH	R1,TOTAL	MTE04010	
0486	C510 FFFF	402	CLHI	R1,X'FFFF'	MTE04020	
048A	4280 0370	403	BL	KEEP4	MTE04030	
048E	C810 8000	404	HALT9	LHI R1,X'8000'	MTE04040	
0492	9501	405	EPSR	R0,R1	MTE04050	
0494	41C0 0552	406	KEEP92	BAL R12,TSTDU	MTE04060	
0498	2035	407	BNZS	HALT9	MTE04070	
049A	C450 FFFE	408	KEEP10	NHI R5,-1-WASDU	MTE04080	
049E	C650 0400	409	OHI	R5,ISITERR	MTE04090	
04A2	41D0 06A4	410	BAL	R13,CRLF	MTE04100	
04A6	4870 09E8	411	LH	R7,TOTAL	MTE04110	
04AA	41D0 07EC	412	BAL	R13,PRINTR7	MTE04120	
04AE	C840 098C	413	LHI	R4,TOTALMSG	MTE04130	
04B2	4100 0572	414	BAL	R13,MESSAGE	MTE04140	
04B6	4870 09EA	415	LH	R7,TOTERR	MTE04150	
04BA	41D0 07EC	416	BAL	R13,PRINTR7	MTE04160	
04BE	C840 0996	417	LHI	R4,ERRORS	MTE04170	
04C2	41D0 0572	*18	BAL	R13,MESSAGE	MTE04180	

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04C6 4300 0236

419 \*  
420

B OPTIN

\* XXXX TOTAL, YYYY ERRORS

MTE04190  
MTE04200

## SUBROUTINES

04CA 9566	422 PARERR	EPSR R6,R6	CAPTURE CURRENT PSW	MTE04220
04CC C350 1000	423 THI R5,PARITY		IGNORE FIRST PARITY ERROR	MTE04230
04D0 2135	424 BNZS PARERR1		REACT TO ALL OTHERS	MTE04240
04D2 C550 1000	425 OHI R5,PARITY		SET FIRST PARITY ERROR FLAG	MTE04250
04D6 C200 0038	426 LPSW X#38'		RETURN	MTE04260
04DA C650 0400	427 PARERR1	OHI R5,ISITERR	FORCE PRINTING	MTE04270
04DE 41D0 06A4	428 BAL R13,CRLF			MTE04280
04E2 C840 08F8	429 LHI R4,MALFMSG			MTE04290
04E6 41D0 0572	430 BAL R13,MESSAGE		PRINT "MACHINE MALFUNCTION"	MTE04300
04EA 41C0 0810	431 BAL R12,PRINTR6		PRINT CURRENT CONDITION CODE	MTE04310
04EE C800 0020	432 LHI R0,X#20'			MTE04320
04F2 41C0 0628	433 BAL R12,OUTCHR			MTE04330
04F6 4870 0038	434 LH R7,X#38'			MTE04340
04FA 41D0 07EC	435 BAL R13,PRINTR7		OLD PSW	MTE04350
04FE C800 0020	436 LHI R0,X#20'			MTE04360
0502 41C0 0628	437 BAL R12,OUTCHR			MTE04370
0506 4970 003A	438 LH R7,X#3A'			MTE04380
050A 41D0 07EC	439 BAL R13,PRINTR7		OLD LOC	MTE04390
050E C800 0020	440 LHI R0,X#20'			MTE04400
0512 41C0 0628	441 BAL R12,OUTCHR			MTE04410
0516 086E	442 LHR R6,R14			MTE04420
0518 41C0 0810	443 BAL R12,PRINTR6		OUTPUT PHYSICAL ADDRESS	MTE04430
051C 087F	444 LHR R7,R15			MTE04440
051E 41D0 07EC	445 BAL R13,PRINTR7			MTE04450
0522 4300 048E	446 B HALT9			MTE04460
0526 C650 0400	448 ILLEG1	OHI R5,ISITERR	FORCE PRINTING	MTE04480
052A 41D0 06A4	449 BAL R13,CRLF			MTE04490
052E C840 0910	450 LHI R4,ILLMSG			MTE04500
0532 41D0 0572	451 BAL R13,MESSAGE		PRINT "ILLEGAL INSTRUCTION"	MTE04510
0536 4870 0030	452 LH R7,X#30'			MTE04520
053A 41D0 07EC	453 BAL R13,PRINTR7		OLD PSW	MTE04530
053E C800 0020	454 LHI R0,X#20'			MTE04540
0542 41C0 0628	455 BAL R12,OUTCHR			MTE04550
0546 4870 0032	456 LH R7,X#32'			MTE04560
054A 41D0 07EC	457 BAL R13,PRINTR7		OLD LOC	MTE04570
054E 4300 048E	458 B HALT9			MTE04580

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SUBROUTINES

460 \* SUBROUTINE TSTDU MTE04600  
461 \* TEST FOR DU STATUS ON CONSOLE DEVICE MTE04610  
462 \* CALLING SEQUENCE: BAL R12,TSTDU MTE04620  
463 \* REGISTERS USED: R12,R2,R3 MTE04630  
464 \* SUBROUTINES USED: NONE MTE04640  
465 \* MTE04650  
466 \* MTE04660  
467 \* MTE04670

0552 C350 0100	469 TSTDU THI R5,PASFLG	PASLA?	
0556 2338	470 BZS TESTDU1	SKIP IF NO	MTE04690
0558 9D23	471 SSR R2,R3		MTE04700
055A C430 00FC	472 NHI R3,X*FC*		MTE04710
055E 273C	473 SIS R3+X*DC*	BUSY & EXAMINE?	MTE04720
0560 2337	474 BZS SETDU	YES	MTE04730
0562 0733	475 XHR R3,R3	CLEAR CC	MTE04740
0564 030C	476 BR R12	RETURN	MTE04750
0566 9D23	477 TESTDU1 SSR R2,R3		MTE04760
0568 C430 0001	478 NHI R3,1		MTE04770
056C 030C	479 BR R12		MTE04780
056E 2431	480 SETDU LIS R3,1		MTE04790
0570 030C	481 BR R12	NON ZERO CC	MTE04800
			MTE04810

## SUBROUTINES

483 *	S U B R O U T I N E	M E S S A G E	MTE04830
484 *			MTE04840
485 *	SUBROUTINE OUTPUTS MESSAGE TO TTY		MTE04850
486 *	(R4) IS MESSAGE START ADDRESS		MTE04860
487 *	MESSAGE OUTPUT TERMINATES WHEN A X'FF' CHARACTER IS OUTPUT		MTE04870
488 *			MTE04880
489 *	CALLING SEQUENCE: LHI R4,MESSAGE START ADDRESS		MTE04890
490 *	BAL R13,MESSAGE		MTE04900
491 *			MTE04910
492 *	REGISTERS USED: R13,R2,R12,R3,R0,R4		MTE04920
493 *	SUBROUTINES USED: TSTDU,OUTCHR		MTE04930

0572 4820 09F6	495	MESSAGE	LH R2,CONADR		MTE04950
0576 C350 0100	496		THI R5,PASFLG	IS IT A PASLA?	MTE04960
057A 2333	497		BZS P4		MTE04970
057C DE20 09FA	498		OC R2,CON2ND	PASLA SET-UP COMMAND	MTE04980
0580 41C0 0552	499	P4	BAL R12,TSTDU	TEST FOR DU STATUS	MTE04990
0584 2334	500		BZS P1	SKIP IF NOT DU	MTE05000
0586 C650 0001	501		OHI R5,WASDU	SET DU FLAG	MTE05010
058A 0300	502		BR R13	RETURN	MTE05020
058C C350 0001	503	P1	THI R5,WASDU	NOT DU NOW, WAS IT?	MTE05030
0590 4330 05B4	504		BZ P3	SKIP IF IT WASN'T	MTE05040
0594 C830 FFFF	505		LHI R3,X'FFFF'		MTE05050
0598 2731	506		SIS R3,1	DELAY	MTE05060
059A 2031	507		BTBS 3,1		MTE05070
059C C450 FFFE	508		NHI R5,-1-WASDU	CLEAR FLAG	MTE05080
05A0 C650 0002	509		OHI R5,WASDU1	SET WAS DU ONCE FLAG	MTE05090
05A4 2501	510		LCS R0,1	CHARACTER = 'FF'	MTE05100
05A6 2444	511		LIS R4,4	COUNT OF FOUR	MTE05110
0548 41C0 0628	512	P2	BAL R12,OUTCHR	OUTPUT 4 DELETES	MTE05120
05AC 2741	513		SIS R4,1		MTE05130
05AE 2023	514		BPS P2		MTE05140
05B0 4300 049A	515		B KEEP10	PRINT TOTAL,TOTERR	MTE05150
05B4 4830 0A50	516	P3	LH R3,NOMSG+6	TEST NO MESSAGE OPTION	MTE05160
05B8 2334	517		BZS MESAGEL	PRINT ALL MESSAGES	MTE05170
058A C350 0400	518		THI R5,ISITERR	TEST IF ERROR MESSAGE	MTE05180
05BE 233B	519		BZS TSTBRK	EXIT THROUGH TSTBRK	MTE05190
05C0 D304 0000	520	MESAGEL	LB R0,0(R4)	PICK UP MESSAGE CHARACTER	MTE05200
05C4 41C0 0628	521		BAL R12,OUTCHR	OUTPUT IT	MTE05210
05C8 2641	522		AIS R4,1	INCREMENT INDEX	MTE05220
05CA C400 007F	523		NHI R0,X'7F'		MTE05230
05CE C500 007F	524		CLHI R0,X'7F'	DONE WHEN OUTPUT DELETE CHARACTER	MTE05240
05D2 2039	525		BNES MESAGEL		MTE05250
	526	*		EXIT THROUGH TSTBRK	MTE05260

## SUBROUTINES

	528 * S U B R O U T I N E T S T B R K		
	529 * CALLING SEQUENCE: BAL R13,TSTBRK		MTE05280
	530 * REGISTERS USED: R13,R2,R3		MTE05290
	531 * SUBROUTINES USED: NONE		MTE05300
			MTE05310
			MTE05320
			MTE05330
05D4 4820 39F5	535 TSTBRK LH R2,CONADR	SELECT READ MODE	MTE05350
05D8 DE20 39F8	536 OC R2,CONRD		MTE05360
05DC 9023	537 SSR R2,R3		MTE05370
05DE C330 0020	538 THI R3,X*20*	LINE BREAK STATUS?	MTE05380
05E2 033D	539 BZR R13	EXIT IF NO	MTE05390
05E4 C350 0004	540 THI R5,MICROFLG	MICRO I/O BUS?	MTE05400
05E8 233E	541 BZS TSTBRK2	SKIP IF NO	MTE05410
05EA C330 0003	542 TSTBRK0 THI R3,B	BUSY ALSO SET?	MTE05420
05EE 2134	543 BNZS TSTBRK1	SKIP IF YES	MTE05430
05F0 9820	544 RDR R2,R0	DUMMY READ	MTE05440
05F2 9023	545 SSR R2,R3		MTE05450
05F4 2282	546 BFBS 8,2	WAIT FOR BUSY TO SET	MTE05460
05F6 9023	547 TSTBRK1 SSR R2,R3		MTE05470
05F8 C330 0020	548 THI R3,X*20*		MTE05480
05FC 2039	549 BNZS TSTBRK0	LOOP UNTIL BREAK RESETS	MTE05490
05FE 9820	550 RDR R2,R0		MTE05500
0600 4300 0624	551 B TSTBRK4	TAKE BREAK EXIT	MTE05510
0604 C350 0100	552 TSTBRK2 THI R5,PASFLG	PASLA?	MTE05520
0608 233A	553 BZS TSTBRK3	SKIP IF NO	MTE05530
060A C330 0008	554 THI R3,X*08*	BUSY SET?	MTE05540
060E 023D	555 BNZR R13	EXIT IF YES, BREAK ACKNOWLEDGED	MTE05550
0610 9820	556 RDR R2,R0	READ THE CHARACTER	MTE05560
0612 9023	557 SSR R2,R3	WAIT TIL BUSY SETS	MTE05570
0614 2281	558 BFBS 8,1		MTE05580
0616 0800	559 LHR R0,R0	TEST CHARACTER	MTE05590
0618 023D	560 BNZR R13	EXIT IF FRAMING ERROR	MTE05600
061A 2305	561 BS TSTBRK4	ELSE, REAL BREAK	MTE05610
061C 9023	562 TSTBRK3 SSR R2,R3	WAIT FOR BREAK RELEASE	MTE05620
061E C330 0020	563 THI R3,X*20*		MTE05630
0622 2033	564 BNZS TSTBRK3		MTE05640
0624 4300 0236	565 TSTBRK4 B OPTIN		MTE05650

## SUBROUTINES

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567 *      S U B R O U T I N E   O U T C H R
568 *
569 * SUBROUTINE OUTPUTS CHARACTER CONTAINED IN R0 TO THE TTY
570 *
571 * CALLING SEQUENCE:     BAL  R12,OUTCHR
572 * REGISTERS USED: R12,R3,R2
573 * SUBROUTINES USED: TSTDU

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MTE05670  
MTE05680  
MTE05690  
MTE05700  
MTE05710  
MTE05720  
MTE05730

0628 40C0 068C	575	OUTCHR	STH R12,OUT1+2	SAVE RETURN ADDRESS	MTE05750
062C C350 0080	576	THI	R5,CAROUSEL	CAROUSEL 300?	MTE05760
0630 4330 066E	577	BZ	OUTCHR2	SKIP IF NO TRANS PAUSE	MTE05770
0634 C450 FFBF	578	NHI	R5,-1-PAUSE	RESET FLAG	MTE05780
0638 41C0 0552	579	OTC.0	BAL R12,TSTDU	ON LINE?	MTE05790
063C 4230 0686	580	BNZ	OUT0	SKIP IF NO	MTE05800
0640 9223	581	SSR	R2,R3	CHARACTER TO READ?	MTE05810
0642 2386	582	BNCS	OTC.2	BRANCH IF YES	MTE05820
0644 C350 0040	583	OTC.1	THI R5,PAUSE	PAUSED NOW?	MTE05830
0648 2038	584	BNZS	OTC.0	YES, WAIT FOR DC2	MTE05840
064A 4300 066E	585	B	OUTCHR2	PRESS ON	MTE05850
064E 9823	586	OTC.2	RDR R2,R3	DC2,DC4	MTE05860
0650 C430 007F	587	NHI	R3,X#7F'	DC2?	MTE05870
0654 CB30 0012	588	SHI	R3,X#12"	SKIP IF NO	MTE05880
0658 2134	589	BNZS	OTC.3	YES, RE-SET FLAG	MTE05890
065A C450 FFBF	590	NHI	R5,-1-PAUSE	DC4?	MTE05900
065E 2308	591	BS	OUTCHR2	NO, KEEP LOOKING	MTE05910
0660 2732	592	OTC.3	SIS R3,2	SET FLAG	MTE05920
0662 4230 0638	593	BNZ	OTC.0		MTE05930
0666 C650 0040	594	OHI	R5,PAUSE		MTE05940
066A 4300 0638	595	B	OTC.0		MTE05950
	596 *				MTE05960
066E 41C0 0552	597	OUTCHR2	BAL R12,TSTDU	LEAVE IF DU	MTE05970
0672 213A	598	BNZS	OUT0	PASLA?	MTE05980
0674 C350 0100	599	SETUP	THI R5,PASFLG	SKIP IF NO	MTE05990
0678 2333	600	BZS	SETUP1	SELECT XMIT SIDE	MTE06000
067A C620 0001	601	OHI	R2,1	SELECT WRITE MODE	MTE06010
067E DE20 09F9	602	SETUP1	OC R2,CONWR		MTE06020
0682 9D23	603	OTC.4	SSR R2,R3	SKIP IF NOT DU	MTE06030
0684 2315	604	BNMS	CONT02	SET DU FLAG	MTE06040
0686 C650 0001	605	OUT0	OHI R5,WASDU	RETURN	MTE06050
068A 4300 068A	605	OUT1	B OUT1		MTE06060
	607 *				MTE06070
068E C530 000C	608	CONT02	CLHI R3,12		MTE06080
0692 2236	609	BES	OUT0		MTE06090
0694 C330 0008	610	THI	R3,8		MTE06100
0698 203B	611	BNZS	OTC.4	LOOP ON BUSY	MTE06110
069A 9A20	612	WDR	R2,R0		MTE06120
069C 9023	613	OTC.5	SSR R2,R3		MTE06130
069E 203C	614	BNZS	OUT0	EXIT	MTE06140
06A0 2082	615	BCS	OTC.5		MTE06150
06A2 220C	616	BS	OUT1	EXIT	MTE06160

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SUBROUTINES

618	*	S U B R O U T I N E   C R L F	
619	*		MTE06180
620	*	* OUTPUT CARRIAGE RETURN, LINE FEED SEQUENCE TO TTY	MTE06190
621	*		MTE06200
622	*	* CALLING SEQUENCE:      BAL    R13,CRLF	MTE06210
623	*		MTE06220
624	*	* REGISTERS USED: R13,R12,R0	MTE06230
625	*	* SUBROUTINES USED: DUTCHR	MTE06240
			MTE06250

06A4	2400	627	CRLF	LIS    R0,X'0D'	CARRIAGE RETURN	MTE06270
06A6	41C0 0628	628	BAL	R12,OUTCHR		MTE06280
06AA	240A	629	LIS	R0,X'0A'	LINE FEED	MTE06290
06AC	41C0 0628	630	BAL	R12,OUTCHR		MTE06300
06B0	0300	631	BR	R13		MTE06310

633	*	S U B R O U T I N E   G E T C H R		MTE06330
634	*			MTE06340
635	*	* READ CHARACTER FROM CONSOLE DEVICE		MTE06350
636	*			MTE06360
637	*	* CALLING SEQUENCE:      BAL    R13,GETCHR		MTE06370
638	*			MTE06380
639	*	* REGISTERS USED: R13,R2,R0,R3		MTE06390
640	*	* SUBROUTINES USED: NONE		MTE06400

05B2	4820 09F5	642	GETCHR	LH    R2,CONADR	PICK UP DEVICE NUMBER	MTE06420
05B6	DE20 09F8	643		OC    R2,CONRD		MTE06430
06BA	9B20	644	RDR	R2,R0	DUMMY READ	MTE06440
06BC	9D20	645	SSR	R2,R0		MTE06450
06BE	0210	646	BTCR	1,R13	RETURN IF DU	MTE06460
06C0	2082	647	BTBS	8,2	LOOP ON BUSY	MTE06470
06C2	9B20	648	RDR	R2,R0		MTE06480
06C4	C350 0004	649	THI	R5,MICROFLG	SEE IF MICRO I/O BUS	MTE06490
06C8	2333	650	BZS	SENSET	SKIP IF NOT MICRO I/O BUS	MTE06500
06CA	9A20	651	WDR	R2,R0		MTE06510
06CC	2308	652	BS	SENSEX		MTE06520
		653	*			MTE06530
06CE	C350 0080	654	SENSET	THI    R5,CAROUSEL		MTE06540
06D2	2335	655	BZS	SENSEX		MTE06550
06D4	2621	656	AIS	R2,1	ODD ADDRESS	MTE06560
06D6	9D23	657	SENSEM	SSR    R2,R3		MTE06570
06D8	2081	658	BCS	SENSEM		MTE06580
06DA	9A20	659	WDR	R2,R0	LOOP ON BUSY	MTE06590
		660	*			MTE06600
06DC	C400 007F	661	SENSEX	NHI    R0,X'7F'		MTE06610
06E0	0300	662	BR	R13		MTE06620

## SUBROUTINES

664	*	S U B R O U T I N E	O P T V A L	MTE06640
665	*			MTE06650
666	*	C A L L I N G S E Q U E N C E :	B A L R13,O P T V A L	MTE06660
667	*			MTE06670
668	*	R E G I S T E R S U S E D :	R13,R14,R15,R0	MTE06680
669	*	S U B R O U T I N E S U S E D :	G E T C H R	MTE06690

05E2	07EE	671	O P T V A L	X H R	R14,R14	C L E A R A C C U M U L A T O R	MTE06710
06E4	07FF	672		X H R	R15,R15		MTE06720
06E6	40D0 072A	673		S T H	R13,O P T V A L X + 2		MTE06730
06EA	41D0 06B2	674		B A L	R13,G E T C H R	G E T A C H A R A C T E R I N R0	MTE06740
06EE	24DF	675	O P T V A L 0	L I S	R13,15	I N D E X	MTE06750
06F0	D40D 081C	676	O P T V A L 1	C L B	R0,A S C I I (R13)	C O M P A R E C H A R A C T E R T O T A B L E E N T R I E S	MTE06760
06F4	2335	677		B E S	O P T V A L 1 A	F O U N D I T , R13=H E X V A L U E	MTE06770
06F6	27D1	678		S I S	R13,1	B A C K U P T H R U T A B L E	MTE06780
06F8	2284	679		B N L S	O P T V A L 1	L O O P	MTE06790
06FA	4300 0380	680		B	Q M A R K	E R R O R I F N O T A H E X C H A R A C T E R	MTE06830
06FE	0800	681	O P T V A L 1 A	L H R	R0,R13	V A L U E T O R0	MTE06810
0700	C400 000F	682	O P T V A L 2	N H I	R0,X*F*		MTE06820
0704	EDE0 0004	683		S L L	R14,4	S H I F T A C C U M U L A T O R	MTE06830
0708	06F0	684		O H R	R15,R0	O R I N N E W D I G I T	MTE06840
070A	41D0 06B2	685	O P T V A L 3	B A L	R13,G E T C H R	G E T A N O T H E R C H A R A C T E R	MTE06850
070E	C500 005F	686		C L H I	R0,X*5F*	L E F T A R R O W ?	MTE06860
0712	2134	687		B N E S	O P T V A L 4		MTE06870
0714	ECE0 0004	688		S R L	R14,4	D E L E T E L A S T C H A R A C T E R	MTE06880
0718	2207	689		B S	O P T V A L 3		MTE06890
071A	C500 0009	690	O P T V A L 4	C L H I	R0,X*0D*	C A R R I A G E R E T U R N ?	MTE06900
071E	2335	691		B E S	O P T V A L X	Y E S , E X I T	MTE06910
0720	C500 002C	692		C L H I	R0,X*2C*	C O M M A ?	MTE06920
0724	4230 06EE	693		B N E	O P T V A L 0	L O O P	MTE06930
0728	4300 0728	694	O P T V A L X	B	O P T V A L X	R E T U R N	MTE06940

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SUBROUTINES

696	*	S U B R O U T I N E   A D R S E T	
697	*		MTE06960
698	*	REGISTER PAIR R14,R15 CONTAINS AN 18 BIT MAIN MEMORY ADDRESS.	MTE06970
699	*	SUBROUTINE COPIES R15 INTO R1 THEN ADJUSTS R1 AND THE CURRENT	MTE06980
700	*	PROGRAM STATUS WORD SO THAT THE ARGUMENT ADDRESS CAN BE ACCESSED	MTE06990
701	*		MTE07000
702	*	CALLING SEQUENCE:      BAL    R13,ADRSET	MTE07010
703	*		MTE07020
704	*	REGISTERS USED: R13,R12,R0,R1	MTE07030
705	*	SUBROUTINES USED: NONE	MTE07040
			MTE07050

072C	95CC	707	ADRSET	EPSR    R12,R12	CAPTURE CURRENT PSW	MTE07070
072E	C4C0 FF0F	708	NHI	R12,X#FF0F*	RESET BANK SELECT BITS	MTE07080
0732	081F	709	LHR	R1,R15	LS 1e ADRS BITS TO R1	MTE07090
0734	C4E0 0003	710	NHI	R14,3	CLEAN UP R14	MTE07100
0738	233B	711	BZS	ADRSETX		MTE07110
073A	D39E 0752	712	LB	R0,XADRTAB(R14)	TRANSLATE TO PSW BIT PATTERN	MTE07120
073E	CA10 8000	713	AHI	R1,X#8000*	ADRS BIT 16 TO CARRY FLAG	MTE07130
0742	4E00 00E4	714	AC4	R0,ZERO	ADJUST PSW BIT PATTERN	MTE07140
0746	C610 8000	715	OHI	R1,X#8000*	FORCE BIT 0 OF HW ADRS SET	MTE07150
074A	9104	716	SLLS	R0,4	POSITION FIELD	MTE07160
074C	06C0	717	OHR	R12,R0	OR IN BITS	MTE07170
074E	950C	718	ADRSETX	EPSR    R0,R12	LOAD NEW PSW	MTE07180
0750	0300	719	BR	R13	RETURN TO CALL	MTE07190
0752	0001 0305	720	*			MTE07200
		721	XADRTAB	DB    0,1,3,5		MTE07210

## SUBROUTINES

723	*	S U B R O U T I N E   D I S P L A Y	MTE07230
724	*		MTE07240
725	*	SUBROUTINE DISPLAYS CURRENT MEMORY ADDRESS	MTE07250
726	*		MTE07260
727	*	CALLING SEQUENCE:      BAL    R13,DISPLAY	MTE07270
728	*		MTE07280
729	*	REGISTERS USED: R13,R0	MTE07290
730	*	SUBROUTINES USED: NONE	MTE07300

0756	2401	732	DISPLAY	LIS	R0,1	MTE07320
0758	DE00 09EC	733		OC	R0,INCRMNTL	MTE07330
075C	94FF	734		EXBR	R15,R15	MTE07340
075E	980F	735		WHR	R0,R15	MTE07350
0760	94FF	736		EXBR	R15,R15	MTE07360
0762	9A0E	737		WDR	R0,R14	MTE07370
0764	0800 09E4	738		WH	R0,ZERO	MTE07380
0768	030D	739		BR	R13	MTE07390

741	*	S U B R O U T I N E   E R R M S G	MTE07410
742	*		MTE07420
743	*	REGISTER PAIR R14,R15 CONTAINS THE FAILING MEMORY ADDRESS	MTE07430
744	*	REGISTER P9 CONTAINS THE DATA EXPECTED	MTE07440
745	*	REGISTER R8 CONTAINS THE DATA OBSERVED	MTE07450
746	*		MTE07460
747	*	CALLING SEQUENCE: BAL    R13,ERRMSG	MTE07470
748	*		MTE07480
749	*	REGISTERS USED: R13,R12,R7,R4,R3,R2,R0	MTE07490
750	*	SUBROUTINES USED: TSTDU,PRINTR7,MESSAGE,CRLF,OUTCHR	MTE07500

076A	4820 09E6	752	ERRMSG	LH	R2,CONADR	MTE07520
076E	C550 0408	753		OHI	R5,ISITERR+ERRFLG	*TE07530
0772	41C0 0552	754		BAL	R12,TSTDU	MTE07540
0776	233B	755		BZS	ERRMSG1	MTE07550
0778	4800 09EA	756		LH	R0,TOTERR	MTE07560
077C	2601	757		AIS	R0,1	MTE07570
077E	4000 09EA	758		STH	R0,TOTERR	MTE07580
0782	C500 FFFF	759		CLHI	R0,X'FFFF'	*TE07590
0786	023D	760		BNER	R13	MTE07600
0788	4300 048E	761		B	HALT9	MTE07610
		762	*			MTE07620
078C	4000 07EA	763	ERRMSG1	STH	R13,RETURN	MTE07630
0790	41D0 06A4	764		BAL	R13,CRLF	MTE07640
0794	4800 09EA	765		LH	R0,TOTERR	MTE07650
0798	2135	766		BNZS	ERRMSG2	MTE07660
079A	C840 092C	767		LHI	R4,MEMORY	MTE07670
079E	41D0 0572	768		BAL	R13,MESSAGE	MTE07680
		769	*			MTE07690

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SUBROUTINES

		770 *		LOCATION EXPECTED OBSERVED	
07A2	2401	771 ERRMSG2	LIS R0,1		MTE07700
07A4	6100 09EA	772 AHM R0,TOTERR		INCREMENT ERROR TALLY	MTE07710
07A8	C800 0020	773 LHI R0,X"20"		SPACE	MTE07720
07AC	C350 0800	774 THI RS,EXTMEM		MORE THAN 64 KB ?	MTE07730
07B0	2333	775 BZS NONEXT		SKIP IF NO	MTE07740
07B2	030E 081C	776 LB R0,ASCII(R14)		MS DIGIT OF ADDRESS	MTE07750
07B6	41C0 0628	777 NONEXT	BAL R12,OUTCHR		MTE07760
07BA	C800 0020	778 LHI R0,X"20"		SPACE	MTE07770
07BE	41C0 0628	779 BAL R12,OUTCHR			MTE07780
07C2	087F	780 LHR R7,R15			MTE07790
07C4	41D0 07EC	781 BAL R13,PRINTR7		PRINT REST OF ADDRESS	MTE07800
07C8	C840 0966	782 LHI R4,SPACE3			MTE07810
07CC	41D0 0572	783 BAL R13,MESSAGE		THREE SPACES	MTE07820
07D0	0879	784 LHR R7,R9			MTE07830
07D2	41D0 07EC	785 BAL R13,PRINTR7		PRINT DATA EXPECTED	MTE07840
07D6	C840 0964	786 LHI R4,SPACES			MTE07850
07DA	41D0 0572	787 BAL R13,MESSAGE			MTE07860
07DE	0878	788 LHR R7,R8			MTE07870
07E0	41D0 07EC	789 BAL R13,PRINTR7		PRINT DATA OBSERVED	MTE07880
07E4	C450 FBFF	790 NHI RS,-1-ISITERR			MTE07890
07E8	4300 07EA	791 B RETURN			MTE07900
	0000 07EA	792 RETURN	EQU *-2		MTE07910
					MTE07920

## SUBROUTINES

794	*	S U B R O U T I N E   P R I N T R 7	MTE07940
795	*		MTE07950
796	*	THE FOUR HEX DIGITS IN R7 ARE CONVERTED TO HEX	MTE07960
797	*	AND OUTPUT TO THE CONSOLE DEVICE	MTE07970
798	*		MTE07980
799	*	CALLING SEQUENCE:        BAL    R13,PRINTR7	MTE07990
800	*		MTE08000
801	*	REGISTERS USED: R13,R6,R7,R12	MTE08010
802	*	SUBROUTINES USED: PRINTR6	MTE08020

07EC	0766	804	PRINTR7	XHR	R6,R6	USING R6,R7 AS 32 BIT ACCUMULATOR	MTE08040
07EE	ED60 0004	805	SLL	R6,4		R6 = R7 BITS 0:3	MTE08050
07F2	41C0 0810	806	BAL	R12,PRINTR6		PRINT IT	MTE08060
07F6	ED60 0004	807	SLL	R6,4		R7 BITS 4:7	MTE08070
07FA	41C0 0810	808	BAL	R12,PRINTR6		PRINT IT	MTE08080
07FE	ED60 0004	809	SLL	R6,4		R7 BITS 8:11	MTE08090
0802	41C0 0810	810	BAL	R12,PRINTR6		PRINT IT	MTE08100
0806	ED60 0004	811	SLL	R6,4		R7 BITS 12:1K	MTE08110
080A	41C0 0810	812	BAL	R12,PRINTR6		PRINT IT	MTE08120
080E	030D	813	BR	R13		RETURN	MTE08130

915	*	S U B R O U T I N E   P R I N T R 6	MTE08150				
816	*		MTE08160				
817	*	CONVERT THE LS 4 BITS OF R6 TO ASCII AND OUTPUT	MTE08170				
818	*		MTE08180				
819	*	CALLING SEQUENCE:        BAL    R12,PRINTR6	MTE08190				
820	*		MTE08200				
821	*	REGISTERS USED: R12,R6,R0	MTE08210				
822	*	SUBROUTINES USED: OUTCHR	MTE08220				
823	*		MTE08230				
824	*		MTE08240				
0810	C460 000F	825	PRINTR6	NHI	R6,X*F*		MTE08250
0814	D306 081C	826		LB	R0,ASCII(R6)		MTE08260
0818	4300 0628	827		B	OUTCHR	EXIT THROUGH OUTCHR	MTE08270
081C	3031 3233 3435 3637	828	*				MTE08280
0824	3839 4142 4344 4546	829	ASCII	DC	C'0123456789ABCDEF'		MTE08290

## SUBROUTINES

		931 * SUBROUTINE TESTNUM	MTE08310
		832 *	MTE08320
		833 * SUBROUTINE PRINTS TITLE OF NEXT SUBTEST TO PERFORM	MTE08330
		834 *	MTE08340
		835 * CALLING SEQUENCE: BAL R14,TESTNUM	MTE08350
		836 *	MTE08360
		837 * REGISTERS USED: R14,R1,R4,R13	MTE08370
		838 * SUBROUTINES USED: MESSAGE	MTE08380
		839 *	MTE08390
		840 *	MTE08400
082C	4810 09EE	841 TESTNUM LH R1,SUBST	PICK UP SUBTEST NUMBER
0830	D311 081C	842 LB R1,ASCII(R1)	CONVERT TO ASCII
0834	D210 0802	843 STB R1,TT	STORE IN MESSAGE
0838	C840 08C6	844 LHI R4,SBNUM	
083C	4100 0572	845 BAL R13,MESSAGE	PRINT "SUBTEST N"
0840	D30E	846 BR R14	RETURN
			MTE08410
			MTE08420
			MTE08430
			MTE08440
			MTE08450
			MTE08460
		348 * SUBROUTINE ADCHECK	MTE08480
		849 *	MTE08490
0842	088E	850 ADCHECK LHR R11,R14	
0844	08CF	851 LHR R12,R15	MTE08500
0846	CBC0 10C8	852 SHI R12,LAST	MTE08510
084A	4FB0 09E4	853 SCH R11,ZERO	MTE08520
084E	2127	854 BPS ADCHK01	MTE08530
0850	C840 0964	855 ADCHK.ER LHI R4,ADRSERR	MTE08540
0854	4100 0572	856 BAL R13,MESSAGE	MTE08550
0858	4300 0236	857 B OPTIN	MTE08560
085C	4880 09E0	858 ADCHK01 LH R11,MAXMEM	MTE08570
0960	48C0 09E2	859 LH R12,MAXMEM+2	MTE08580
0364	0BCF	860 SHR R12,R15	MTE08590
0866	0FBE	861 SCHR R11,R14	MTE08600
0868	038D	862 BMLR R13	MTE08610
086A	220D	863 BS ADCHK.ER	MTE08620
			MTE08630

## MESSAGES AND BUFFERS

086C 000A	865	TITLE2	DCX	000A,0000	MTE08650
086E 0000					
0870 332F 3136 2045 2045	866		DC	C'8/16 E EXTENDED MEMORY TEST PART 2 06-221R007'	MTE08660
0878 5854 454E 4445 4420					
0880 4D45 4D4F 5259 2054					
0888 4553 5420 5041 5254					
0890 2032 2020 3036 2032					
0898 3231 5230 3020					
089E 000A	867		DCX	000A,FFFF	MTE08670
08A0 FFFF					
08A2 5052 4F47 5241 4D20	868	PDMXMM	DC	C'PROGRAM DETECTED MAXIMUM MEMORY '	MTE08680
08AA 4445 5445 4354 4544					
08B2 204D 4158 494D 554D					
08BA 204D 454D 4F52 5920					
08C2 2020					
08C4 FFFF	869		DCX	FFFF	MTE08690
08C6 000D	870	SUBNUM	DC	X'000D',X'0400',C'SUBTEST '	MTE08700
08C8 0A00					
08CA 5355 4254 4553 5420					
08D2 0000	871	TT	DC	X'0000',X'2020',X'FFFF'	MTE08710
08D4 2020					
08D6 FFFF					
08D8 0000	872	NOER	DC	X'0000',C'NO ERROR',X'FFFF'	MTE08720
08DA 4E4F 2045 5252 4F52					
08E2 FFFF					
08E4 000A	873	EOTMSG	DC	X'000A',X'0000',C'END OF TEST',X'000A',X'FFFF'	MTE08730
08E6 0000					
08E8 454E 4420 4F46 2054					
08F0 4553 5420					
08F4 000A					
08F6 FFFF					
08F8 0000	874	HALFMSG	DC	0,C'MACHINE MALFUNCTION ',X'FFFF'	MTE08740
08FA 4D41 4348 494E 4520					
0902 4D41 4C46 554E 4354					
090A 494F 4E20					
090E FFFF					
0910 0000	875	ILLMSG	DC	0,C'ILLEGAL INSTRUCTION ',X'FFFF'	MTE08750
0912 494C 4C45 4741 4C20					
091A 494E 5354 5255 4354					
0922 494F 4E20					
0926 FFFF					
0928 0020 3FFF	876	QUEST	DB	0,C' ?',X'FF'	MTE08760
092C 4D45 4D4F 5259 2020	877	MEMORY	DC	C'MEMORY DATA DATA',X'000A'	MTE08770
0934 2044 4154 4120 2020					
093C 2020 4441 5441					
0942 000A					
0944 0000	878		DC	X'0000'	MTE08780
0946 4C4F 4341 5449 4F4E	879		DC	C'LOCATION EXPECTED OBSERVED',X'000A',X'FFFF'	MTE08790
094E 2045 5850 4543 5445					
0956 4420 4F42 5345 5256					
095E 4544					
0960 000A					
0962 FFFF					

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 MESSAGES AND BUFFERS

0964	2020	880	SPACES5	DC	X'2020'	
0966	2020	881	SPACE3	DC	X'2020',X'20FF'	MTE08800
0968	20FF					MTE08810
096A	00CA	882	ADRSERR	DC	X'000A',X'0000'	MTE08820
096C	0000					
096E	4144 4452 4553 5320	883		DC	C' ADDRESS ERROR, CHECK OPTIONS'	MTE08830
0976	4552 524F 522C 2043					
097E	4845 434B 204F 5054					
0986	494F 4E53					
098A	FFFF	884		DC	X'FFFF'	
098C	2954 4F54 414C 2C20	885	TOTALMSG	DC	C' TOTAL, ',X'FFFF'	MTE08840
0994	FFFF					MTE08850
0996	2045 5252 4F52 5320	886	ERRORS	DC	C' ERRORS',X'FFFF'	MTE08860
099E	FFFF					
09A0	8000	888	BIT0	DCX	8000,4000,2000,1000	MTE08880
09A2	4000					
09A4	2000					
09A6	1000					
09A8	0800	889		DCX	800,400,200,100	MTE08890
09AA	0400					
09AC	0200					
09AE	0100					
09B0	0080	890		DCX	80,40,20,10	MTE08900
09B2	0040					
09B4	0020					
09B6	0010					
09B8	0008	891		DCX	8,4,2,1	MTE08910
09BA	0004					
09BC	0002					
09BE	0001					
09C0	FFFF	893	DATA2	DCX	FFFF,FFFD,FFFF,FFF7	MTE08930
09C2	FFFD					
09C4	FFF8					
09C6	FFF7					
09C8	FFEF	894		DCX	FFEF,FFDF,FFBF,FF7F	MTE08940
09CA	FFDF					
09CC	FFBF					
09CE	FF7F					
09D0	FEFF	895		DCX	FEFF,FDFE,F8FF,F7FF	MTE08950
09D2	FDFE					
09D4	F8FF					
09D6	F7FF					
09D8	EFFF	896		DCX	EFFF,DFFF,BFFF,7FFF	MTE08960
09DA	DFFF					
09DC	BFFF					
09DE	7FFF					
 	 	897	*			MTE08970

## MESSAGES AND BUFFERS

09E0 0000	898 *			MTE08980
09E2 0000	899 MAXMEM	DCX	0000,0000	MTE08990
09E4 0000	900 ZERO	DCX	0	MTE09000
09E6 0000	901 COUNT	DCX	0	MTE09010
09E8 0000	902 TOTAL	DCX	0	MTE09020
09EA 0000	903 TOTERR	DCX	0	MTE09030
09EC 40	904 INCRMNTL	DB	X*40*	MTE09040
09ED 80	905 NORMAL	DB	X*80*	MTE09050
09EE 0000	906 SUBTST	DCX	0	MTE09060
	907 *			MTE09070
09F0	908 OPTBUF	DS	6	MTE09080
09F6 0000	909 CONADR	DCX	0000	MTE09090
09F8 00	910 CONRD	DB	0	CONSOLE DEVICE ADRS MTE09100
09F9 00	911 CONWRT	DB	0	MTE09110
09FA 00	912 CON2ND	DB	0	MTE09120
09FB 00	913 CONENRD	DB	0	MTE09130
09FC 03	914 CONRQ2S	DB	0	MTE09140
09FD 03	915 MICRORST	DB	03	MTE09150
09FE 8222	916 MICRORD	DCX	8222	MTE09160
0A00 A9AB	917 CARRD	DCX	A9AB	MTE09170
0A02 F069	918 CAR2ND	DCX	F069	MTE09180
0A04 23	919 CARRQ2S	DB	X*23*	MTE09190
0A05 38	920 CRTRQ2S	DB	X*38*	MTE09200
0A06 B9AB	921 CRTRD	DCX	B9AB	MTE09210
0A08 F879	922 CRT2ND	DCX	F879	MTE09220
0A0A A4D8	923 CLIFRD	DCX	A4D8	MTE09230
0A0C 0064	924 CLIF2ND	DCX	0064	MTE09240
0000 0A0E	925 OPT	EQU	*	MTE09250
0A0E 5255 4E20 2020	926 RUN	DC	C*RUN *,X*0000*,X*0000*	MTE09260
0A14 0000				
0A16 0000				
0A18 4CAF 5720 2020	927 LOW	DC	C*LOW *,X*0000*,X*0000*	MTE09270
0A1E 0000				
0A20 0000				
0A22 4849 4748 2020	928 HIGH	DC	C*HIGH *,X*0000*,X*0000*	MTE09280
0A28 0000				
0A2A 0000				
0A2C 4C4F 4F50 2020	929 LOOP	DC	C*LOOP *,X*0000*,X*0000*	MTE09290
0A32 0000				
0A34 0000				
0A36 5445 5354 2020	930 TEST	DC	C*TEST *,X*0000*,X*F880*	MTE09300
0A3C 0000				
0A3E FB80				
0A40 434F 4E54 494E	931 CONTIN	DC	C*CONTIN*,X*0000*,X*0000*	MTE09310
0A46 0000				
0A48 0000				
0A4A 4E4F 4D53 4720	932 NOMSG	DC	C*NOMSG *,X*0000*,X*0000*	MTE09320
0A50 0000				
0A52 0000				
0A54 4441 5441 2020	933 DATA	DC	C*DATA *,X*0000*,X*A5A5*	MTE09330
0A56 0000				
0A5C A5A5				

MODEL 8/16 E EXTENDED MEMORY TEST 06-221R00M96 PART 2

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MESSAGES AND BUFFERS

0ASE FFFF 0000 0A3E	934 DC X'FFFF' 935 DEFTESTS EQU TEST+8	MTE09340 MTE09350
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## S U B T E S T 0

937 \* SUBTEST 0 IS A MINIMAL ADDRESS DECODE TEST  
 938 \* TESTING THE 8KB SEGMENT ABOVE THE PROGRAM  
 939 \* FOR MULTIPLE ADDRESSING ERRORS  
 940 \*  
 941 \*  
 942 TEST0 EQU \*  
 943 XHR R14,R14  
 944 LHI R15, LAST+2  
 945 OHI R15,X'FF'  
 946 AIS R15,1  
 947 STM R14, STRTAADRS  
 948 XHR R8,R8  
 949 LIS R10,8  
 950 BAL R13,ADRSET  
 951 TEST0.01 BAL R13,DISPLAY  
 952 LHR R11,R1  
 953 DHR R11,R10  
 954 STH R8,0(R11)  
 955 STH R8,2(R11)  
 956 STH R8,4(R11)  
 957 STH R8,6(R11)  
 958 AHR R10,R10  
 959 CLHI R10,X'1000'  
 960 BLS TEST0.01  
 961 \*  
 962 \*  
 963 LIS R10,8  
 964 TEST0.10 LM R14,STRTAADRS  
 965 DHR R15,R10  
 966 SAL R13,ADRSET  
 967 BAL R13,DISPLAY  
 968 LHI R8,X'F000'  
 969 STH R8,0(R1)  
 970 SRSL R8,4  
 971 STH R8,2(R1)  
 972 SRSL R8,4  
 973 STH R8,4(R1)  
 974 SRSL R8,4  
 975 STH R8,6(R1)  
 976 \*  
 977 XHR R9,R9  
 978 LIS R11,8  
 979 TEST0.20 CLHR R10,R11  
 980 BE TEST0.24  
 981 LM R14,STRTAADRS  
 982 DHR R15,R11  
 983 BAL R13,ADRSET  
 984 LH R8,0(R1)  
 985 BZS TEST0.21  
 986 BAL R13,ERRMSG  
 987 TEST0.21 AIS R15,2  
 988 LH R8,2(R1)  
 989 BZS TEST0.22

NEXT HIGHER 256 BYTE BOUNDARY

SAVE START ADDRESS

ADDRESS PATTERN

TEST AREA = 4 HALFWORDS EACH AT  
01008,01010,01020,  
01040,01080,01100,  
01200,01400, AND 01800

4 HALFWORDS CLEARED

R10 = WORKING OFF-SET  
PICK JP START ADDRESS  
ADD OFF-SET  
SET-JP ADDRESS IN PSW,R1  
RS = 'F000'  
RS = '0F00'  
RS = '00F0'  
RS = '000F'  
TEST AREA LOADED

R11 = TEST OFF-SET  
SKIP IF SAME AS WORKING OFF-SET

TEST FIRST WORD  
R14,R15 = AREA START ADRS  
TEST SECOND WORD

MTE09370  
MTE09380  
MTE09390  
MTE09400  
MTE09410  
MTE09420  
MTE09430  
MTE09440  
MTE09450  
MTE09460  
MTE09470  
MTE09480  
MTE09490  
MTE09500  
MTE09510  
MTE09520  
MTE09530  
MTE09540  
MTE09550  
MTE09560  
MTE09570  
MTE09580  
MTE09590  
MTE09600  
MTE09610  
MTE09620  
MTE09630  
MTE09640  
MTE09650  
MTE09660  
MTE09670  
MTE09680  
MTE09690  
MTE09700  
MTE09710  
MTE09720  
MTE09730  
MTE09740  
MTE09750  
MTE09760  
MTE09770  
MTE09780  
MTE09790  
MTE09800  
MTE09810  
MTE09820  
MTE09830  
MTE09840  
MTE09850  
MTE09860  
MTE09870  
MTE09880  
MTE09890

\* S U B T E S T 0

0AE8 41D0 076A	990	BAL	R13,ERRMSG		
0AEC 26F2	991	TEST0.22	AIS	R15,2	MTE09900
0AEE 4881 0004	992	LH	R8,4(R1)		MTE09910
0AF2 2733	993	BZS	TEST0.23		MTE09920
0AF4 41D0 076A	994	BAL	R13,ERRMSG		MTE09930
0AF8 26F2	995	TEST0.23	AIS	R15,2	MTE09940
0AFA 4881 0005	996	LH	R8,6(R1)		MTE09950
0AFE 2333	997	BZS	TEST0.24		MTE09960
0B00 41D0 076A	998	BAL	R13,ERRMSG		MTE09970
0B04 0ABB	999	TEST0.24	AHR	R11,R11	MTE09980
0B06 C580 1000	1000	CLHI	R11,X'1000'		MTE09990
0B0A 4280 0AC6	1001	BL	TEST0.26		MTE10000
	1002	*		LOOP THRU OTHER SEGMENTS	MTE10010
	1003	*			MTE10020
0B0E D1E0 108C	1004	LW	R14,STRTADRS		MTE10030
0B12 06FA	1005	OHR	R15,R10		MTE10040
0B14 41D0 072C	1006	BAL	R13,ADRSET		MTE10050
0B18 4091 0030	1007	STH	R9,0(R1)		MTE10060
0B1C 4091 0002	1008	STH	R9,2(R1)		MTE10070
0B20 4091 0004	1009	STH	R9,4(R1)		MTE10080
0B24 4091 0006	1010	STH	R9,6(R1)		MTE10090
0B28 0AAA	1011	AHR	R10,R10		MTE10100
0B2A C5A0 1000	1012	CLHI	R10,X'1000'		MTE10110
0B2E 4280 0A9A	1013	BL	TEST0.10	DONE?	MTE10120
0B32 4300 03D6	1014	B	TEST.END		MTE10130
					MTE10140

## S U B T E S T 1

		1016	* SUBTEST 1 CHECKS MEMORY FROM LAST+2 THROUGH X*1FFE*	MTE10160	
		1017	* FOR MEMORY DATA INTEGRITY	MTE10170	
		1018	*	MTE10180	
		1019	*	MTE10190	
	0000 0835	1020	TEST1 EQU *	MTE10200	
	0B36 07EE	1021	XHR R14,R14	MTE10210	
	0B38 C8F0 10CA	1022	LHI R15, LAST+2	MTE10220	
	0B3C 41D0 072C	1023	BAL R13,ADRSET	MTE10230	
	0B40 41D0 0756	1024	BAL R13,DISPLAY	MTE10240	
	0B44 C890 8000	1025	TEST1.01 LHI R9,X*8000*	MTE10250	
	0B48 4091 0000	1026	TEST1.02 STH R9,0(R1)	MTE10260	
	0B4C 2512	1027	AIS R1,2	MTE10270	
	0B4E C510 2000	1028	CLHI R1,X*2000*	MTE10280	
	0B52 2334	1029	BES TEST1.10	MTE10290	
	0B54 9091	1030	SRLS R9,1	MTE10300	
	0B56 2239	1031	BZS TEST1.01	MTE10310	
	0B58 2208	1032	BS TEST1.02	MTE10320	
		1033	*	MTE10330	
	0B5A C890 8000	1034	TEST1.10 LHI R9,X*8000*	MTE10340	
	0B5E 488F 0000	1035	TEST1.11 LH R8,0(R15)	MTE10350	
	0B62 41D0 0756	1036	BAL R13,DISPLAY	MTE10360	
	0B66 0598	1037	CLHR R9,R8	MTE10370	
	0B68 2333	1038	BES TEST1.12	MTE10380	
	0B6A 41D0 076A	1039	BAL R13,ERRMSG	R14,R15 = FAILURE ADDRESS *	MTE10390
	0B6E 25F2	1040	TEST1.12 AIS R15,2	MTE10400	
	0B70 C5F0 2000	1041	CLHI R15,X*2000*	MTE10410	
	0B74 2336	1042	BES TEST1.20	MTE10420	
	0B76 9091	1043	SRLS R9,1	MTE10430	
	0B78 4330 0B5A	1044	BZ TEST1.10	MTE10440	
	0B7C 4300 0B5E	1045	B TEST1.11	MTE10450	
		1046	*	MTE10460	
		1047	*	MTE10470	
	0B80 07EE	1048	TEST1.20 XHR R14,R14	MTE10480	
	0B82 C8F0 1FFE	1049	LHI R15,X*1FFE*	MTE10490	
	0B86 41D0 072C	1050	BAL R13,ADRSET	MTE10500	
	0B8A 07AA	1051	TEST1.21 XHR R10,R10	MTE10510	
	0B8C 489A 09C0	1052	TEST1.22 LH R9,DATA2(R10)	MTE10520	
	0B90 4091 0000	1053	STH R9,0(R1)	MTE10530	
	0B94 2712	1054	SIS R1,2	MTE10540	
	0B96 C510 10C8	1055	CLHI R1, LAST	MTE10550	
	0B9A 2336	1056	BES TEST1.30	MTE10560	
	0B9C 26A2	1057	AIS R10,2	MTE10570	
	0B9E C5A0 0020	1058	CLHI R10,32	MTE10580	
	0BA2 223C	1059	BES TEST1.21	MTE10590	
	0BA4 220C	1060	BS TEST1.22	MTE10600	
		1061	*	MTE10610	
	0BA6 07AA	1062	TEST1.20 XHR R10,R10	MTE10620	
	0B88 488F 0000	1063	TEST1.31 LH R8,0(R15)	MTE10630	
	0BAC 41D0 0756	1064	BAL R13,DISPLAY	MTE10640	
	0BB0 409A 09C0	1065	LH R9,DATA2(R10)	MTE10650	
	0B84 0589	1066	CLHR R8,R9	MTE10660	
	0B86 2533	1067	BES TEST1.32	MTE10670	
	0BB8 41D0 076A	1068	BAL R13,ERRMSG	R14,R15 = FAILING ADDRESS *	MTE10680

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\* S U B T E S T 1

089C	27F2	1069	TEST1.32	SIS	R15,2	DECREMENT TEST ADDRESS	MTE10690
088E	C5F0 10C8	1070		CLHI	R15, LAST		MTE10700
0BC2	4330 03D6	1071		BE	TEST-END	END OF SUBTEST 1	MTE10710
0BC6	26A2	1072		AIS	R10,2	NEXT PATTERN	MTE10720
0BC8	C5A0 0020	1073		CLHI	R10,32		MTE10730
0BCC	4330 0BA6	1074		BE	TEST1.30	RESET R10 TO REPEAT PATTERN	MTE10740
0BD0	4300 0BA8	1075		B	TEST1.31		MTE10750

## S U B T E S T 2

		1077 * SUBTEST 2 TESTS ALL OF MEMORY FROM LAST+2 TO MAXMEM	MTE10770
		1078 *	MTE10780
		1079 *	MTE10790
0BD4	07EE	1080 TEST2 EQU *	MTE10800
0BD6	C8F0 10CA	1081 XHR R14,R14	MTE10810
0BDA	41D0 072C	1082 LHI R15,LAST+2	MTE10820
0BDE	41D0 0756	1083 TEST2.01 BAL R13,ADRSET	MTE10830
0BE2	4011 0000	1084 BAL R13,DISPLAY	MTE10840
0BE6	45E0 09E0	1085 TEST2.02 STH R1,0(R1)	MTE10850
0BEA	2184	1086 CLH R14,MAXMEM	MTE10860
0BEC	45F0 09E2	1087 BLS TEST2.03	MTE10870
0BF0	2388	1088 CLH R15,MAXMEM+2	MTE10880
0BF2	26F2	1089 BNLS TEST2.10	MTE10890
0BF4	4EE0 09E4	1090 TEST2.03 AIS R15,2	MTE10900
0BF8	2612	1091 ACH R14,ZERO	MTE10910
0BFA	228C	1092 AIS R1,2	MTE10920
0BFC	4300 0BDA	1093 BNCS TEST2.02	MTE10930
		1094 B TEST2.01	MTE10940
		1095 *	MTE10950
0C00	07EE	1096 TEST2.10 XHR R14,R14	MTE10960
0C02	C8F0 10CA	1097 LHI R15,LAST+2	MTE10970
0C06	41D0 072C	1098 TEST2.11 BAL R13,ADRSET	MTE10980
0C0A	0891	1099 TEST2.12 LHR R9,R1	MTE10990
0CDC	41D0 0756	1100 BAL R13,DISPLAY	MTE11000
0C10	4881 0000	1101 LH R8,0(R1)	MTE11010
0C14	0589	1102 CLHR R8,R9	MTE11020
0C16	2333	1103 BES TEST2.13	MTE11030
0C18	41D0 076A	1104 BAL R13,ERRMSG	MTE11040
0C1C	45E0 09E0	1105 TEST2.13 CLH R14,MAXMEM	MTE11050
0C20	2184	1106 BLS TEST2.14	MTE11060
0C22	45F0 09E2	1107 CLH R15,MAXMEM+2	MTE11070
0C26	2389	1108 BNLS TEST2.20	MTE11080
0C28	26F2	1109 TEST2.14 AIS R15,2	MTE11090
0C2A	4EE0 09E4	1110 ACH R14,ZERO	MTE11100
0C2E	2612	1111 AIS R1,2	MTE11110
0C30	4380 0C0A	1112 BNC TEST2.12	MTE11120
0C34	4300 0C06	1113 B TEST2.11	MTE11130
		1114 *	MTE11140
		1115 *	MTE11150
0C38	D1E0 09E0	1116 TEST2.20 LM R14,MAXMEM	MTE11160
0C3C	41D0 072C	1117 TEST2.21 BAL R13,ADRSET	MTE11170
0C40	41D0 0756	1118 BAL R13,DISPLAY	MTE11180
0C44	2581	1119 TEST2.22 LCS R8,1	MTE11190
0C46	0781	1120 XHR R8,R1	MTE11200
0C48	4081 0000	1121 STH R8,0(R1)	MTE11210
0C4C	27F2	1122 SIS R15,2	MTE11220
0C4E	4FE0 09E4	1123 SCH R14,ZERO	MTE11230
0C52	C5F0 10C8	1124 CLHI R15,LAST	MTE11240
0C56	2133	1125 BNES TEST2.23	MTE11250
0C58	08EE	1126 LHR R14,R14	MTE11260
0C5A	2335	1127 BZS TEST2.30	MTE11270
0C5C	2712	1128 TEST2.23 SIS R1,2	MTE11280
0C5E	201D	1129 BMS TEST2.22	MTE11290

ADDRESS AS DATA  
R14,R15 = STARTING ADDRESS  
STORE ADDRESS AS DATA  
DONE LAST HALFWORD  
INCREMENT STORAGE ADDRESS  
INCREMENT PROGRAM ADDRESS  
NO NEED TO ADJUST IF NO CARRY  
R9 = DATA EXPECTED  
R8 = DATA OBSERVED  
R14,R15 = FAILING ADDRESS \*  
TEST IF DONE  
INCREMENT TEST ADDRESS  
INCREMENT PROGRAM ADDRESS  
NO NEED TO ADJUST IF NO CARRY  
ADDRESS FALSE AS DATA  
R14,R15 = STARTING ADDRESS  
GOING FROM TOP OF MEMORY DOWN  
R8 = ONES COMPLEMENT OF ADDRESS  
STORE ADDRESS FALSE AS DATA  
DECREMENT TEST ADDRESS  
SEE IF DONE  
DECREMENT PROGRAM ADDRESS  
NO NEED TO ADJUST IF BIT 0 SET

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\* S U B T E S T 2

0C60	4300 0C3C	1130	B	TEST2.21		
		1131	*			MTE11300
		1132	*			MTE11310
0C64	D1E0 09E0	1133	TEST2.30	LH R14,MAXMEM	NOW CHECK THE LOCATIONS	MTE11320
0C68	41D0 072C	1134	TEST2.31	BAL R13,ADRSET		MTE11330
0C6C	2591	1135	TEST2.32	LCS R9,1	R9 = 'FFFF'	MTE11340
0C6E	41D0 0756	1136	BAL	R13,DISPLAY	R9 = DATA EXPECTED	MTE11350
0C72	0791	1137	XHR	R9,R1	R8 = DATA OBSERVED	MTE11360
0C74	4881 0000	1138	LH	R8,0(R1)		MTE11370
0C78	0589	1139	CLHR	R8,R9		MTE11380
0C7A	2333	1140	BES	TEST2.33	OK IF THE SAME	MTE11390
0C7C	41D0 076A	1141	BAL	R13,ERRMSG	R14,R15 = FAILING ADDRESS *	MTE11400
0C80	27F2	1142	TEST2.33	SIS R15,2	DECREMENT TEST ADDRESS	MTE11410
0C82	4FE0 09E4	1143	SCH	R14,ZERO		MTE11420
0C86	C5F0 10C8	1144	CLHI	R15,LAST	SEE IF DONE	MTE11430
0C8A	2134	1145	BNES	TEST2.34		MTE11440
0C8C	08EE	1146	LHR	R14,R14		MTE11450
0C8E	4330 03D6	1147	BZ	TEST-END	END OF SUBTEST 2 *	MTE11460
0C92	2712	1148	TEST2.34	SIS R1,2	DECREMENT PROGRAM ADDRESS	MTE11470
0C94	4210 0C6C	1149	BM	TEST2.32	NO NEED TO ADJUST IF BIT 0 SET	MTE11480
0C98	4300 0C68	1150	S	TEST2.31		MTE11490
						MTE11500

## \* S U B T E S T 3

		1152	*	SUBTEST 3 TESTS ALL OF MEMORY FROM LAST+2 TO MAXMEM	
		1153	*		MTE11520
		1154	*	ONE THROUGH A FIELD OF ZEROS	MTE11530
	0000 0C9C	1155	TEST3	EQU *	MTE11540
	0C9C 07EE	1156	XHR	R14,R14	MTE11550
	0C9E C8F0 10CA	1157	LHI	R15, LAST+2	MTE11560
	0CA2 0788	1158	XHR	R8,R8	MTE11570
	0CA4 41D0 072C	1159	TEST3.01	BAL R13,ADRSET	MTE11580
	0CA8 41D0 0756	1160	BAL	R13,DISPLAY	MTE11590
	0CAC 4081 0000	1161	TEST3.02	STH R8,0(R1)	MTE11600
	0CB0 45E0 09E0	1162	CLH	R14,MAXMEM	MTE11610
	0CB4 2184	1163	BLS	TEST3.03	MTE11620
	0CB6 45F0 09E2	1164	CLH	R15,MAXMEM+2	MTE11630
	0CBA 2387	1165	BNLS	TEST3.10	MTE11640
	0CBC 26F2	1166	TEST3.03	AIS R15,2	MTE11650
	0CBE 0EE8	1167	ACHR	R14,R8	MTE11660
	0CC0 2612	1168	AIS	R1,2	MTE11670
	0CC2 2288	1169	BNCS	TEST3.02	MTE11680
	0CC4 4300 0CA4	1170	B	TEST3.01	MTE11690
		1171	*		MTE11700
		1172	*		MTE11710
	0CC8 07EE	1173	TEST3.10	XHR R14,R14	MTE11720
	0CCA C8F0 10CA	1174	LHI	R15, LAST+2	MTE11730
	0CCE 0799	1175	XHR	R9,R9	MTE11740
	0CD0 25A1	1176	LCS	R10,1	MTE11750
	0CD2 41D0 072C	1177	TEST3.11	BAL R13,ADRSET	MTE11760
	0CD6 41D0 0756	1178	TEST3.12	BAL R13,DISPLAY	MTE11770
	0CDA 4881 0000	1179	LH	R8,0(R1)	MTE11780
	0CDE 2333	1180	BZS	TEST3.13	MTE11790
	0CE0 41D0 076A	1181	BAL	R13,ERRMSG	MTE11800
	0CE4 40A1 0000	1182	TEST3.13	STH R10,0(R1)	MTE11810
	0CE8 45E0 09E0	1183	CLH	R14,MAXMEM	MTE11820
	0CEC 2184	1184	BLS	TEST3.14	MTE11830
	0CEE 45F0 09E2	1185	CLH	R15,MAXMEM+2	MTE11840
	0CF2 2388	1186	BNLS	TEST3.20	MTE11850
	0CF4 26F2	1187	TEST3.14	AIS R15,2	MTE11860
	0CF6 0EE9	1188	ACHR	R14,R9	MTE11870
	0CF8 2612	1189	AIS	R1,2	MTE11880
	0CFA 4380 0CD6	1190	BNC	TEST3.12	MTE11890
	0CFE 4300 0CD2	1191	B	TEST3.11	MTE11900
		1192	*		MTE11910
		1193	*		MTE11920
	0D02 D1E0 09E0	1194	TEST3.20	LM R14,MAXMEM	MTE11930
	0D06 07AA	1195	XHR	R10,R10	MTE11940
	0D08 2591	1196	LCS	R9,1	MTE11950
	0D0A 41D0 072C	1197	TEST3.21	BAL R13,ADRSET	MTE11960
	0D0E 41D0 0756	1198	TEST3.22	BAL R13,DISPLAY	MTE11970
	0D12 4881 0000	1199	LH	R8,0(R1)	MTE11980
	0D16 0589	1200	CLHR	R8,R9	MTE11990
	0D18 2333	1201	BES	TEST3.23	MTE12000
	0D1A 41D0 076A	1202	BAL	R13,ERRMSG	MTE12010
	0D1E 40A1 0000	1203	TEST3.23	STH R10,0(R1)	MTE12020
	0D22 27F2	1204	SIS	R15,2	MTE12030
				RE-WRITE ALL ZEROS	MTE12040
				DECREMENT TEST ADDRESS	

\*

## S U B T E S T 3

0D24	0FEA	1205	SCHR	R14,R10	
0D26	C5F0 10C8	1206	CLHI	R15 LAST	MTE12050
0D2A	2134	1207	BNES	TEST3.24	MTE12060
0D2C	08EE	1208	LHR	R14,R14	MTE12070
0D2E	4330 03D6	1209	BZ	TEST-END	MTE12080
0D32	2712	1210	TEST3.24	SIS R1,2	MTE12090
0D34	4210 0DDE	1211	BM	TEST3.22	MTE12103
0D38	4300 0D0A	1212	B	TEST3.21	MTE12110
				END OF SUBTEST 3	*
				DECREMENT PROGRAM ADDRESS	
				NO NEED TO ADJUST IF BIT 0 SET	

## S U B T E S T 4

		1214	*	SUBTEST 4 IS THE MODULE DECODE EXERCISE	MTE12140
		1215	*	IN ONE 8K BLOCK, ONE HALFWORD OF ONES IS WRITTEN	MTE12150
		1216	*	THE CORRESPONDING LOCATION IN ALL OTHER 8K BLOCKS	MTE12160
		1217	*	IS THEN TESTED FOR THE BACKGROUND PATTERN '0000'	MTE12170
		1218	*		MTE12180
		1219	*		MTE12190
	0000 0D3C	1220	TEST4	EQU *	MTE12200
	0D3C 07EE	1221	XHR	R14,R14	MTE12210
	C8F0 10CA	1222	LHI	R15,X'LAST+2	MTE12220
	0D42 0788	1223	XHR	R8,R8	MTE12230
	41D0 072C	1224	TEST4.01	BAL R13,ADRSET	MTE12240
	0D48 41D0 0756	1225	BAL	R13,DISPLAY	MTE12250
	0D4C 4081 0000	1226	TEST4.02	STH R8,0(R1)	MTE12260
	45E0 09E0	1227	CLH	R14,MAXMEM	MTE12270
	0D54 2184	1228	BLS	TEST4.03	MTE12280
	45F0 09E2	1229	CLH	R15,MAXMEM+2	MTE12290
	0D5A 2387	1230	BNLS	TEST4.10	MTE12300
	0D5C 26F2	1231	TEST4.03	AIS R15,2	MTE12310
	0D5E 0EE8	1232	ACHR	R14,R8	MTE12320
	0D60 2512	1233	AIS	R1,2	MTE12330
	0D62 2288	1234	BNCS	TEST4.02	MTE12340
	0D64 4300 0D44	1235	B	TEST4.01	MTE12350
		1236	*		MTE12360
		1237	*		MTE12370
	0D68 07AA	1238	TEST4.10	XHR R10,R10	MTE12380
	C8F0 1400	1239	LHI	R11,X'1400'	MTE12390
	0D6E 08EA	1240	TEST4.20	LHR R14,R10	MTE12400
	0D70 08FB	1241	LHR	R15,R11	MTE12410
	41D0 072C	1242	BAL	R13,ADRSET	MTE12420
	0D76 41D0 0756	1243	BAL	R13,DISPLAY	MTE12430
	0D7A 2581	1244	LCS	R8,1	MTE12440
	0D7C 4081 0000	1245	STH	R8,0(R1)	MTE12450
		1246	*	STORE 'FFFF' IN ONE CELL	MTE12460
	0D80 07EE	1247	TEST4.30	XHR R14,R14	MTE12470
	C8F0 1400	1248	LHI	R15,X'1400'	MTE12480
	0D86 41D0 0756	1249	TEST4.31	BAL R13,DISPLAY	MTE12490
	0D8A 0799	1250	XHR	R9,R9	MTE12500
	0D8C 05EA	1251	CLHR	R14,R10	MTE12510
	0D8E 2134	1252	BNES	TEST4.32	MTE12520
	0D90 05FB	1253	CLHR	R15,R11	MTE12530
	0D92 4330 0DA4	1254	BE	TEST4.40	MTE12540
	0D96 41D0 072C	1255	TEST4.32	BAL R13,ADRSET	MTE12550
	0D9A 4881 0003	1256	LH	R8,0(R1)	MTE12560
	2333	1257	BZS	TEST4.40	MTE12570
	41D0 076A	1258	BAL	R13,ERRMSG	MTE12580
		1259	*	R14,R15 = FAILING BLOCK *	MTE12590
		1260	*		MTE12600
	0DA4 CAF0 2000	1261	TEST4.40	AHI R15,X'2000'	MTE12610
	0DA8 0EE9	1262	ACHR	R14,R9	MTE12620
	45E0 09E0	1263	CLH	R14,MAXMEM	MTE12630
	0DAE 42B0 0086	1264	BL	TEST4.31	MTE12640
	0DB2 21B5	1265	BPS	TEST4.41	MTE12650
	45F0 09E2	1266	CLH	R15,MAXMEM+2	MTE12660

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\* S U B T E S T 4

0DB8	4280 0086	1267	BL	TEST4.31	
		1268	*		MTE12670
		1269	*		MTE12680
0DBC	09EA	1270	TEST4.41	LHR R14,R10	MTE12690
0DBE	08FB	1271	LHR	R15,R11	MTE12700
0DC0	4100 072C	1272	BAL	R13,ADRSET	MTE12710
0DC4	4091 0000	1273	STH	R9,0(R1)	MTE12720
		1274	*		MTE12730
0DC8	C400 2000	1275	AHI	R11,X*2000!	MTE12740
0DCC	0EA9	1276	ACHR	R10,R9	MTE12750
0DCE	45A0 09E0	1277	CLH	R10,MAXMEM	MTE12760
0DD2	4280 0D6E	1278	BL	TEST4.20	MTE12770
0DD6	4220 0306	1279	BP	TEST-END	MTE12780
0DDA	45B0 09E2	1280	CLH	R11,MAXMEM+2	MTE12790
0DDE	4280 0D6E	1281	BL	TEST4.20	MTE12800
0DE2	4300 0306	1282	B	TEST-END	MTE12810
					MTE12820

## \* S U B T E S T 5

0000 0DE6	1284 TEST5 EQJ *		MTE12840
	1285 * SUBTEST 5 WRITES A SELECTED PATTERN INTO MEMORY		MTE12850
	1286 *		MTE12860
0DE6 D1E0 0A1E	1287 LM R14,LOW+6	PICK UP LOW MEMORY ADDRESS	MTE12870
0DEA 41D0 0842	1288 BAL R13,ADCHECK	CHECK LIMITS	MTE12880
0DEE D1E0 0A28	1289 LM R14,HIGH+6	PICK UP HIGH MEMORY ADDRESS	MTE12890
0DF2 41D0 0842	1290 BAL R13,ADCHECK	CHECK LIMITS	MTE12900
0DF6 4BF0 0A20	1291 SH R15,LOW+8	COMPARE TO LOW ADDRESS	MTE12910
0DFA 4FE0 0A1E	1292 SCH R14,LOW+6		MTE12920
0DFE 42B0 0850	1293 BL ADCHK.ER	ERROR IF LOW > HIGH	MTE12930
0E02 4820 09F6	1294 LH R2,CONAD?		MTE12940
0E06 DE20 09F8	1295 OC R2,CONRD	CONSOLE IN READ MODE	MTE12950
0E0A 07AA	1296 XHR R10,R10		MTE12960
0E0C D1E0 0A1E	1297 TEST5.10 LM R14,LOW+6	START ADDRESS	MTE12970
0E10 4890 0A5A	1298 LH R9,DATA+6	DATA PATTERN	MTE12980
0E14 41D0 072C	1299 TEST5.11 BAL R13,ADRSET		MTE12990
0E18 41D0 0756	1300 TEST5.12 BAL R13,DISPLAY		MTE13000
0E1C 4051 0000	1301 STH R9,0(R1)	STORE PATTERN	MTE13010
0E20 9023	1302 SSR R2,R3		MTE13020
0E22 C330 0029	1303 THI R3,X*20*	TEST FOR BREAK	MTE13030
0E26 4230 05D4	1304 BNZ TSTBRK		MTE13040
0E2A 26F2	1305 AIS R15,2	INCREMENT DISPLAY ADDRESS	MTE13050
0E2C 0EEA	1306 ACHR R14,R10		MTE13060
0E2E 45E0 0A28	1307 CLH R14,HIGH+6		MTE13070
0E32 2185	1308 BLS TEST5.20		MTE13080
0E34 45F0 0A2A	1309 CLH R15,HIGH+8		MTE13090
0E38 4380 0EOF	1310 BNL TEST5.10		MTE13100
0E3C 2612	1311 TEST5.20 AIS R1,2	REPEAT FROM LOW ADDRESS	MTE13110
0E3E 4380 0E18	1312 BNC TEST5.12	INCREMENT PROGRAM ADDRESS	MTE13120
0E42 4300 0E14	1313 B TEST5.11	NO ADJUST IF NO CARRY	MTE13130

\* SUBTEST 6

		1315 * SUBTEST 6 IS THE WORST CASE ACCESS TEST		
		1316 * MEMORY IS CLEARED. ALL ONES ARE WRITTEN TO A HALFWORD		MTE13150
		1317 * AND THE NEXT SEQUENTIAL HALFWORD IS READ AND TESTED FOR		MTE13160
		1318 * ZEROS. WITH MEMORY EQUAL TO ALL ONES, ZEROS ARE WRITTEN		MTE13170
		1319 * TO A HALFWORD AND THE NEXT SEQUENTIAL HALFWORD IS TESTED		MTE13180
		1320 * FOR ALL ONES.		MTE13190
		1321 *		MTE13200
		1322 *		MTE13210
	0C80 0E46	1323 TEST6 EQU *		MTE13220
0E46	07EE	1324 XHR R14,R14		MTE13230
0E48	C8F0 10CA	1325 LHI R15, LAST+2	R14,R15 = STARTING ADDRESS	MTE13240
0E4C	0798	1326 XHR R8,R8		MTE13250
0E4E	41D0 072C	1327 TEST6.01 BAL R13,ADRSET		MTE13260
0E52	41D0 0756	1328 BAL R13,DISPLAY		MTE13270
0E56	4081 0000	1329 TEST6.02 STH R8,0(R1)	CLEAR ALL OF MEMORY	MTE13280
0E5A	45E0 09E0	1330 CLH R14,MAXMEM		MTE13290
0E5E	2184	1331 BLS TEST6.03		MTE13300
0E60	45F0 09E2	1332 CLH R15,MAXMEM+2		MTE13310
0E64	2387	1333 BNLS TEST6.04		MTE13320
0E66	25F2	1334 TEST6.03 AIS P15,2		MTE13330
0E68	0EE8	1335 ACHR R14,R8		MTE13340
0E6A	2612	1336 AIS R1,2		MTE13350
0E6C	228B	1337 BNCS TEST6.02		MTE13360
0E6E	4300 0E4E	1338 B TEST6.01		MTE13370
		1339 *		MTE13380
		1340 *		MTE13390
0E72	07EE	1341 TEST6.04 XHR R14,R14		MTE13400
0E74	C8F0 10CA	1342 LHI R15, LAST+2	R14,R15 = STARTING ADDRESS	MTE13410
0E78	0799	1343 XHR R9,R9		MTE13420
0E7A	25A1	1344 LCS R10,1		MTE13430
0E7C	41D0 072C	1345 TEST6.10 BAL R13,ADRSET		MTE13440
0E80	41D0 0756	1346 TEST6.11 BAL R13,DISPLAY		MTE13450
0E84	C510 FFFE	1347 CLHI R1,X"FFF"	SEE IF AT BOUNDARY	MTE13460
0E88	233B	1348 BES TEST6.12	IF YES, JUST WRITE ONES	MTE13470
0E8A	40A1 0000	1349 STH R10,0(R1)	WRITE ONES	MTE13480
0E8E	4881 0002	1350 LH R8,2(R1)	READ ZEROS	MTE13490
0E92	233B	1351 BZS TEST6.13	SKIP IF ZERO	MTE13500
0E94	26F2	1352 AIS R15,2	WORKING ADDRESS PLUS 2	MTE13510
0E96	0EE9	1353 ACHR R14,R9		MTE13520
0E98	41D0 076A	1354 BAL R13,ERRMSG	R14,R15 = FAILING ADDRESS *	MTE13530
0E9C	2305	1355 BS TEST6.14		MTE13540
0E9E	40A1 0000	1356 TEST6.12 STH R10,0(R1)	WRITE ONES	MTE13550
0EA2	26F2	1357 TEST6.13 AIS R15,2	INCREMENT TEST ADDRESS	MTE13560
0EA4	0EE9	1358 ACHR R14,R9		MTE13570
0EA6	45E0 09E0	1359 TEST6.14 CLH R14,MAXMEM	TEST IF ODNE	MTE13580
0EAA	2184	1360 BLS TEST6.15		MTE13590
0EAC	45F0 09E2	1361 CLH R15,MAXMEM+2		MTE13600
0EB0	2386	1362 BNLS TEST6.20		MTE13610
0EB2	2612	1363 TEST6.15 AIS R1,2	DONE	MTE13620
0EB4	4280 0E7C	1364 BC TEST6.10	INCREMENT PROGRAM ADDRESS	MTE13630
0EB8	4300 0E80	1365 B TEST6.11	RE-ADJUST IF CARRY	MTE13640
		1366 *		MTE13650
		1367 *		MTE13660
				MTE13670

## S U B T E S T 6

0EBC	07EE	1368	TEST6.20	XHR	R14,R14	MTE13680	
0EBE	C8F0 10CA	1369	LHI	R15, LAST+2	MTE13690		
0EC2	2591	1370	LCS	R9,1	MTE13700		
0EC4	07AA	1371	XHR	R10,R10	MTE13710		
0EC6	41D0 072C	1372	TEST6.21	BAL	R13,ADRSET	MTE13720	
0ECA	41D0 0756	1373	BAL	R13,DISPLAY	MTE13730		
0EDC	C510 FFFE	1374	TEST6.22	CLHI	R1,X'FFFF'	SEE IF AT BOUNDARY MTE13740	
0ED2	2333	1375	BES	TEST6.23	SKIP IF YES	MTE13750	
0ED4	40A1 0002	1376	STH	R10,2(R1)	WRITE ZEROS TO LOC+2	MTE13760	
0ED8	4881 0000	1377	TEST6.23	LH	R8,0(R1)	READ ONES FROM LOC MTE13770	
0EDC	0589	1378	CLHR	R8,R9	MTE13780		
0EDE	2333	1379	BES	TEST6.24	MTE13790		
0EE0	41D0 076A	1380	BAL	R13,ERRMSG	R14,R15 = FAILING ADDRESS *	MTE13800	
0EE4	40A1 0009	1381	TEST6.24	STH	R10,0(R1)	WRITE ZEROS IN TEST LOC	MTE13810
0EE8	C510 FFFE	1382	CLHI	R1,X'FFFF'	SEE IF AT BOUNDARY	MTE13820	
0EEC	2333	1383	BES	TEST6.25	MTE13830		
0EEE	4091 0002	1384	STH	R9,2(R1)	LOC+2 RESET TO 'FFFF'	MTE13840	
0EF2	26F2	1385	TEST6.25	AIS	R15,2	INCREMENT TEST ADDRESS	MTE13850
0EF4	0EEA	1386	ACHR	R14,R10	MTE13860		
0EF6	45E0 09E0	1387	CLH	R14,MAXMEM	TEST IF END OF MEMORY	MTE13870	
0EFA	2184	1388	BLS	TEST6.26	MTE13880		
0EFC	45F0 09E2	1389	CLH	R15,MAXMEM+2	MTE13890		
0F00	2386	1390	BNLS	TEST6.30	DONE	MTE13900	
0F02	2612	1391	TEST6.26	AIS	R1,2	INCREMENT PROGRAM ADDRESS	MTE13910
0F04	4280 0ECS	1392	8C	TEST6.21	ADJUST IF CARRY	MTE13920	
0F08	4300 0ECE	1393	B	TEST6.22	MTE13930		
		1394	*			MTE13940	
		1395	*	ALL OF MEMORY FROM LAST+2 UP IS CLEAR		MTE13950	
		1396	*			MTE13960	
0F0C	07EE	1397	TEST6.30	XHR	R14,R14	MTE13970	
0F0E	C8F0 10CA	1398	LHI	R15, LAST+2	MTE13980		
0F12	41D0 072C	1399	TEST6.31	BAL	R13,ADRSET	MTE13990	
0F16	41D0 0756	1400	BAL	R13,DISPLAY	MTE14000		
0F1A	0799	1401	TEST6.32	XHR	R9,R9	R9 = '0000'	MTE14010
0F1C	25A1	1402	LCS	R10,1	R10 = 'FFFF'	MTE14020	
0F1E	4881 0000	1403	LH	R8,0(R1)	READ ZEROS	MTE14030	
0F22	D2A1 0000	1404	STB	R10,0(R1)	WRITE ONES <0:7>	MTE14040	
0F26	D2A1 0001	1405	STB	R10,1(R1)	WRITE ONES <8:15>	MTE14050	
0F2A	48A1 0000	1406	LH	R10,0(R1)	READ ONES	MTE14060	
0F2E	4091 0000	1407	STH	R9,0(R1)	WRITE ZEROS	MTE14070	
0F32	0888	1408	LHR	R8,R8	DID WE GET ZEROS FIRST TIME?	MTE14080	
0F34	2333	1409	BZS	TEST6.33	OK IF YES	MTE14090	
0F36	41D0 076A	1410	BAL	R13,ERRMSG	R14,R15 = FAILING ADDRESS *	MTE14100	
0F3A	2591	1411	TEST6.33	LCS	R9,1	EXPECTING 'FFFF'	MTE14110
0F3C	088A	1412	LHR	R8,R10	DID WE GET 'FFFF' ?	MTE14120	
0F3E	0589	1413	CLHR	R8,R9	MTE14130		
0F40	2333	1414	BES	TEST6.34	SKIP IF YES	MTE14140	
0F42	41D0 076A	1415	BAL	R13,ERRMSG	R14,R15 = FAILING ADDRESS *	MTE14150	
0F46	25F2	1416	TEST6.34	AIS	R15,2	NEXT HALFWORD	MTE14160
0F48	0EEA	1417	ACHR	R14,R10	MTE14170		
0F4A	45E0 09E0	1418	CLH	R14,MAXMEM	MTE14180		
0F4E	2185	1419	BLS	TEST6.35	MTE14190		
0F50	45F0 09E2	1420	CLH	R15,MAXMEM+2	MTE14200		

## \* S U B T E S T 6

0F54	4380 03D6	1421	BNL	TEST-END		
0F58	2512	1422	TEST6.35 AIS	R1,2	INCREMENT PROGRAM ADDRESS	MTE14210
0F5A	4280 0F12	1423	BC	TEST6.31	ADJUST ADDRESS	MTE14220
0F5E	4300 0F1A	1424	B	TEST6.32		MTE14230
						MTE14240

## S U B T E S T 7

		1426	* SUBTEST 7 LOADS WORST CASE PATTERNS INTO MEMORY	MTE14260	
		1427	*	MTE14270	
		1428	* FIRST ALL LOCATIONS ARE LOADED WITH ALTERNATE	MTE14280	
		1429	* ONES AND ZEROS I.E. 5555 THEN AAAA	MTE14290	
		1430	*	MTE14300	
		1431	*	MTE14310	
0F62	0000	1432	DATAPAT DCX 0000	MTE14320	
		1433	*	MTE14330	
0F64	0000 0F64	1434	TEST7 EQU *	MTE14340	
0F64	C890 5555	1435	LHI R9,X*5555*	MTE14350	
0F68	4090 0F62	1436	TEST7.0X STH R9,DATAPAT	SAVE DATA PATTERN	MTE14360
0F6C	07EE	1437	XHR R14,R14	MTE14370	
0F6E	C8F0 10CA	1438	LHI R15, LAST+2	MTE14380	
0F72	4890 0F62	1439	LH R9,DATAPAT	MTE14390	
0F76	25A1	1440	LCS R10,1	MTE14400	
0F78	41D0 072C	1441	TEST7.01 BAL R13,ADRSET	MTE14410	
0F7C	41D0 0756	1442	BAL R13,DISPLAY	MTE14420	
0F80	4091 0000	1443	TEST7.02 STH R9,0(R1)	STORE PATTERN	MTE14430
0F84	079A	1444	XHR R9,R10	COMPLEMENT FOR NEXT TIME	MTE14440
0F86	26F2	1445	AIS R15,2	INCREMENT ADDRESS	MTE14450
0F88	4EE0 09E4	1446	ACH R14,ZERO	MTE14460	
0F8C	45E0 09E0	1447	CLH R14,MAXMEM	TEST IF DONE	MTE14470
0F90	2184	1448	BLS TEST7.03	MTE14480	
0F92	45F0 09E2	1449	CLH R15,MAXMEM+2	MTE14490	
0F96	2386	1450	BMLS TEST7.10	MTE14500	
0F98	2612	1451	TEST7.03 AIS R1,2	DONE	MTE14510
0F9A	4280 0F78	1452	BC TEST7.01	INCREMENT PROGRAM ADDRESS	MTE14520
0F9E	4300 0F80	1453	B TEST7.02	ADJUST IF CARRY	MTE14530
		1454	*	MTE14540	
		1455	*	MTE14550	
0FA2	4890 0F62	1456	TEST7.10 LH R9,DATAPAT	FIRST PATTERN	MTE14560
0FA6	07EE	1457	XHR R14,R14	MTE14570	
0FA8	C8F0 10CA	1458	LHI R15, LAST+2	MTE14580	
0FAC	4100 072C	1459	TEST7.11 BAL R13,ADRSET	MTE14590	
0FB0	4100 0756	1460	BAL R13,DISPLAY	MTE14600	
0FB4	4881 0000	1461	TEST7.12 LH R8,0(R1)	READ '5555'	MTE14610
0FB8	0589	1462	CLHR R8,R9	MTE14620	
0FBA	2333	1463	BES TEST7.13	MTE14630	
0FBC	41B0 076A	1464	BAL R13,ERRMSG	R14,R15=FAILING ADDRESS *	MTE14640
0FC0	079A	1465	TEST7.13 XHR R9,R10	COMPLEMENT PATTERN	MTE14650
0FC2	4091 0000	1466	STH R9,0(R1)	STORE IT	MTE14660
0FC6	4881 0000	1467	LH R8,0(R1)	READ 'AAAA'	MTE14670
0FCA	0589	1468	CLHR R8,R9	MTE14680	
0FCC	2333	1469	BES TEST7.14	MTE14690	
0FCE	4100 076A	1470	BAL R13,ERRMSG	R14,R15=FAILING ADDRESS *	MTE14700
0FD2	079A	1471	TEST7.14 XHR R9,R10	BACK TO ORIGINAL PATTERN	MTE14710
0FD4	4091 0000	1472	STH R9,0(R1)	RESTORE	MTE14720
0FD8	079A	1473	XHR R9,R10	COMPLEMENT PATTERN FOR NEXT PASS	MTE14730
0FDA	26F2	1474	AIS R15,2	INCREMENT ADDRESS	MTE14740
0FDC	4EE0 09E4	1475	ACH R14,ZERO	MTE14750	
0FE0	45E0 09E0	1476	CLH R14,MAXMEM	TEST IF DONE	MTE14760
0FE4	2184	1477	BLS TEST7.15	MTE14770	
0FE6	45F0 09E2	1478	CLH R15,MAXMEM+2	MTE14780	

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## S U B T E S T 7

0FEA 2386	1479	BNLS	TEST7.20	DONE	
0FEC 2512	1480	TEST7.15	AIS R1,2	INCREMENT PROGRAM ADDRESS	MTE14790
0FEE 4280 0FAC	1481	BC	TEST7.11	ADJUST IF CARRY	MTE14800
0FF2 4300 0FB4	1482	B	TEST7.12		MTE14810
	1483	*			MTE14820
	1484	*			MTE14830
	1485	*	FIRST PASS SET MEMORY TO '5555', 'AAAA', 'SSSS', 'AAAA', ETC.		MTE14840
	1486	*	ON SECOND PASS, USE '0000', 'FFFF', '0000', 'FFFF', ETC.		MTE14850
	1487	*	ON LAST PASS, USE 'C6C6', '3939', 'C6C6', '3939', ETC.		MTE14860
	1488	*			MTE14870
	1489	*			MTE14880
0FF6 4890 0F62	1490	TEST7.20	LH R9,DATAPAT	CHECK LAST PATTERN USED	MTE14890
0FFA 2336	1491	BZS	TEST7.21	WAS '0000', 'FFFF'	MTE14900
0FFC 4210 03D6	1492	BM	TEST.END	WAS 'C6C6', '3939'	MTE14910
	1493	*		WAS '5555', 'AAAA'	MTE14920
1000 0799	1494	XHR	R9,R9	USE '0000', 'FFFF'	MTE14930
1002 4300 0F68	1495	B	TEST7.0X		MTE14940
1006 C890 C6C6	1496	TEST7.21	LHI R9,X'C6C6'	USE 'C6C6', '3939'	MTE14950
100A 4300 0F68	1497	B	TEST7.0X		MTE14960
					MTE14970

## S U B T E S T 8

		1499	*	EXECUTE A SUBROUTINE FROM EVERY AVAILABLE MEMORY LOCATION	MTE14990
		1500	*		MTE15000
	0000 100E	1501	TEST8	EQJ *	MTE15010
	100E 07EE	1502	XHR	R14,R14	MTE15020
	1010 C8F0 10CA	1503	LHI	R15, LAST+2	MTE15030
	1014 D0E0 10BC	1504	TEST8.10	STM R14,STRTADRS	MTE15040
	1018 41D0 0755	1505	BAL	R13,DISPLAY	MTE15050
	101C 0700	1506	XHR	R0,R0	MTE15060
	101E CAF0 001F	1507	AHI	R15,SIZE-1	MTE15070
	1022 0EE0	1508	ACHR	R14,R0	MTE15080
	1024 D0E0 10C0	1509	STM	R14,ENDADRS	MTE15090
	1028 41D0 072C	1510	BAL	R13,ADRSET	MTE15100
	102C 95DD	1511	EPSR	R13,R13	MTE15110
	102E C4D0 00F0	1512	NHI	R13,X'00F0'	MTE15120
	1032 40D0 10C4	1513	STH	R13,SELECT	MTE15130
	1036 4010 10C6	1514	STH	R1,ADDRESS	MTE15140
	103A D1E0 10BC	1515	LM	R14,STRTADRS	MTE15150
	103E 41D0 072C	1516	BAL	R13,ADRSET	MTE15160
	1042 95DD	1517	EPSR	R13,R13	MTE15170
	1044 C4D0 00F0	1518	NHI	R13,X'00F0'	MTE15180
	1048 45D0 10C4	1519	CLH	R13,SELECT	MTE15190
	104C 4230 107A	1520	BNE	TEST8.30	MTE15200
		1521	*		MTE15210
	1050 08D1	1522	LHR	R13,R1	MTE15220
	1052 47D0 10C6	1523	XH	R13,ADDRESS	MTE15230
		1524	*		MTE15240
		1525	*		MTE15250
	1056 4210 107A	1526	BM	TEST8.30	MTE15260
		1527	*		MTE15270
	1054 08C1	1528	LHR	R12,R1	MTE15280
	105C 07DD	1529	XHR	R13,R13	MTE15290
	105E 48BD 109C	1530	TEST8.20	LH R11,SBRTN(R13)	MTE15300
	1062 40BC 0000	1531	STH	R11,0(R12)	MTE15310
	1066 25C2	1532	AIS	R12,2	MTE15320
	1068 26D2	1533	AIS	R13,2	MTE15330
	106A C5D0 0020	1534	CLHI	R13,SIZE	MTE15340
	106E 2088	1535	BLS	TEST8.20	MTE15350
	1070 01D1	1536	BALR	R13,R1	MTE15360
		1537	*		MTE15370
	1072 0899	1538	LHR	R9,R9	MTE15380
	1074 2333	1539	BZS	TEST8.30	MTE15390
	1076 41D0 076A	1540	BAL	R13,ERRMSG	MTE15400
	107A 48C0 10C0	1541	TEST8.30	LH R12,ENDADRS	MTE15410
	107E 48D0 10C2	1542	LH	R13,ENDADRS+2	MTE15420
	1082 0700	1543	XHR	R0,R0	MTE15430
	1084 25F2	1544	AIS	R15,2	MTE15440
	1086 0EE0	1545	ACHR	R14,R0	MTE15450
	1088 26D2	1546	AIS	R13,2	MTE15460
	108A 0EC0	1547	ACHR	R12,R0	MTE15470
	108C 4BDO 09E2	1548	SH	R13,MAXMEM+2	MTE15480
	1090 4FC0 09E0	1549	SCH	R12,MAXMEM	MTE15490
	1094 4280 1014	1550	BL	TEST8.10	MTE15500
	1098 4300 0306	1551	B	TEST.END	MTE15510

\*

## S U B T E S T 8

109C	08C1	1552 *			
109E	CAC0 000A	1553 SBRTN LHR R12,R1	R12 = ENTRY PROGRAM ADDRESS	MTE15520	
10A2	C890 0054	1554 AHI R12,SBRTNX-SBRTN	ADDRESS OF SBRTNX FOR LOOP	MTE15530	
10A6	4091 001E	1555 LHI R9,100	R9 = LOOP COUNT	MTE15540	
10AA	4881 001E	1556 SBRTNX STH R9,30(R1)	STORE COUNT AT SBRTNY	MTE15550	
10AE	0589	1557 LH R8,30(R1)	PICK IT UP	MTE15560	
10B0	0230	1558 CLHR R8,R9	COMPARE	MTE15570	
10B2	2791	1559 BNER R13	ERROR EXIT, R8 NON ZERO	MTE15580	
10B4	2301	1560 SIS R9,1	DECREMENT COUNT	MTE15590	
10B6	023C	1561 BS **2		MTE15600	
10B8	0300	1562 BNZR R12	IF NOT ZERO, LOOP THROUGH R12	MTE15610	
10BA	0000	1563 BR R13	NORMAL EXIT, R9 = 0	MTE15620	
	0000 0020	1564 SBRTNY DC 0		MTE15630	
		1565 SIZE EQU **-SBRTN		MTE15640	
		1566 *		MTE15650	
10BC	0030	1567 *		MTE15660	
10BE	0000	1568 STRTADRS DCX 0,0		MTE15670	
10C0	0000	1569 ENDADRS DCX 0,0		MTE15680	
10C2	0000				
10C4	0000	1570 SELECT DCX 0		MTE15690	
10C6	0000	1571 ADDRESS DCX 0		MTE15700	
	0000 10C8	1572 LAST EQU *		MTE15710	
	0000 10C7	1573 LN2B EQU **-1		MTE15720	
				MTE15730	

## CHKSUM/M17 PUNCHER

10C8 2400		1575 \$CHKSUM	LIS R0,0	PUNCH M17 TAPE WITH CHECKSUM	MTE15750
10CA 9510		1576 EPSR	R1,R0	SELECT REG.SET 0	MTE15760
		1577 *			MTE15770
10CC C810 0100		1578 LDAI	R1,ORIGIN1	START	MTE15780
10D0 2421		1579 LIS	R2,1	INCREMENT	MTE15790
10D2 C830 10C7		1580 LDAI	R3,LNZB	FINAL	MTE15800
10D6 2440		1581 LIS	R4,0	CHECKSUM BYTE	MTE15810
10D8 D351 0000		1582 \$GEN	LB R5,0(R1)		MTE15820
10DC 0745		1583 XAR	R4,R5		MTE15830
10DE C110 10D8		1584 BXLE	R1,\$GEN		MTE15840
10E2 0240 0080		1585 STB	R4,MN+3	CHECKSUM BYTE TO BOOT LOADER	MTE15850
		1586 *			MTE15860
10E6 C810 0080		1587 \$TAPE	LHI R1,X'0080'		MTE15870
10EA 9E21		1588 OCR	R2,R1	DISPLAY : NORMAL MODE	MTE15880
10EC 9444		1589 EXBR	R4,R4		MTE15890
10EE 9824		1590 WHR	R2,R4	CHECKSUM BYTE TO D1	MTE15900
10F0 9411		1591 EXBR	R1,R1		MTE15910
10F2 9501		1592 EPSR	R0,R1	HALT PROCESSOR.	MTE15920
10F4 D360 007A		1594 \$PUNCH	LB R6,X'7A'	GET BOUTDV (PUNCH) ADDRESS.	MTE15940
10F8 DE60 0078		1595 OC	R6,X'7B'	START TAPE PUNCH	MTE15950
10FC 9D60		1596 SSR	R6,R0		MTE15960
10FE 2081		1597 BTBS	8,1		MTE15970
1100 41F0 1142		1598 BAL	R15,\$TAPL	PUNCH LEADER	MTE15980
1104 9411		1599 EXBR	R1,R1	(R1) = X'0080'	MTE15990
1106 C830 00CF		1600 LHI	R3,X'CF'		MTE16000
110A DA61 0000		1601 \$PNCH1	WD R6,0(R1)	PUNCH BOOT LOADER	MTE16010
110E 9D60		1602 SSR	R6,R0		MTE16020
1110 2081		1603 BTBS	8,1		MTE16030
1112 C110 110A		1604 BXLE	R1,\$PNCH1		MTE16040
1116 41F0 1148		1605 BAL	R15,\$TAPL1	PUNCH ONE-FOLD GAP.	MTE16050
		1605 *			MTE16060
111A D340 008D		1607 LB	R4,MN+3	GET CHECKSUM BYTE	MTE16070
111E C810 0100		1608 LDAI	R1,ORIGIN1	(NORMALLY X'A00')	MTE16080
1122 C830 10C7		1609 LDAI	R3,LNZB		MTE16090
1126 D351 0000		1610 \$PNCH2	LB R5,0(R1)	PUNCH PROGRAM	MTE16100
112A 0745		1611 XAR	R4,R5		MTE16110
112C 9A65		1612 WDR	R6,R5		MTE16120
112E 9401		1613 EXBR	R0,R1		MTE16130
1130 9820		1614 WHR	R2,R0	DATA ADDRESS TO DISPLAY	MTE16140
1132 9D60		1615 SSR	R6,R0		MTE16150
1134 2081		1616 BTBS	8,1		MTE16160
1136 C110 1126		1617 BXLE	R1,\$PNCH2		MTE16170
113A 41F0 1142		1618 BAL	R15,\$TAPL	PUNCH TRAILER.	MTE16180
113E 4300 10E5		1619 \$TAPE	B	DISPLAY CHECKSUM, HALT PROCESSOR	MTE16190
1142 C900 0100		1621 \$TAPL	LHI R0,256	TO PUNCH BLANK LEADER	MTE16210
1146 2303		1622 BS	\$TAPLP		MTE16220
1148 C800 0055		1623 \$TAPL1	LHI R0,85	TO PUNCH 1-FOLD GAP	MTE16230

## CHKSUM/M17 PUNCHER

114C 2701						
114E 032F	1624	\$TAPLP	SIS	R0,1		MTE16240
1150 2430	1625	SNPR	R15		RETURN	MTE16250
1152 9A53	1626	LIS	R3,0			MTE16250
1154 9268	1627	DCR	R6,R3		PUNCH BLANK FRAME	MTE16270
1156 2031	1628	SSR	R6,R8			MTE16270
1158 2206	1629	BT3S	B,1			MTE16280
115A	1630	BS	\$TAPLP		CONTINUE.	MTE16290
	1631	END				MTE16300
						MTE16310

MODEL 8116 E EXTENDED MEMORY TEST 05-221R30M93S PART 2 PAGE 47 08:39:12 08712780

CHKSUM/M17 PUNCHER

ASSEMBLED BY CAL 03-066R03-00 (32-BIT)

START OPTIONS: \*NONE\*

NO CAL ERRORS  
1 CAL WARNING PREVIOUS WARNING ON PAGE 1  
2 PASSES

TABLE SPACE USED : 9K

MODEL 8/16 E EXTENDED MEMORY TEST 06-221R00096 PART 2 PAGE 48 08:39:12 08/12/80  
CHKSUM/M17 PUNCHER

CRT	0000 015A	116	135*
CRT2	0000 016A	134	139*
CRT2ND	0000 0A08	137	922*
CRTRD	0000 0A06	136	921*
CRTRG2S	0000 0A05	138	920*
DATA	0000 0A54	933*	1298
DATA2	0000 09C0	893*	1052 1065
DATAPAT	0000 0F62	1432*	1436 1439 1456 1490
DEF.OPT	0000 0224	202*	207
DEFTESTS	0000 0A3E	292	935*
DEVSET	0000 0184	128	143 147*
DISPLAY	0000 0756	732*	951 967 1024 1034 1054 1084 1100 1113 1135 1150 1173 1178
ENDADRS	0000 10C0	1225	1243 1249 1300 1328 1346 1373 1400 1442 1460 1505
EOTMSG	0000 03E4	1509	1541 1542 1569*
ERRFLG	0000 0008	386	873*
ERRMSG	0000 076A	62*	317 363 753
		752*	986 990 994 998 1039 1068 1104 1141 1181 1202 1258 1354
ERRMSG1	0000 078C	1390	1410 1415 1454 1470 1540
ERRMSG2	0000 07A2	755	763*
ERRORS	0000 0996	765	771*
EXECUTE	0000 0190	417	886*
EXTMEM	0000 0800	151*	
FINDMAX	0000 01AA	68*	179 774
FOUND1	0000 01FE	153*	171
GETCHR	0000 06B2	159	178 184 190*
HALT9	0000 048E	232	642* 674 685
HIGH	0000 0422	404*	407 446 458 761
ILLEGAL	0000 0526	193	285 928* 1289 1307 1309
ILLMSG	0000 0910	224	448*
IMPTOP	0000 0000R	450	875*
INCRMNTL	0000 09EC	395	733 904*
IO	0000 0110	109*	113
ISITERR	0000 0400	67*	309 337 339 409 427 448 518 753 790
KEEP10	0000 049A	408*	515
KEEP3	0000 036C	313*	383
KEEP4	0000 0370	314*	403
KEEP5	0000 0396	323	326*
KEEP6	0000 039A	325	327*
KEEP7	0000 03FC	358	363*
KEEP7.1	0000 0416	371*	
KEEP9	0000 045E	377	391*
KEEP91	0000 0468	394*	
KEEP92	0000 0494	379	389 406*
LADC	0000 0001		
LAST	0000 10C8	155	182 852 944 1022 1055 1070 1082 1097 1124 1144 1157 1174
LDWT	0000 00B8	1205	1222 1325 1342 1369 1398 1438 1458 1503 1572*
LNZB	0000 10C7	91	93*
LOOK1	0000 02CA	74	1573* 1580 1609
LOOK2	0000 02CE	256*	263
LOOK3	0000 02E0	258*	267
LOOK4	0000 02F2	261	254*
		275*	

CHKSUM/M17 PUNCHER

MODEL 8/16 E EXTENDED MEMORY TEST 06-221R00496 PART 2 PAGE 50 08:39:12 08/12/80  
CHKSUM/M17 PUNCHER

## CHKSUM/M17 PUNCHER

		1177	1178	1181	1197	1198	1202	1224	1225	1242	1243	1249	1255	1258
		1272	1288	1290	1299	1300	1327	1328	1345	1346	1354	1372	1373	1380
		1399	1400	1410	1415	1441	1442	1459	1460	1464	1470	1503	1510	1511
		1511	1512	1513	1516	1517	1517	1518	1519	1522	1523	1529	1529	1530
		1533	1534	1536	1540	1542	1546	1548	1559	1553				
R14	0000 000E	52*	158	158	161	175	186	187	191	192	193	197	287	326
		442	671	671	683	688	710	712	737	776	846	850	861	943
		943	947	964	981	1004	1021	1021	1048	1048	1081	1081	1086	1091
		1096	1096	1105	1110	1116	1123	1126	1126	1133	1143	1146	1146	1156
		1156	1162	1167	1173	1183	1188	1194	1205	1208	1208	1221	1221	
		1227	1232	1240	1247	1247	1251	1262	1263	1270	1287	1289	1292	1297
		1306	1307	1324	1324	1330	1335	1341	1341	1353	1358	1359	1368	1368
		1386	1387	1397	1397	1417	1418	1437	1437	1446	1447	1457	1457	1475
		1476	1502	1502	1508	1508	1515	1545						
R15	0000 000F	53*	159	170	176	176	185	190	199	282	292	293	297	299
		299	300	300	301	444	672	672	684	709	734	734	735	736
		736	780	851	860	944	945	946	965	982	987	991	995	1005
		1022	1035	1040	1041	1049	1063	1069	1070	1082	1088	1090	1097	1107
		1109	1122	1124	1142	1144	1157	1164	1166	1174	1185	1187	1204	1206
		1222	1229	1231	1241	1248	1253	1261	1266	1271	1291	1305	1309	1325
		1332	1334	1342	1352	1357	1361	1369	1385	1389	1398	1416	1420	1438
		1445	1449	1458	1474	1478	1503	1507	1544	1598	1605	1618	1625	
R2	0000 0002	40*	73	85	90	124	127	129	135	141	144	147	471	477
		495	498	535	536	537	544	545	547	550	556	557	562	581
		586	601	602	603	612	613	642	643	644	645	648	651	655
		657	659	752	1294	1295	1302	1579	1588	1590	1614			
R3	0000 0003	41*	74	151	151	152	322	324	329	330	350	351	471	472
		473	475	475	477	478	480	505	506	516	537	538	542	545
		547	548	554	557	562	563	581	586	587	588	592	593	608
		610	613	657	1302	1303	1580	1600	1609	1626	1627			
R4	0000 0004	42*	76	77	78	80	86	88	132	138	142	154	195	336
		365	386	413	417	429	450	511	513	520	522	767	782	786
		844	855	1581	1583	1585	1589	1589	1590	1607	1611			
R5	0000 0005	43*	73	80	81	81	83	84	86	88	114	114	123	133
		139	179	308	317	332	337	339	352	363	378	391	408	409
		423	425	427	448	469	496	501	503	508	509	518	540	552
		576	578	583	590	594	599	605	649	654	753	774	790	1582
		1583	1610	1611	1612									
R6	0000 0006	44*	75	84	85	90	140	141	197	217	218	219	219	220
		221	422	422	442	804	804	805	807	809	811	825	826	1594
R7	0000 0007	45*	199	295	295	301	304	392	393	411	415	434	438	444
R8	0000 0008	46*	173	174	231	240	243	249	251	252	256	256	260	264
		266	788	948	948	954	955	956	957	968	969	970	971	972
		973	974	975	984	988	992	996	1035	1037	1063	1066	1101	1102
		1119	1120	1121	1138	1139	1158	1158	1161	1167	1179	1199	1200	1223
		1223	1226	1232	1244	1245	1256	1326	1326	1329	1335	1350	1377	1378
		1403	1408	1408	1412	1413	1461	1462	1467	1468	1557	1558	1628	
R9	0000 0009	47*	201	202	204	205	206	255	257	262	273	275	282	283
		285	287	784	977	977	1007	1008	1009	1010	1025	1026	1030	1034
		1037	1043	1052	1053	1065	1066	1099	1102	1135	1137	1139	1175	1175
		1188	1196	1200	1250	1250	1262	1273	1276	1298	1301	1343	1343	1353

MODEL 8/16 E EXTENDED MEMORY TEST 06-221R00M96 PART 2 PAGE 52 08:39:12 08/12/80  
CHKSUM/M17 PUNCHER

## CHKSUM/M17 PUNCHER

TEST2	0000 0BD4	345	1080*
TEST2.01	0000 03DA	1083*	1094
TEST2.02	0000 0BE2	1085*	1093
TEST2.03	0000 0BF2	1087	1090*
TEST2.10	0000 0C00	1089	1096*
TEST2.11	0000 0C06	1098*	1113
TEST2.12	0000 0C0A	1099*	1112
TEST2.13	0000 0C1C	1103	1105*
TEST2.14	0000 0C28	1106	1109*
TEST2.20	0000 0C38	1108	1115*
TEST2.21	0000 0C3C	1117*	1130
TEST2.22	0000 0C44	1119*	1129
TEST2.23	0000 0C5C	1125	1128*
TEST2.30	0000 0C64	1127	1133*
TEST2.31	0000 0C68	1134*	1150
TEST2.32	0000 0C6C	1135*	1149
TEST2.33	0000 0C80	1140	1142*
TEST2.34	0000 0C92	1145	1148*
TEST3	0000 0C9C	345	1155*
TEST3.01	0000 0CA4	1159*	1170
TEST3.02	0000 0CAC	1161*	1169
TEST3.03	0000 0CBC	1163	1165*
TEST3.10	0000 0CC8	1165	1173*
TEST3.11	0000 0CD2	1177*	1191
TEST3.12	0000 0CD6	1178*	1190
TEST3.13	0000 0CE4	1180	1182*
TEST3.14	0000 0CF4	1184	1187*
TEST3.20	0000 0D02	1186	1194*
TEST3.21	0000 0D0A	1197*	1212
TEST3.22	0000 0D0E	1198*	1211
TEST3.23	0000 0D1E	1201	1203*
TEST3.24	0000 0D32	1207	1210*
TEST4	0000 0D3C	345	1220*
TEST4.01	0000 0D44	1224*	1235
TEST4.02	0000 0D4C	1226*	1234
TEST4.03	0000 0D5C	1228	1231*
TEST4.10	0000 0D68	1230	1233*
TEST4.20	0000 0D6E	1240*	1278 1281
TEST4.30	0000 0D80	1247*	
TEST4.31	0000 0D86	1249*	1264 1267
TEST4.32	0000 0D96	1252	1255*
TEST4.40	0000 0DA4	1254	1257 1261*
TEST4.41	0000 0DBC	1265	1270*
TEST5	0000 0DE6	346	1284*
TEST5.10	0000 0E0C	1297*	1310
TEST5.11	0000 0E14	1299*	1313
TEST5.12	0000 0E18	1300*	1312
TEST5.20	0000 0E3C	1308	1311*
TEST6	0000 0E46	346	1323*
TEST6.01	0000 0E4E	1327*	1338
TEST6.02	0000 0E56	1329*	1337
TEST6.03	0000 0E66	1331	1334*
TEST6.04	0000 0E72	1333	1341*

MODEL 8/16 E EXTENDED MEMORY TEST 06-221R000496 PART 2 PAGE 54 08:39:12 08/12/80  
CHKSUM/M17 PUNCHER

TESTS.10	0000 0E7C	1345*	1354					
TEST6.11	0000 0E80	1346*	1365					
TEST6.12	0000 0E9E	1348	1355*					
TEST6.13	0000 0EA2	1351	1357*					
TEST6.14	0000 0EA6	1355	1359*					
TEST6.15	0000 0EB2	1359	1363*					
TEST6.20	0000 0EBC	1362	1368*					
TEST6.21	0000 0EC6	1372*	1392					
TESTS.22	0000 0ECE	1374*	1393					
TEST6.23	0000 0ED8	1375	1377*					
TEST6.24	0000 0EE4	1379	1381*					
TEST6.25	0000 0EF2	1383	1385*					
TEST6.26	0000 0F02	1398	1391*					
TEST6.30	0000 0F0C	1390	1397*					
TEST6.31	0000 0F12	1399*	1423					
TEST6.32	0000 0F1A	1401*	1424					
TEST6.33	0000 C=3A	1409	1411*					
TEST6.34	0000 0F46	1414	1416*					
TEST6.35	0000 0F58	1419	1422*					
TEST7	0000 0F64	347	1434*					
TEST7.01	0000 0F78	1441*	1452					
TEST7.02	0000 0F80	1443*	1453					
TEST7.03	0000 0F98	1448	1451*					
TEST7.0X	0000 0F68	1436*	1495	1497				
TEST7.10	0000 0FA2	1450	1456*					
TEST7.11	0000 0FAC	1459*	1481					
TEST7.12	0000 0F94	1461*	1482					
TEST7.13	0000 0FC0	1467	1465*					
TEST7.14	0000 0FD2	1469	1471*					
TEST7.15	0000 0FEC	1477	1480*					
TEST7.20	0000 0FF6	1479	1490*					
TEST7.21	0000 1006	1491	1496*					
TEST8	0000 100E	347	1501*					
TEST8.10	0000 1014	1504*	1550					
TEST8.20	0000 105E	1539*	1535					
TEST8.30	0000 107A	1520	1526	1539	1541*			
TESTADRS	0000 03C4	331	344*					
TESTDU1	0000 0566	470	477*					
TESTNUM	0000 082C	326	841*					
TESTOP	0000 0324	276	290*					
TESTOP1	0000 0334	291	295*					
TESTOP2	0000 0336	296*	303					
TITLE2	0000 086C	154	865*					
TOM2	0000 01DE	180*	188					
TOTAL	0000 09E8	311	393	395	397	401	411	452*
TOTALMSG	0000 098C	413	885*					
TOTERR	0000 09EA	312	398	399	415	756	758	765
TSTBRK	0000 05D4	321	359	380	519	535*	1304	772
TSTBRK0	0000 05EA	542*	549					
TSTBRK1	0000 05F6	543	547*					
TSTBRK2	0000 0504	541	552*					
TSTBRK3	0000 061C	553	562*	564				
TSTBRK4	0000 0524	551	561	565*				

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